

VERTEX 80v

User Manual

1003246

2nd edition 2013, publication date May 2013

© 2013 BRUKER OPTIK GmbH, Rudolf-Plank-Straße 27 D-76275 Ettlingen, www.brukeroptics.com

All rights reserved. No part of this manual may be reproduced or transmitted in any form or by any means including printing, photocopying, microfilm, electronic systems etc. without our prior written permission. Brand names, registered trademarks etc. used in this manual, even if not explicitly marked as such, are not to be considered unprotected by trademarks law. They are the property of their respective owner.

This manual is the original documentation for the FT-IR spectrometer VERTEX 80v.

Table of Contents

1	Safety	/	7
	1.1	General safety information	7
	1.2	Classification of the safety notes	7
	1.3	Overview of possible types of hazard	8
	1.3.1	Possible hazards during installation and operation	8
	1.3.2	Possible hazardous sample materials	9
	1.4	Laser safety	10
	1.5	Intended use	10
	1.6	Service contact data	11
2	Gener	al	13
	2.1	Technical features	13
	2.2	Evacuation ability	13
	2.3	Spectrometer validation	14
	2.4	Possible instrumental set-ups	14
3	Install	ation	17
	3.1	General information	17
	3.2	Delivery scope	17
	3.3	Inspecting the packaging	18
	3.4	Transporting the spectrometer	18
	3.5	Site requirements	19
	3.6	Connecting the spectrometer to the power supply	22
	3.6.1	General information	22
	3.6.2	Safety note	22
	3.6.3	Procedure	23
	3.7	Connecting the spectrometer to a compressed-air line	24
	3.7.1	General information	24
	3.7.2	Procedure	24
	3.8	Connecting the spectrometer to the vacuum pump	26
	3.8.1	General information	26
	3.8.2	Procedure	27
	3.9	Connecting the spectrometer to the purge gas supply line	29
	3.9.1	General information	29
	3.9.2	Procedure	30
	3.10	Connecting the spectrometer to a PC	32
	3.10.1	General information	32
	3.10.2	Possible connection variants	34
	3.10.3	Network addresses	37
	3.10.4	Assigning a network address to the spectrometer	39
	3.10.5	PC network address	41
	3.10.6	Checking the communication between the spectrometer and the PC	42

4	Overview43			
	4.1	External components	. 43	
	4.1.1	Spectrometer compartments	. 43	
	4.1.2	Status indicator board	. 44	
	4.1.3	Sample compartment	. 47	
	4.1.4	IR beam ports	. 48	
	4.1.5	Ports and connectors at the spectrometer rear side	. 49	
	4.2	Internal components	. 51	
	4.2.1	Overview	. 51	
	4.2.2	Source	. 52	
	4.2.3	Detector	. 53	
	4.2.4	Beamsplitter	. 56	
	4.2.5	Laser	. 57	
	4.2.6	Interferometer	. 57	
	4.2.7	Sample compartment windows	. 58	
	4.3	Optical beam path	. 60	
5	Operat	Operation61		
	5.1	General information	. 61	
	5.2	Putting the spectrometer into operation	. 62	
	5.3	Shutting down the spectrometer	. 64	
	5.4	Placing an accessory in the sample compartment	. 66	
	5.4.1	QuickLock mechanism	. 66	
	5.4.2	Putting an accessory in the sample compartment	. 67	
	5.4.3	Automatic accessory recognition (AAR)	. 67	
	5.4.4	Taking an accessory out of the sample compartment	. 67	
	5.5	General measurement procedure	. 68	
	5.6	Evacuating and venting the spectrometer	. 69	
	5.6.1	Activating the vacuum mode in OPUS	. 69	
	5.6.2	General information	. 69	
	5.6.3	Evacuating	. 70	
	5.6.4	Venting	.71	
	5.7	Optimizing the vacuum	.72	
	5.7.1	General information	.72	
	5.7.2	Reproducibility of the measurement results	. 72	
	5.7.3	Residual water vapor	. 72	
	5.7.4	Evacuation time	.73	
	5.7.5	Optimal evacuation procedure	.73	
	5.8	Purging the spectrometer	.75	
	5.8.1	General information	.75	
	5.8.2	Activating the purge mode in OPUS	. 76	
	5.8.3	Controlling the flaps	. 77	
	5.8.4	Special case	. 78	

5.9	Extending the spectral range	79
5.9.1	General information	79
5.9.2	Standard and optional spectral ranges	
5.9.3	Automatic component recognition (ACR)	79
5.10	Exchanging the beamsplitter	80
5.10.1	General information	80
5.10.2	Handling instructions	81
5.10.3	Manual beamsplitter exchange procedure	82
5.10.4	Loading the automatic beamsplitter changer	
5.10.5	Software-controlled beamsplitter exchange procedure	85
5.11	Exchanging the detector	86
5.11.1	General information	
5.11.2	Procedure	
5.12	Replacing a sample compartment window	89
5.12.1	General information	
5.12.2	Handling instruction	
5.12.3	Safety note	
5.12.4	Replacement procedure for a window mounted on a flap	90
5.12.5	Replacement procedure for a window flanged to the sample compartment	wall 91
5.13	Checking the signal	
5.13.1	General information	
5.13.2	Procedure	
5.13.3	Saving the interferogram peak position	
5.14	Cooling the MCT detector	95
5.14.1	General information	
5.14.2	Safety notes	
5.14.3	Preparing the detector compartment cover	
5.14.4	Filling the MCT detector with liquid nitrogen	
Repai	r and Maintenance	101
6.1	General information	101
6.2	Performing an OQ test using OVP	101
6.3	Restoring the detector dewar vacuum	102
6.3.1	General information	102
6.3.2	Evacuating the MCT detector dewar	102
6.3.3	Regenerating the vacuum of a PERMAVAC-type MCT detector	107
6.4	Replacing a defective IR source	110
6.4.1	General information	110
6.4.2	Safety notes	110
6.4.3	Procedure	110
6.4.4	Resetting the source operating hours counter	114
6.5	Replacing a broken or opaque sample compartment window	115
6.6	Cleaning the spectrometer	115

6

7	Troub	leshooting	117
	7.1	General information	117
	7.2	Diagnostic means	118
	7.2.1	Status indicator board	119
	7.2.2	OPUS dialog Instrument Status	120
	7.2.3	Instrument status messages in OPUS	122
	7.2.4	Diagnostic pages of the spectrometer firmware	122
	7.2.5	Diagnostic LEDs at the spectrometer rear side	127
	7.3	General information about how to diagnose a fault	128
	7.4	Remote fault diagnosis	129
	7.5	Problem - possible cause - solution	131
	7.5.1	Spectrometer problem indicated by a red status indicator board LED	131
	7.5.1.1	Red VACUUM LED	131
	7.5.1.2	Red LASER LED	132
	7.5.1.3 7514	Red STATUS LED.	133
	7.5.1.4	Red FLAPS LED.	135
	7.5.1.6	Red BMS LED	136
	7.5.2	Spectrometer problem indicated by an instrument status message in OPUS.	136
	7.5.2.1	Instrument status message regarding the laser	136
	7.5.2.2	Instrument status message regarding the source	137
	7.5.2.3 7524	Instrument status message regarding the interferometer	138
	7.5.2.4	Instrument status message regarding an automation unit	139
	7.5.3	No signal is detected or signal intensity is too low	140
	7.5.4	A failed validation test	142
	7.5.5	Spectrometer problem indicated by the voltage status LEDs	144
	7.5.5.1	All voltage status LEDs are off	144
	7.5.5.2	One voltage LED is off	145
	7.5.6	Spectrometer problem indicated by a red ERR LED	145
	7.5.7	The SR LED lights permanently	146
	7.5.8	No communication between spectrometer and computer	146
	7.5.8.1 7.5.8.2	The green RX LED does not light at all During connection establishment the RX LED lights but the TX LED does not	147 t 147
Α	Specif	ication	149
	A.1	Spectrometer	149
	A.2	Power supply	150
	A.3	Compressed air supply	150
	A.4	Purge gas supply	151
	A.5	Environmental conditions	151
в	Replac	cement parts	153
	B.1	Source	153
	B.2	Beamsplitter	153
	B.3	Windows	154

С	Measurement parameters		155
	C.1	General information	155
	C.2	Default parameter values and settings	155
	C.3	Interactive setting of optics parameters	157
D	Dime	nsional drawings	159
Е	Electi	ronics & power supply unit	165
	E.1	Electronics unit - Diagnostic LEDS and connecting ports	165
	E.2	Power supply unit - Diagnostic LEDs and connecting ports	168
F	Spect	rometer firmware	169
	F.1	General information	169
	F.2	Starting the FCONF program	169
	F.3	Updating the spectrometer firmware	170
	F.4	Restoring a previous firmware version	171
	F.5	Backing up the current spectrometer firmware version	172
G	Samp	le preparation	173
	G.1	General information	173
	G.1.1	State of aggregation	173
	G.1.2	Absorptivity	173
	G.2	Sample preparation techniques	174
	G.2.1	No sample preparation	175
	G.2.2	Thin film between plates	175
	G.2.3	Solid sample as sample solution	176
	G.2.4	Preparing a mull	176
	G.2.5	Pressing a KBr pellet	177
	G.2.6	Liquid cell	178
	G.2.7	Gas cell	178

1 Safety

1.1 General safety information

Read carefully all instructions and safety notes in this manual before installing and putting the spectrometer into operation. Keep this manual for future reference available at any time.

Always observe the instructions and safety notes given in this manual. Failure to do so can lead to personal injuries and/or property damage. Non-observance of the instructions and safety notes will violate the intended use of the spectrometer. (See section 1.5.)



It is the operator's duty to plan and implement all necessary safety measures and to supervise their observance. Moreover, the operator must ensure that the spectrometer is in proper condition and fully functioning.

A safe and trouble-free operation of the spectrometer is ensured only if all components of the analysis system are installed and operated as well as maintained and repaired according to the procedures described in this manual and in compliance with all relevant safety standards and regulation.

The spectrometer should be operated only by authorized personnel which is trained in operating the spectrometer and which is familiar with the relevant safety instructions and laser safety regulations.

Never remove or deactivate any supporting safety systems during spectrometer operation. Objects and/or material not required for the operation should be kept outside the operating area of the spectrometer.

The spectrometer complies with the IEC/EN 61010-1 safety regulations.

1.2 Classification of the safety notes

Depending on the degree of hazard, important safety notes are classified in this manual by signal words as follows:



DANGER

 Indicates a hazardous situation which, if not avoided, will result in death or serious (possibly irreversible) injury and major property damage.



Indicates a hazardous situation which, if not avoided, could result in death or serious (possibly irreversible) injury and major property damage.



 Indicates a hazardous situation which, if not avoided, may result in minor or moderate (reversible) injury and minor property damage.

NOTE

Hazard, which could result in material damage if the appropriate safety instructions are not observed.

1.3 Overview of possible types of hazard

1.3.1 Possible hazards during installation and operation

Hazards that can possibly occur during installing, operating and repairing the spectrometer are indicated by the appropriate warning labels on the spectrometer. The following warning labels indicate different dangerous situations which may be caused by an improper use of the analysis system:

Warning symbol	Definition
	General hazard: This warning symbol indicates a general hazard. The label is located near the danger spot in question. Observe the safety instructions and follow the precautions described to avoid personal injury and/or prop- erty damage.
	Laser radiation: This warning symbol indicates the existence of laser radiation. The label is located near the aperture at which hazardous laser radiation exits the instrument. Do not look directly into the laser beam or use any kind of optical instruments to look into the beam as this may cause permanent eye damage.
	Electrical shock: This warning symbol indicates an electrical hazard. The label is located near live parts or on housings behind which are live parts that represent an accidental contact hazard. Do not touch these parts. Before removing the corresponding housing and beginning any maintenance or repair work, first turn off the main power switch and unplug the main power cable. Ensure that all live parts do not come into contact with a conductive substance or liquid. Non-observance of these safety instructions can cause severe personal injury and/or property damage.
	Hot surface: This warning symbol refers to components and surfaces which can become very hot during the spectrometer operation. Do not touch these components and surfaces. Risk of skin burn! Be careful when operating near hot components and/or surfaces.
	Danger of frostbite: This warning symbol indicates cryogenic liquids (e.g. liquid nitrogen) required to operate the spectrometer (e.g. cooling the detector). Exposure to these liquids or cooled components causes frostbite effects. Handle the liquids with utmost care. Observe the safety instructions for operating with cryogenic liquids.

Important: All warning labels on the spectrometer must always be kept legible. Immediately replace a worn or damaged label!

1.3.2 Possible hazardous sample materials

There can also be hazards caused by the sample material. Depending on the type of hazardous substances you work with, you have to observe specific substance-relevant safety instructions. Affix the corresponding warning label at the appropriate place at the spectrometer. The label must be well legible and permanently discernible. The following list contains some examples of hazardous substances:

Symbol	Definition	
	Infectious material This warning symbol indicates the possible existence of biological dangerous and infectious material. When working with this kind material always observe the prevailing laboratory safety regulation and take necessary precautions and disinfection measures (e.g. weak ing protective clothing, masks, gloves etc.). Non-observance material cause severe personal injury or even death. For information on how to use, dilute and efficiently apply disinfectant refer to the Laboratory Biosafety Manual: 2004 by WHO - World Heat Organization.	
A	Radioactive material This warning symbol indicates the possible existence of radioactivity. When working with radioactive material always observe the safety reg- ulations and take necessary protective measures. Wear protective clothing, e.g. masks and gloves. Non-observance may cause severe personal injury or even death.	
	Corrosive substances This warning symbol indicates the possible existence of corrosive sub- stances. When working with corrosive substances always observe the laboratory safety regulations, and take protective measures (e.g. wear protective masks and gloves). Non-observance may cause severe personal injury or even death.	

Waste disposal

Dispose all waste produced (chemicals, infectious and radioactively contaminated substances etc.) according to the prevailing laboratory regulations. Detergents and cleaning agents must be disposed according to the special waste regulations.

1.4 Laser safety

The interferometer is equipped with a HeNe laser. This laser emits red light with a wavelength of 632.8nm. The rated power output is 5mW. According to EN 60825-1:2007, the laser is laser class 3R product.

Due to constructional measures, the spectrometer is classified as a laser class 2 product, i.e. the intensity of accessible laser radiation is reduced.

During all exchange, repair and maintenance works (e.g. manual beamsplitter exchange, replacement of a defective MIR source) which require the opening of the interferometer compartment, observe the following safety instructions regarding laser class 2.



A WARNING

Eye injury because of exposure to laser radiation of laser class 2

Non-observance of the following safety instruction could result in injury.

Do not stare into the laser beam! An exposure time > 0.25 sec. will cause eye injury.

1.5 Intended use

The spectrometer is designed for FT-IR spectroscopic measurements under vacuum conditions. It is suited for all kinds of solid and liquid and gaseous samples which absorb infrared light (radiation energy).

The spectrometer is approved for the use in a laboratory under the environmental conditions specified in appendix A.5.

The intended use includes also the compliance with the relevant standards and regulations, especially:

- · regional or national safety regulations
- regional or national accident prevention regulations
- generally recognized technical regulations

The intended use also includes the strict observance of all instructions given in this manual, namely:

- safety instructions
- installation instructions,
- operation instructions
- repair and maintenance instructions

Use only components and accessories supplied by Bruker. For components and accessories made by other manufacturers and used in conjunction with the spectrometer, Bruker Optik GmbH does not assume any liability for safe operation and proper functioning.



Health hazard because of unintended use of the spectrometer

Non-observance of the following safety instruction could result in serious injury (possibly irreversible skin and/or eye injuries).

Do not take any action that violates the intended use. The operational safety of the spectrometer is ensured only if it is used as intended.

1.6 Service contact data

In case you have questions about safety, installation and/or operation as well as repair and maintenance of the spectrometer or you need technical assistance in case of a hardware and/or software problem, you can contact the Bruker service as follows:

- Service hotline hardware:
- Service hotline software:
- Fax:
- E-mail:
- Internet:

+49 (0) 72 43 504-2020 +49 (0) 7243 504-2030 +49 (0) 72 43 504-2100 service@brukeroptics.com www.brukeroptics.com

2 General

2.1 Technical features

The spectrometer is equipped with a number of features such as AAR (<u>A</u>utomatic <u>A</u>ccessory <u>R</u>ecognition) ACR (<u>A</u>utomatic <u>C</u>omponent <u>R</u>ecognition) and Performance-Guard that facilitate performing spectroscopic measurements and ensure reliable measurement results. The function AAR identifies automatically the accessory installed in the sample compartment, performs several tests and loads automatically the corresponding experiment file including the pre-defined measurement parameters. The function ACR recognizes automatically the currently installed optical components like source, detector and beamsplitter. These components are electronically coded so that the spectrometer firmware can recognize them. This information is passed on to the application software OPUS. The purpose of ACR is to enable the user to select the right optics parameters in OPUS. In addition, the spectrometer components are monitored permanently to ensure that they operate within the specification range. This feature is called Performance Guard. Its purpose is to facilitate fault diagnostics and maintenance.

The data acquisition is based on a free running delta-sigma, dual-channel A/D converter with 24-bit dynamic range. The A/D converter is integrated into the detector preamplifier electronics. The DigiTect technology ensures a signal transmission free from interferences and guarantees the highest signal-to-noise ratio.

The spectrometer can be controlled by any data system (PC workstation, notebook etc.) on which the operating system Microsoft Windows and the spectroscopic software OPUS is installed. The Ethernet connection provides the possibility to control the spectrometer also via your intranet or the internet.

The standard spectrometer configuration is equipped for data acquisition in the mid IR region. Optionally, the spectrometer can be equipped with different optical components to cover the whole spectral range - starting in the far infrared or THz region at 5cm⁻¹ up to the ultraviolet region at 50,000cm⁻¹. Due to the pre-aligned optical components and the actively aligned UltraScan interferometer, the spectral range can be changed easily. If you work with the advanced spectrometer configuration (i.e. two detector positions and two source positions are available inside the spectrometer) you can select them using the software. Removable vacuum-tight covers provide access to the detector and beam-splitter if you want to exchange these components.

Diagnostic routines help to maintain optimum instrument status and performance. The internal validation unit (IUV) is located inside the spectrometer. It contains standards (test samples) used for the validation and testing of the instrument.

2.2 Evacuation ability

The evacuable spectrometer allows measurements under vacuum conditions, i.e. unwanted atmospheric interferents (e.g. water vapor or carbon dioxide) are eliminated nearly completely from the spectrometer interior. Evacuating the spectrometer is more efficient than purging it or using desiccant cartridges. The result of an optimal measurement under vacuum conditions is an IR spectrum in which no H₂O or CO₂ vapor absorptions mask weak spectral features.

The spectrometer design enables a separate evacuation of the spectrometer compartments, i.e. either the complete spectrometer interior (sample compartment plus the optical bench) or only the optical bench can be evacuated. Vacuum shutters (so called flaps), which can be equipped with optical windows, allow a ventilation of only the sample compartment in order to preserve the vacuum in the rest of the optics compartment during a sample change or an accessory installation. Evacuating and venting the sample compartment and/or optical bench are computer-controlled. Moreover, the spectrometer is equipped with two pressure sensors providing for the display of the current pressure inside the spectrometer optics and/or sample compartment.

The spectrometer is supplied with an efficient vacuum pump that can evacuate the spectrometer optics within a few minutes. The oil-free vacuum pump prevents the spectrometer optics from being contaminated by hydrocarbons.

2.3 Spectrometer validation

The spectrometer and the spectroscopy software OPUS are designed for validating the spectrometer to ensure that the spectrometer operates within the specifications and delivers reliable measurement results. For this purpose, the spectrometer is equipped with a computer-controlled internal validation unit (IVU) as a standard feature. The IVU is a wheel equipped with different filters. Depending on which test protocol (OQ¹ or PQ²) is running, the corresponding filter is moved automatically in the beam path. Validation intervals and test protocols (OQ and PQ) are defined by the user using OVP³. For detailed information about OVP and spectrometer validation, refer to the OPUS Reference Manual.

2.4 **Possible instrumental set-ups**

The spectrometer has five IR beam outlet ports (on the right, front and left side) and two IR beam inlet ports (on the right and rear side) allowing the connection of a multitude of optional accessories and/or components like:

- TGA FT-IR coupling
- PMA 50 (Polarization Modulation Accessory for VCD and PM-IRRAS)
- HYPERION 1000/2000 IR microscope and HYPERION 3000 imaging microscope with FPA detector (Focal Plane Array detector system)
- IMAC module (Imaging Accessory with FPA detector)
- HTS-XT module (High Throughput Screening Extension)
- Fiber optic coupling module with MIR or NIR fiber probes for solid and liquid samples
- FT Raman module (e.g. RAM II)
- FIR bolometer
- External, water-cooled source

Depending on the requirements, the R&D applications impose on the analysis system, a large number of different instrumental set-ups is possible.

^{1.} OQ - Operational Qualification

^{2.} PQ - Performance Qualification

^{3.} OVP - <u>O</u>PUS <u>Validation</u> <u>Program</u>



Figure 2.1: Examples of possible instrumental set-ups

As figure 2.1 illustrates, there are many possibilities to connect several accessories and/ or components simultaneously to the spectrometer.

An example for a very comprehensive instrumental set-up is the following: a watercooled Hg-arc source at the rear side, the RAM II FT-Raman module at the right side, a fibre optics coupling at the right front side, the HYPERION IR microscope at the left side and a bolometer detector at the front side.

3 Installation

3.1 General information

Installation and initial start-up of the spectrometer are done by Bruker service technicians. The operating company has to provide an installation site that meets the site requirements described in section 3.5. (See also the technical document *Installation Requirements for VERTEX 80v* provided by Bruker Optik GmbH in advance.)

The installation of the spectrometer includes the following works:

- connecting the spectrometer to the power supply
- connecting the spectrometer to the vacuum pump
- connecting the spectrometer to a compressed-air line
- connecting the spectrometer to the purge gas supply line
- · connecting the spectrometer to a computer

For detailed information about how to install the computer, refer to the computer manual.

3.2 Delivery scope

The delivered items are divided into standard components and optional components. So the actual delivery scope depends on the customer's order.

Standard components:	 The standard delivery scope includes the following items: VERTEX 80v (including the user manual) Power cord Compressed air hose (OD: 6mm, length: approx. 5m) PC compatible data system (if desired, the PC can also be provided by the customer) Data cable (Cat5, crossover cable for 10Base-T Ethernet standard) Tool kit (slot-head screw driver, cross-head screw-driver and hex keys of several sizes, sample preparation tools, 3x spare fuses, IR sensor card, metallic cap) OPUS software, basic IR package (including the OPUS Reference Manual) For installing and operating the vacuum pump, the following items are included: Vacuum pump (including the user manual) Vibration absorber 2x flexible metal hoses 4x hose clamps 4x sealing rings
Optional components:	 In addition, the delivery scope can include also following optional components: Optional spectrometer components (e.g. optional detectors, sources and/or beamsplitter) Optional accessories Optional OPUS software packages (QUANT, IDENT, etc.) including the corresponding manuals Purge option (S316/V)

3.3 Inspecting the packaging

After having received the spectrometer, inspect the packaging for damages.

ACAUTION

Possible damage to the delivered spectrometer because of transport damage



- Inspect the packaging for damages. If there are signs of damage contact shipping company.
- A spectrometer delivered in a damaged packaging may be damaged as well. Therefore, in this case do not put the spectrometer into operation. Contact Bruker instead. (See section 1.6.)

3.4 Transporting the spectrometer

The spectrometer has to be carried by at least four persons. Attach the supplied transport handles to the right and left spectrometer side as shown in figure 3.1 using 12 screws (M5 x 16). After having transported the instrument to its destination place, you can remove the transport handles again. Due to the spectrometer weight (ca. 120 kg), this method of transport is suited only for very short distances.

For transporting the spectrometer over longer distances, it is recommended to use a wheeled table, for example.



ACAUTION

Injury and/or spectrometer damage due to an inadequate method of transport

Non-observance of the following safety instructions could result in injury.

- For short-distance transport, the spectrometer has to be carried by at least four persons. Pay attention to the spectrometer weight (ca. 120 kg) Install the supplied transport handles.
- For long-distance transport, put the spectrometer on a wheeled table or use a fork lifter, for example. To avoid damages, transporting the spectrometer in original packing is recommended.

3.5 Site requirements

The operating company has to provide an installation site that meets the following site requirements:

Space requirements:	 Spectrometer dimensions: 85cm x 71cm x 31cm (width x depth x height) (For exact spectrometer dimensions refer to appendix D.) At the rear side, the spectrometer requires a clearance of at least 25cm (10"). The spectrometer should be placed on a stable and horizontal base. Note that the basic instrument has a weight of about 120 kg.
Environmental requirements:	 Temperature range: 18°C - 35°C (64°F to 95°C) Temperature variations: max. 1°C/h and max. 2°C/day (Temperature variations can impair the results of long-term measurements.) Humidity (non-condensing): ≤ 80% (relative humidity) Installation site: in a closed room, max. 2000m above sea level The spectrometer should not be installed near vibration sources (e.g. ventilation hoods, air conditioners, motors elevators) or in rooms with intense floor vibrations. The spectrometer should not be installed near sources of potential inductive electrical interference (e.g. pumps, switching motors, microwave ovens etc.), sources of high energy pulses, and sources that might cause magnetic or radio frequency interference. These devices can interfere with the spectrometer and cause spectrometer malfunction. Ensure that these types of devices are not connected to the same electrical circuit as the spectrometer.

Compressed air:	 pressure: between min. 1.0 bar (14.5 psi) and max. 2.0 bar (29 psi) flow rate: ca. 100 l/h compressed-air properties: dry and clean air (oil-free and dust-free, dew point < -15°C) or dry and clean nitrogen gas Note: The local compressed air supply line needs to be dimensioned for a PVC hose having an outer diameter of 6mm.
Purge gas supply requirements:	 dry air or nitrogen gas (dew point < -40°C corresponds to a degree of dryness of 128ppm humidity) oil-free and dust-free min. pressure: 1 bar (14.5 psi) max. pressure: 2 bar (29 psi) Initial purge gas flow rate should not exceed 500 liters/hour. Sustained purge gas flow rate should not exceed 200 liters/hour. Note: The local purge gas supply line needs to be dimensioned for a PVC hose having an outer diameter of 6mm.
Power supply:	The spectrometer power supply is realized by the sup- plied external power supply unit. The external power supply unit has a wide input range which means that it is able to adapt itself to the most common public sup- ply mains. Input range: 100 - 240 V AC, ~ 2.5V, 50 - 60 Hz Output: 24 V DC, 4.75 A, max. 90 W Connect the spectrometer only to a socket outlet with earthing contact that complies with VDE 0620-1 or IEC! The spectrometer is constructed for the connection to a SELV (safety extra low voltage) circuit. For safety reasons, make sure that the interfaces of electric accessories connected to the spectrometer comply with SELV (safety extra low voltage) circuit requirements. Normally, this condition is met if the accessory design is based on the requirements described in EN 61010 or EN 60950. If there are problems concerning main power supply (e.g. brownouts, power surges, frequent thunder- storms or power blackouts) use an UPS unit (<u>U</u> ninter- ruptible <u>P</u> ower <u>S</u> upply) to ensure an uninterruptible power supply and consequently an operation without interruptions.
Possibilities of interrupt- ing the mains power sup- ply:	 The mains power supply of the spectrometer can be interrupted as follows: by pulling the mains plug of the power cord by pulling the power cord from the external power supply unit by switching off the spectrometer using the ON / OFF switch at the spectrometer rear side

External devices:	• Line-powered accessories connected to spectrome- ter interfaces (e.g. Ethernet) have to have special electrical disconnecting features. The electric circuits of these interfaces have to comply with the require- ments imposed on SELV circuits (<u>safety extra low</u> <u>voltage circuit</u>).
	1 Typically, this is achieved when connecting SELV circuits to each other. In general, the interface meets the requirement if the device complies with the regulations outlines in EN 61010 (Safety regulations for laboratory equipment) or EN 60950 (Safety for information technology facilities).

3.6 Connecting the spectrometer to the power supply

3.6.1 General information

The spectrometer power supply is realized by an external power supply unit. The external power supply unit plus power cord and low-voltage cable are included in the standard delivery scope of the spectrometer.

The external power supply unit has a wide input range which means that it is able to adapt itself to the most common public supply mains.

- Input range: 100 240 V AC, ~ 2.5V, 50 60 Hz
- Output: 24 V DC, 4.75 A, max. 90 W
- Depending on the local conditions, the original power cord may need to be exchanged for a power cord that complies with the standards of the country in question. Ensure that the installed power cord has the approval of the local authority (UL for US, CSA for Canada or VDE for Europe).

3.6.2 Safety note

To ensure a safe operation of the external power supply unit, observe the following safety instructions:

- Operate the external power supply unit only in a dry environment.
- Make sure that the external power supply unit is not exposed to direct sunlight. Avoid temperatures above +50 °C. Provide for sufficient air circulation.
- Position the external power supply unit in such a way that it does not present a trip hazard.
- Do not put heavy objects on the external power supply unit.
- Do not place the external power supply unit on a hot surface.
- If the external power supply unit is damaged disconnect it instantly from the supply circuit. Never put a damaged external power supply unit into operation! Only authorized technicians are allowed to repair the external power supply unit!

3.6.3 Procedure



3.7 Connecting the spectrometer to a compressed-air line

3.7.1 General information

The linear scanner of the spectrometer is supported by an air bearing. For a proper functioning of the linear scanner, the spectrometer needs to connected to a compressed-air line. The compressed-air supply has to meet the following requirements:

- Pressure: between minimum 1.0 bar (14.5 psi) and maximum 2.0 bar (29 psi)
- Flow rate: about 100 l/h
- Gas: dry and clean air or nitrogen gas (oil-free and dust-free, dew point < -15°C)

NOTE

We <u>do not</u> recommend connecting the spectrometer to a compressor as this connection requires in addition a water separator and/or an oil separator in order to prevent oil and/or water from entering the interferometer air bearings. Take into consideration that oil and/or water which enters the air bearings can cause a severe interferometer problem! Bruker Optik offers suitable compressors, dryers and combined systems.

3.7.2 Procedure

A compressed air hose (length: ca. 5 m, OD: 6mm) is included in the delivery scope of the standard spectrometer configuration.





3.8 Connecting the spectrometer to the vacuum pump

3.8.1 General information

The attachment flange for connecting the vacuum pump is at the spectrometer rear side. Figure 3.2 shows the valve block with removed cover.



Figure 3.2	Component / Control element
А	Attachment flange (NW25 flange) for the vacuum pump
В	Valve for evacuating the sample compartment
С	Valve for venting the sample compartment
D	Opening for venting the sample compartment Note: When purging the spectrometer this port is used as purge gas inlet for the sample compartment.
E	Valve for evacuating the optical bench
F	Valve for venting the optical bench
G	Opening for venting the optical bench (Note: When purging the spectrometer this port is used as purge gas inlet for the optical bench.

When VERTEX80v is used as a vacuum spectrometer, the two vent openings are covered by a plug made from sintered-powder metal which is air-permeable (i.e. the spectrometer can be vented with the plugs installed on the vent openings). When the spectrometer is vented, these plugs function like a filter preventing particles from entering the spectrometer together with the influent air.

The required connecting components (2x flexible metal hoses, 4x hose clamps and 4x sealing rings) are included in the standard delivery scope.

3.8.2 Procedure

1		Remove the valve block cover ① at the spectrometer rear side. To do this, loosen the two Allen screws ② using a hex key (size 3mm) and pull off the valve block cover ①.
2		Install the sealing ring ① at the flange port ②.
3	2 3	Press the flexible metal hose (1) against the flange port (2) and attach the hose to the flange port using a hose clamp (3) .
4		Secure the hose clamp ① by fastening the wing screw ②.



Attention: Make sure that the vibrating metal hoses do not come into contact with the table on which the spectrometer is placed.

For detailed information about the vacuum pump (e.g. installation, operation, maintenance), refer to the user manual provided by the vacuum pump manufacturer.

3.9 Connecting the spectrometer to the purge gas supply line

3.9.1 General information

As an alternative to the vacuum operation, the spectrometer can be purged with either dry air or dry nitrogen gas.

The spectrometer has two purge gas inlets; one for purging the sample compartment and the other for purging the optical bench. The purge gas inlets are at the spectrometer rear side. Figure 3.3 shows the valve block with removed cover.



Figure 3.3	Purge gas inlet for
A	Purge gas inlet for optical bench (Figure 3.3 shows the purge gas inlet with installed plug.)
	(Note: In case of vacuum operation, it is the vent opening for venting the optical bench.)
В	Purge gas inlet for sample compartment (Figure 3.3 shows the purge gas inlet with installed plug.)
	(Note: In case of vacuum operation, it is the vent opening for venting the sample compartment.)

The purge gas supply has to meet the following requirements:

- dry air or nitrogen gas (dew point < -40°C corresponds to a degree of dryness of 128ppm humidity)
- oil-free and dust-free
- min. pressure: 1 bar (14.5 psi)
- max. pressure: 2 bar (29 psi)
- initial purge gas flow rate should not exceed 500 liters/hour
- sustained purge gas flow rate should not exceed 200 liters/hour

3.9.2 Procedure

1 The required hoses are not included in the standard delivery scope. Normally, it is the operating company's duty to provide the hoses of the required length (PVC hose, outer diameter: 6mm). Make sure that the hose is rated for the indicated operating pressure. Only in case the purge option S316/V has been ordered, the required hoses including an air flow regulator are included in the delivery scope of the spectrometer.



Depending on whether you want to purge either only the sample compartment or only the optical bench (i.e. interferometer compartment and detector compartment) or both compartments, there are two variants for connecting the hose.

For purging either the sample compartment or the optical bench

This variant requires a stiff PVC hose with an outer diameter of 6mm.

Remove the plug from the purge gas inlet of either the optical bench (A in fig. 3.3) or the sample compartment (B in fig. 3.3) and insert the hose in the purge gas inlet.

Connect the other end of the hose to the local purge gas supply line.

For purging both the sample compartment and the optical bench

This variant requires a stiff PVC hose (T-shaped) with an outer diameter of 6mm.

Connect the main end of the T-shaped hose to the local purge gas supply line.

Remove the plugs from both purge gas inlets at the spectrometer rear side (A and B in fig. 3.3) and insert the other two ends of hose in the purge gas inlets.

3.10 Connecting the spectrometer to a PC

3.10.1 General information

Basically, the following connection variants are possible:

- Connecting the spectrometer directly to a stand-alone PC (It is the standard variant.) See fig. 3.7.
- Connecting both the spectrometer and PC to a network. See fig. 3.8.
- Connecting the spectrometer to a network computer. See fig. 3.9.

Depending on the connection variants, two different data cable types are required:

Data cable type	For realizing the following con- nection variant	Included in the delivery scope
Crossover cable	 Stand-alone operation, i.e. spectrometer is connected to a standalone PC. See fig. 3.7. Spectrometer is connected to a network computer. See fig. 3.9. 	Yes (1 item)
Straight through cable	 Spectrometer and PC are connected to a network. See fig. 3.8. Spectrometer is connected to a network computer. See fig. 3.9. 	No Note : A straight through data cable, category 5, with RJ45 plugs for the Ethernet standard 10/ 100Base-T is required. Note : The data cable length should not exceed 100m (without repeater).



Figure 3.5 and 3.6 illustrate the locations of the Ethernet ports for connecting the data cable(s).



Fig. 3.5	Ethernet port
А	labelled ETH

Depending on the connection variant, the data cable is connected to different Ethernet ports at the PC. (For information about possible connection variants, see section 3.10.2.)



Fig. 3.6	Ethernet port
A	labelled OPTIC CONNECTOR Note: At this Ethernet port, connect only a crossover data cable.
В	labelled LAN Note: At this Ethernet port, connect only a straight through data cable.

Installation 3

3.10.2 Possible connection variants

Spectrometer 10.10.0.1 Crossover cable Figure 3.7: Stand-alone operation

Variant A (Standard): Connecting the spectrometer to a stand-alone PC

The implementation of this connection variant involves the following steps:

- 1. Connect the supplied crossover data cable to the Ethernet port at the spectrometer rear side (A in fig. 3.5) and to the OPTIC CONNECTOR (A in fig. 3.6) at the PC rear side.
- 1 Only in case you have NOT purchased the computer at Bruker, you have to assign the IP address 10.10.0.2 to the computer to which you want to connect the spectrometer.
 - 2. Check the communication between spectrometer and PC. (See section 3.10.6.)

Advantages of this connection variant:

- Full bandwidth available for data transfer between the spectrometer and PC.
- No access conflicts with other PCs that try to access the spectrometer as well.
- No problems caused by varying data transfer rates.

Disadvantages of this connection variant:

- No remote access to the spectrometer from other PCs on which OPUS is installed.
- PC has no access to the network resources.
- A local printer needs to be connected to the stand-alone PC to print out the measurement results.
Variant B: Connecting both spectrometer and PC to a network



The implementation of this connection variant involves the following steps:

- Procure straight through cables category 5, with RJ45 plugs for the Ethernet standard 10/100Base-T. (Note: The number of data cables depends on the number of PCs you intended to connect to the network.)
- 2. **Spectrometer:** Connect one straight through data cable to the Ethernet port at the spectrometer rear side (A in fig. 3.5) and to the network hub.
- 3. **PC:** Connect the other straight through data cable to the LAN connector (B in fig. 3.6) at the PC rear side and to the network hub.
- 4. Assign an IP address to the spectrometer. (See section 3.10.4.) This IP address needs to be defined by your network administrator.
- 5. Assign an IP address to the PC (LAN network interface card). This IP address needs to be defined by your network administrator.
- 6. Check the communication between spectrometer and PC. (See section 3.10.6.)

Advantages of this connection variant:

- Remote access to the spectrometer via the internet or the intranet is possible.
- The PC can access to all network resources.

Disadvantages of this connection variant:

- Data cables are required which are not included in the delivery scope.
- Only a fraction of the bandwidth is available for the data transfer between PC and spectrometer. Due to data transfer delays, the measurement time may increase.
- Access conflicts caused by other PCs that try to access the spectrometer as well.

Variant C: Connecting the spectrometer to a network PC



The implementation of this connection variant involves the following steps:

- 1. Procure a straight through cable category 5, with RJ45 plugs for the Ethernet standard 10/100Base-T.
- 2. **Spectrometer:** Connect the supplied crossover data cable to the Ethernet port at the spectrometer rear side (A in fig. 3.5) and to the OPTIC CONNECTOR (A fig. 3.6) at the PC rear side.
- 3. **PC:** Connect the straight through cable to the LAN connector (B fig. 3.6) at the PC rear side and to a network hub.
- 4. Assign an IP address to the PC (LAN network interface card). This IP address needs to be defined by your network administrator.
- Only in case you have NOT purchased the computer at Bruker, you have to assign the IP address 10.10.0.2 to the computer to which you want to connect the spectrometer.
 - 5. Check the communication between spectrometer and PC. (See section 3.10.6.)

Advantages of this connection variant:

- Full bandwidth is available for the data transfer between the spectrometer and PC.
- Remote access to the spectrometer via internet or intranet is possible.
- The PC has access to all network resources.
- Different data transfer rates for the data exchange between the spectrometer (10/100Base-T) and the network (no restriction) are possible.

Disadvantages of this connection variant:

- A straight through cable is required which is not included in the delivery scope.
- A decrease in computing speed, due to the integration of the PC in a network, may affect time-critical measurements.

3.10.3 Network addresses

The possible connection variants require different network addresses for spectrometer and PC.

Network addresses in case of connection variant A (factory-configured variant):

The spectrometer and the PC delivered by Bruker are factory-configured for the standalone operation, i.e. all network addresses for this connection variant are already assigned. Only if you did not obtain the PC from Bruker, you have to assign the following network addresses to the PC.

	Spectrometer	PC	Note
IP address	10.10.0.1	10.10.0.2	
Subnet mask	255.255.255.0	255.255.255.252	
Gateway	0.0.0.0	0.0.0.0	Do not define when using Windows XP

Network addresses in case of connection variant B:

- Spectrometer and PC must have an unique IP address each.
- The IP addresses depend on the local intranet and have to be defined by your network administrator.
- In case the spectrometer is to be accessed via internet, you have to specify a gateway address as well. Note: The gateway links your intranet domain to other domains (e.g. domains being part of the internet).
- In case the spectrometer is not to be accessed via internet, set the gateway address to 0.0.0.0.
- In case of the operating system Windows XP, do not specify a gateway.

Important: A wrong IP address can cause problems with other devices connected to the network!

Network addresses in case of connection variant C:

The implementation of this connection variant requires the following preconditions:

- The PC needs to be equipped with two network interface cards.
- Three sets of network addresses have to be available:
 - one set of network addresses for the spectrometer
 - one set of network addresses for the OPTIC CONNECTOR network card in the PC (for the communication between PC and spectrometer)
 - one set of network addresses for the LAN network card in the PC (for the communication between PC and network)

	Spectrometer	OPTIC CONNEC- TOR network card	LAN network card
IP address	10.10.0.1	10.10.0.2	assigned by network administrator
Subnet mask	255.255.255.0	255.255.255.252	assigned by network administrator
Gateway	0.0.0.0 do not define when using Windows XP	0.0.0.0 do not define when using Windows XP	assigned by network administrator

3.10.4 Assigning a network address to the spectrometer

General information

The spectrometer is delivered with the factory-assigned standard IP address 10.10.0.1, i.e. in case of connection variant A and C you need not assign network addresses to the spectrometer.

Only in case of connection variant B (i.e. connecting the spectrometer directly to a network, see fig. 3.8), different spectrometer network addresses are required. They need to be defined by your network administrator and assigned to the spectrometer using the FCONF program (<u>Firmware Configuration</u>). This program is part of the OPUS software.

Network address assignment procedure





5	Assigning the address, subnet mask, and gateway to the spectrometer with the MAC address 00 00 AD 00 00 11 (this might take several minutes)	 The assigning process starts immediately and may take several minutes.
		 If the assigning process has been finished successfully, a message confirms the successful comple- tion and the spectrometer auto- matically reboots.
		Now the spectrometer starts up with the newly-assigned network addresses and can be accessed by the PC.
		In case you have assigned a new IP address to the spectrometer, replace the removable label ① at the spectrometer rear side by a new one showing the new IP-address.
	1	Important: Always keep the IP address on the label at the spec- trometer rear side up-to-date. A wrong IP address will lead to com- munication problems between spectrometer and PC!

3.10.5 PC network address

By default, the PC supplied by Bruker is equipped with two network interface cards labelled OPTIC CONNECTOR and LAN. The network interface card OPTIC CONNECTOR is factory-assigned to the IP address 10.10.0.2, i.e. the PC is factory-configured for the standard connection variant (i.e. connecting the spectrometer to a stand-alone PC). See fig. 3.7, connection variant A.)

In case of connection variant B (fig. 3.8) and variant C (fig. 3.9), your network administrator has to define the network addresses for the PC. These addresses need to be assigned to the network interface card LAN of the PC.

In case you have not obtained the PC from Bruker, you have to assign the correct network addresses to the network interface card(s) of the PC to which you connect the spectrometer. Note: The network address for the PC depend on the implemented connection variant. (See to section 3.10.3.) In case of connection variant C (fig. 3.9), make sure that the PC is equipped with two network interface cards.

3.10.6 Checking the communication between the spectrometer and the PC

After having connected the data cable(s) and, if required, assigned different network addresses to the spectrometer and/or the PC, it is recommended to check the communication between the spectrometer and the PC. To do this, proceed as follows:



4 Overview

This chapter provides an overview of all user-relevant external and internal spectrometer components.

4.1 External components

4.1.1 Spectrometer compartments



Fig. 4.1	Spectrometer compartment
А	Electronics compartment
В	Interferometer compartment
С	Detector compartment
D	Sample compartment
E	Beam direction control compartment

The detector compartment, the interferometer compartment and the beam direction control compartment are not separated from each other but form one compartment. All spectrometer compartments are accessible by removing the corresponding cover.

4.1.2 Status indicator board



The color of the six status indicator board LEDs gives a general indication of the operating status of the corresponding spectrometer component.

Moreover, the color of the VACUUM LED indicates the current pressure situation inside the spectrometer compartments (i.e it shows whether a certain compartment is being evacuated/vented just now or is already evacuated/vented).

In case one of these LEDs lights up red indicating a spectrometer malfunction refer to chapter 7 for troubleshooting.

VACUUM

The color of VACUUM LED depends on the current pressure situation inside the individual spectrometer compartments. The following table explains the meaning of the different LED colors:

LED is off.	Sample compartment and optical bench are vented.
LED flashes green.	Sample compartment and optical bench are being either evacuated or vented.
LED lights up green.	Sample compartment and optical bench are evacuated. The ultimate vacuum is achieved.
LED flashes yellow.	Sample compartment is being either evacuated or vented. (In case the sample compartment is already vented, it flashes yellow also when the optical bench is being vented.)
LED lights up yellow.	Sample compartment is vented.
LED lights up red.	When the spectrometer is being evacuated, but a certain threshold pres- sure value is not reached within a certain period of time (i.e. the ultimate vacuum is not achieved). A red VACUUM LED indicates a problem. See section 7.5.1.1 for troubleshooting.

LASER

LED lights up green.	The laser is on and the laser signal is OK.
LED lights up red.	 Normally, a red LASER LED indicates a laser problem, for example: Laser power is too weak or Laser beam is blocked or Laser module is defective or Laser module is out of alignment. See section 7.5.1.2 for troubleshooting. Important note: This LED also lights up red during the spectrometer initialization phase. In this case, there is not any laser problem. After the spectrometer initialization is completed successfully, this LED turns automatically to green.

STATUS

LED lights up green.	The spectrometer is in proper operating condition.	
LED lights up red.	 Normally, a red STATUS LED indicates a spectrometer problem. See section 7.5.1.3 for troubleshooting. Important note: This LED also lights up red during the spectrometer initialization phase. In this case, there is not any laser problem. After the spectrometer initialization is completed successfully, this LED turns automatically to green. 	

PRESSURE

LED lights up green.	There is sufficient air pressure for the air bearing of the linear scanner.	
LED lights up red.	There is not sufficient air pressure for the air bearing of the linear scanner.	
	In this case, measuring is not possible. See section 7.5.1.4 for trou- bleshooting.	

FLAPS

Note: The flaps are vacuum shutters. They are an optional spectrometer feature. The spectrometer is equipped with two flaps. Depending on whether you want to purge, vent or evacuate either the complete spectrometer (i.e. optical bench plus sample compartment) or only either of the two compartments, the two sample compartment wall openings are closed or opened by the flaps. With the flaps closing the two sample compartment wall openings, the flaps provide an air-tight separation of the sample compartment from the optical bench¹.

1. The optical bench includes the interferometer compartment, the detector compartment and the beam direction control compartment. These compartments are not physically separated from each other.

LED lights up green.	The flaps are open. Note: In this case, both the sample compartment and the optical bench can be vented or evacuated.
LED lights up yellow.	The flaps are closed. Note: In this case, the sample compartment and the optical bench can be vented or evacuated separately from each other.
LED lights up red.	There is a flap malfunction or an error regarding the flaps. See section 7.5.1.5 for troubleshooting.

BMS

LED lights up green.	There is a beamsplitter properly installed in the operating position.
LED lights up red.	There is not any beamsplitter installed in the operating position OR the beamsplitter is not installed properly (i.e. it is not locked.) For information about how to install the beamsplitter, see section 5.10. See section 7.5.1.6 for troubleshooting.

4.1.3 Sample compartment



Important note: When you evacuate the sample compartment, do not forget to close the sample compartment properly again!



Bruker offers a large variety of QuickLock-type measurement accessories which are designed for dedicated R&D applications.

i

4.1.4 IR beam ports

The spectrometer has seven IR beam ports - five IR beam outlet ports and two IR beam inlet ports - allowing the coupling / connection of external accessories and/or components (e.g. FT-IR microscope, Raman module, external light source) to the spectrometer. (See also section 2.4.)

	Spectrometer front side
VERTEX 80v	 Outlet port for a focussed IR-beam (e.g. for connecting a bolometer) Outlet port for a parallel IR-beam (e.g. for connecting a fiber optic coupling module)
	 Spectrometer rear side (3) - Inlet port for connecting a light emission source (e.g. Hg source)
	Right spectrometer side
	(4) - Outlet port for a parallel IR-beam
	(5) - Outlet port for a parallel IR-beam (e.g. for connecting the FT-IR microscope HYPERION, PMA50 or external sample compartment XSA)
	6 - Inlet port for connecting a light emission source (e.g. FT Raman module RAM II, water-cooled, high-power MIR source)
(7)	Left spectrometer side
	 Outlet port for a parallel IR-beam (e.g. for connecting the FT-IR microscope HYPERION or an external detector chamber)

1 External accessories (e.g. FT-IR microscope HYPERION) are coupled to the spectrometer by a Bruker service technician only.

All vacant IR-beam ports are vacuum-tight sealed by covers.

4.1.5 **Ports and connectors at the spectrometer rear side**

This section provides an overview of only the most important ports, connectors and buttons at the spectrometer rear side.

General overview



Fig. 4.3	Ports, connectors and buttons
А	Inlet port for connecting a light emission source (e.g. Hg source)
В	Port for connecting the vacuum pump Note: For information about how to connect the vacuum pump to the spectrometer, see section 3.8.
С	Port for connecting the compressed air hose Note: For information about how to connected the spectrometer to a com- pressed-air line, see section 3.7.
D	Electronics unit Note: For detailed information, see appendix E.
E	Power supply unit Note: For detailed information, see appendix E.
F	ON/OFF switch (for switch on / off the spectrometer)
G	Low-voltage socket for connecting the spectrometer to the mains supply Note: For information about how to connect the spectrometer to the mains supply, see section 3.6.

Fig. 4.3	Ports, connectors and buttons
Н	ETH port for connecting the data cable Note: For information about how to connect the spectrometer to a PC, see section 3.10.
1	Vent openings OR purge gas inlets Note: Depending on whether you evacuate or purge the spectrometer, these two ports serve different purposes. In case of evacuating the spec- trometer, these ports serve as vent openings, whereas, when the spec- trometer is purged, the purge gas supply hoses are connected to these ports. Note: For information about how to connect the purge gas hoses, see section 3.9.

4.2 Internal components

4.2.1 Overview

Figure 4.4 shows the location of the most important internal spectrometer components.



Fig. 4.4	Internal spectrometer component
А	Sample holder (included in the standard delivery scope)
	(Note: This sample holder can be exchanged for any another QuickLock-type measurement accessory.)
В	Detectors (digiTect-type)
С	Linear air bearing scanner (UltraScan, true-aligned)
D	Laser
E	2x beamsplitters (in storage position)
F	Beamsplitter (in operation position)
G	MIR source (in operation position)
	Note: It is the standard source.
Н	NIR source (in storage position)
	Note: It is an optional source.
1	QuickLock clamping mechanism (for positioning the measurement accessory in the sample comportment)

4.2.2 Source

Standard source

The basic spectrometer configuration is equipped a MIR source which is installed inside the spectrometer (G in fig. 4.4).

The MIR source is a globar (i.e. an U-shaped silicon carbide piece) that emits mid-infrared light. It is air-cooled, i.e. it does not require special cooling.

With this source, spectroscopic measurements in the mid-infrared region can be performed.

Optional sources

The available optional sources provide for different spectral ranges. Note that the combination of source, detector and beamsplitter defines the IR measurement range.

Type of source	Mode of cooling	Installation location
VIS/NIR source (tungsten halogen lamp)	air-cooled	installed in the spectrometer (G in fig. 4.4)
FIR source (mercury lamp)	water-cooled ^a	connected externally to the spectrometer
UV/VIS/NIR source (tungsten lamp)	water-cooled ^a	connected externally to the spectrometer
UV source (deuterium lamp)	air-cooled	connected externally to the spectrometer
High-power MIR source (globar)	water-cooled ^a	connected externally to the spectrometer

a. For the usage of a water-cooled source, a cooling device with closed water circulation is included in the delivery scope.

All external sources can be connected to either of the two inlet ports (A or B in fig. 4.5). Only for the FIR source (mercury lamp), the preferred connection port is the inlet port at the spectrometer rear side (A in fig. 4.5).



4.2.3 Detector

General information

All available detectors are equipped with an integrated preamplifier and an A/D converter that converts the analog signal from the detector directly into a digital signal. This so called DigiTect technology allows for an interference-free signal transmission and ensure a high signal-to-noise-ratio.



Optionally, an external detector chamber is available. The external detector chamber is coupled to the IR outlet port at the left spectrometer side. (See section 4.1.4.) With the external detector chamber, the spectrometer can be equipped with up to five detectors as follows:



The detector which is to be used for the measurement is selected by the user in OPUS.

Standard detector

The standard detector is a pyroelectric DLaTGS detector which covers a spectral range from 12,000 to 250 cm^{-1} , operates at room temperature and has a sensitivity of D*>4x10⁸ cm Hz^{1/2} W⁻¹.

Optional detectors

The available optional detectors provide for different spectral ranges and sensitivities. Note that the combination of source, detector and beamsplitter defines the IR measurement range.

Detector **Spectral range** Sensitivity Operating temperature / (cm⁻¹) cooling mode Mid-Infrared DLaTGS with KBr 12,000 - 250 Room temperature D*>4x10⁸ cm Hz^{1/2}W⁻¹ window (Standard) DLaTGS with Csl 12,000 - 180 D*>4x10⁸cm Hz^{1/2}W⁻¹ Room temperature window MCT narrow band, with 12,000 - 850 D*:>4x10¹⁰cm Hz^{1/2} W⁻¹ Liquid N₂ cooled BaF₂ window HARMFUL! MCT mid band, with 12,000 - 600 D*:>2x10¹⁰cm Hz^{1/2} W⁻¹ Liquid N₂ cooled ZnSe window TOXIC! MCT broad band, with 12,000 - 420 Liquid N₂ cooled D*:>5x10⁹cm Hz^{1/2}W⁻¹ KRS-5 window TOXIC! Photovoltaic MCT, with 12,000 - 850 Liquid N₂ cooled D*:>3x10¹⁰cm Hz^{1/2} W⁻¹ BaF₂ window HARMFUL! MCT/InSb sandwich, 10,000 - 600 $D^*:>2x10^{10} \text{ cm Hz}^{1/2}W^{-1}$ (MCT) Liquid N₂ cooled with ZnSe window $D^*:>1.5x10^{11}$ cm Hz^{1/2}W⁻¹(InSb) TOXIC! Near-Infrared InSb 10,000 - 1,850 D*:>1.5x10¹¹cm Hz^{1/2} W⁻¹ Liquid N₂ cooled InSb with cold filter D*>5x10¹¹cm Hz^{1/2} W⁻¹ 10,000 - 3,100 Liquid N₂ cooled Ge detector 11,750 - 5,900 NEP<10⁻¹⁵ W Hz^{-1/2} Liquid N₂ cooled InGaAs diode 12,800 - 5,800 NEP:<2x10⁻¹⁴ W Hz^{-1/2} Room temperature InGaAs diode 12,800 - 4,000 Room temperature NEP:<2x10⁻¹³ W Hz^{-1/2}

The following optional detectors are available:

Detector	Spectral range (cm ⁻¹)	Sensitivity	Operating temperature / cooling mode
Far Infrared			
DLaTGS with PE window	700 - 10	D*>4x10 ⁸ cm Hz ^{1/2} W ⁻¹	Room temperature
Silicon bolometer	600 - 8 35 - 4*	NEP<10 ⁻¹³ W Hz ^{-1/2}	Liquid He cooled (*) Liquid He needs to be pumped off.
Visible & UV			
Silicon diode	25,000 - 9,000	NEP:<10 ⁻¹⁴ W Hz ^{-1/2}	Room temperature
GaP diode	50,000-18,000	NEP:<5x10 ⁻¹⁵ W Hz ^{-1/2}	Room temperature

Some detectors are equipped with windows of which the material is harmful or (very) toxic. During normal spectrometer operation, these materials do not pose any health hazard. However, should such a detector window break because of mechanical impact, be extremely careful.



Health hazard because of improper handling of broken harmful or toxic detector window material

Non-observance of the following safety instructions could result in death or serious injury.

- Avoid generating dust of broken detector window material. This material is harmful or toxic if swallowed or inhaled.
- ➤ Also avoid skin and eye contact.
- Dispose the harmful or toxic material according to the laboratory regulations and the national regulations.

For detailed information about how to exchange a detector, see section 5.11.

4.2.4 Beamsplitter

Standard beamsplitter

The basic spectrometer configuration is equipped with a KBr beamsplitter which covers a spectral range from 8000 to 350cm⁻¹.

Optional beamsplitters

The available optional beamsplitters provide for different spectral ranges. Note that the combination of source, detector and beamsplitter defines the IR measurement range. The following optional beamsplitters are available:

Beamsplitter	Spectral range (cm ⁻¹)	Color coding of the beamsplitter handle
Mid-Infrared		
KBr (standard)	8,000 - 350	red
KBr (broad band)	10,000 - 400	red
Near-Infrared		
CaF ₂ HARMFUL!	15,000 - 1,200	brown
Visible & UV		
CaF ₂ NIR/VIS/UV (broad band)	50,000 - 4,000	white
Far-Infrared		
Multilayer (far IR)	680 - 30	metallic
Mylar 25µm	120 - 20	metallic
Mylar 50µm	60 - 10	metallic
Mylar 125µm	22 - 5	metallic
Alignment (glass)	visible	nickel-plated

A WARNING

Health hazard because of improper handling of broken harmful beamsplitter material



Non-observance of the following safety instructions could result in death or serious injury.

- ➤ Avoid generating dust of broken beamsplitter material. The material is harmful if swallowed or inhaled.
- ➤ Also avoid skin and eye contact.
- > Dispose the harmful material according to the laboratory regulations and the national regulations.

Possible beamsplitter exchanging procedures



For detailed information about how to exchange the beamsplitter, see section 5.10.

4.2.5 Laser

The spectrometer is equipped with a HeNe laser (D in fig. 4.4) that emits red light with a wavelength of 632.8nm and has a rated power output of 5mW.

The laser controls the position of the moving interferometer mirror (also called "scanner") and is used to determine the data sampling positions. The monochromatic beam produced by the HeNe laser is modulated by the interferometer to generate a sinusoidal signal.

4.2.6 Interferometer

The spectrometer is equipped with an actively aligned UltraScan interferometer (C in fig. 4.4) based on a linear scanner which ensures highest possible spectral resolution (standard: better than 0.2 cm^{-1} , optional: better than 0.07 cm^{-1}).

The linear scanner is supported by an air bearing which requires the connection to a compressed air line. (For detailed information about how to connect the spectrometer to a compressed air line, see section 3.7.)

4.2.7 Sample compartment windows

General information

Basically, there is a circular opening on either sample compartment side. Through the opening in the left sample compartment wall, the IR beam enters the sample compartment. Through the opening in the right sample compartment wall, the IR beam exits the sample compartment.

Optionally, these openings are closed by IR-transparent windows. The windows are either flanged directly to the sample compartment walls or they are mounted on the flaps¹ or they are of telescopic type.

Overview of the available window materials

The following table lists the available window materials including their transmission range, refraction index and chemical properties.

Material	Transmission range (cm ⁻¹)*	Refraction index n (at 2000cm ⁻¹)	Chemical properties
Quartz (Infrasil) SiO ₂	57,000 - 2,800	1.46	Insoluble in water; soluble in HF
Silicon Si	10,000 - 100	3.42	Insoluble in most acids and bases; soluble in HF and HNO_3
Calcium Fluoride CaF ₂	66,000 - 1,000	1.40	Insoluble in water; resistant to most acids and bases; soluble in NH ₄ salts
Barium Fluoride BaF ₂ HARMFUL!	50,000 - 800	1.45	Low water solubility; soluble in acid and NH ₄ Cl
Sodium Chloride NaCl	28,000 - 580	1.50	Hygroscopic; slightly soluble in alcohol and NH ₃
Zinc Selenide ZnSe TOXIC!	20,000 - 500	2.43	Soluble in strong acids and in HNO ₃
Potassium Bromide KBr	33,000 - 280	1.54	Soluble in water, alcohol, and glycerine; hygroscopic

The flaps are vacuum shutters. The purpose of the flaps is to provide an air-tight separation of the sample compartment from the optical bench in case you want to purge, evacuate or vent only either compartment. Note: Flaps are an optional spectrometer feature.

Material	Transmission range (cm ⁻¹)*	Refraction index n (at 2000cm ⁻¹)	Chemical properties
Cesium lodide Csl HARMFUL!	33,000 - 180	1.74	Soluble in water and alcohol; hygroscopic
KRS-5 (TIBr/I thallium bromide-iodide) VERY TOXIC!	16,000 - 250	2.38	Soluble in warm water and bases; insoluble in acids
Polyethylene PE (high density)	600 - 10	1.52	Resistant to most solvents

50% value at a window thickness of 4mm

Some sample compartment windows are of a material which is harmful or (very) toxic. During normal spectrometer operation, these materials do not pose any health hazard. However, should such a window break because of mechanical impact, be extremely careful.

Health hazard because of improper handling of broken harmful or toxic window material



Non-observance of the following safety instructions could result in death or serious injury.

- Avoid generating dust of broken window material. This material is harmful or toxic if swallowed or inhaled.
- ➤ Also avoid skin and eye contact.
- Dispose the harmful or toxic material according to the laboratory regulations and the national regulations.
- > Observe also the safety instructions of the attached safety data sheets.

For detailed information about how to exchange a sample compartment window, see section 6.5.

4.3 Optical beam path

Note: The optical beam path shown in fig. 4.6 is the optical beam path of the standard spectrometer configuration.



Abbreviation	Explanation
D1	Standard detector
D2	Optional detector
BMS	Beamsplitter
APT	Aperture wheel
IVU / OF	Internal validation wheel / optical filter wheel
IN 1 and IN 2	IR beam inlet port 1 and 2
OUT 1 OUT 5	IR beam outlet port 1 to 5

5 Operation

5.1 General information

The spectrometer is completely computer-controlled, i.e. operating the spectrometer (e.g. selecting the correct spectrometer component), performing a spectroscopic measurement as well as evacuating and venting the spectrometer is done using the spectroscopic software program OPUS.

This manual is restricted mainly to the spectrometer-related aspects that are relevant to operating the spectrometer:

- · putting the spectrometer into operation and shutting the spectrometer down
- chronological sequence of the individual operating steps during a measurement (general measurement procedure)
- evacuating and venting the spectrometer
- purging the spectrometer
- checking the signal
- extending the spectral range
- cooling the MCT detector

Specifying the measurement parameters and starting a measurement and evaluating the measurement results as well as defining and starting a spectrometer validation test (OQ and PQ) are done exclusively using the spectroscopic software program OPUS. For detailed information about these topics refer to the OPUS Reference Manual. For information about the measurement parameters, see also appendix C.

The standard spectrometer configuration is designed for measurements in the mid infrared region. Optionally, the spectral range can be expanded by exchanging the installed MIR components (source, detector and beamsplitter, if available) for the corresponding optical components that allow measurements in the far or near infrared as well as in the visible or ultraviolet region. (For information about the substitution procedure of these optional components refer to the corresponding sections in this chapter.)

5.2 Putting the spectrometer into operation

Provided that the spectrometer has been shut down as described in section 5.3, put the spectrometer into operation as follows:





5.3 Shutting down the spectrometer

Ideally, the optical bench of the spectrometer should always be kept under vacuum and the compressed air supply for the air bearing of the linear scanner should not be interrupted even during time of nonuse (e.g. overnight). If, however, the circumstances require a spectrometer switch-off and/or the vacuum pump switch-off and/or an interruption of the compressed air supply, the following shut-down procedure is recommended:

1		 Interrupt the compressed air supply by either stopping the supply or pulling off the compressed air hose from the spectrometer. Note: In the latter case, the spectrometer has to be vented first. Afterwards, seal the inlet using the intended plug (1). As soon as the compressed air supply is interrupted, the scanner will stop automatically.
2	Materierent Materierent	Evacuate the optical bench of the spec- trometer. To do this, click in the OPUS <i>Measurement</i> dialog on the <i>Evacuate</i> <i>Optics</i> button ①. (See also section 5.6.) ➤ The evacuation will take about 5 minutes.
3		 As soon as the optical bench is evacuated completely, switch off the spectrometer using the ON/OFF switch ① at the spectrometer rear side. ➤ In the electroless spectrometer state, all valves (i.e. all valves for evacuating and venting the spectrometer) are closed.



5.4 Placing an accessory in the sample compartment

5.4.1 QuickLock mechanism

Bruker offers a large variety of measurement accessories designed for dedicated applications. For installing these accessories in the spectrometer, the sample compartment is equipped with an accessory locking mechanism called QuickLock. Therefore, only accessories with a QuickLock-baseplate can be used.

The QuickLock locking mechanism allows for a solid lock and a quick and exact positioning of the accessory in the sample compartment. And the available QuickLock-type accessories ensure an exact and reproducible positioning of the sample in the measurement position.

	 Spectrometer sample compartment (inside view) ① - Contract strip (electronic connectors for AAR and CAN bus; it is the counterpart to the contact strip at the QuickLock baseplate of the accessory ④) ② - QuickLock mechanism for locking
	Standard sample holder with Quick- Lock baseplate 3 - Purge gas diffusor for purging the
4	 (4) - Contract strip (electronic connectors for AAR and CAN bus; it is the counterpart to the contact strip at the QuickLock mechanism in the sample compartment (1)) Note: This sample holder is included in the standard delivery scope of the spectrometer.
(5) VERTEX 80V	Spectrometer (front view) (5) - QuickLock release button

5.4.2 Putting an accessory in the sample compartment

- 1. Push the contact strip of the accessory QuickLock baseplate gently against its counterpart of the QuickLock mechanism in the sample compartment while tilting the accessory QuickLock baseplate front edge slightly upwards.
- 2. Put down the accessory QuickLock baseplate and make sure that the accessory QuickLock baseplate is orientated straight.
- 3. While pressing the release button outside the sample compartment, press the front edge of the accessory QuickLock baseplate downwards until it snaps into the QuickLock mechanism.
- As soon as the accessory QuickLock baseplate locks in place, the electronic connections for AAR are established. This is indicated by a beep.

5.4.3 Automatic accessory recognition (AAR)

All QuickLock-type accessories are electronically coded. So, as soon as an accessory locks in place of the spectrometer QuickLock mechanism, it is automatically recognized by the OPUS software program. This software feature is called AAR (<u>A</u>utomatic <u>A</u>ccessory <u>R</u>ecognition). In addition, the OPUS/AAR program performs several predefined OVP tests and loads automatically the corresponding experiment file including the adequate measurement parameter settings and values, provided the user has already defined and stored them for the accessory in question.

Note: When you put a certain accessory in the sample compartment for the very first time, the OPUS/AAR software cannot recognize it because it is not yet registered. In this case, the software prompts you to register the new accessory.

For detailed information about the OPUS software feature AAR, refer to the OPUS Reference Manual. For detailed information about how to define OVP test parameters for certain accessory types, see the Accessory Manager User Manual.

5.4.4 Taking an accessory out of the sample compartment

- 1. While pressing the release button outside the sample compartment, lift the front edge of the accessory QuickLock baseplate until the baseplate snaps free.
- 2. Take the accessory out of the QuickLock mechanism in the sample compartment. Be careful not to damage the contact strips.

5.5 General measurement procedure

It is highly recommended to validate the spectrometer performance each day before you start your analytical work by performing a PQ test¹ using OVP². For detailed information about how to validate the spectrometer refer to the OPUS Reference Manual.

The following procedure refers exclusively to measurements under vacuum. In case you intend to perform a measurement not under vacuum, ignore the steps regarding evacuating and venting the spectrometer.

- 1. If you intend to measure the sample using a special accessory³, place the accessory (without sample!) in the sample compartment. (See the section 5.4.) If you intend to measure the sample using the standard sample holder, you can skip this step. (Note: This sample holder is included in the standard delivery scope.) Close the sample compartment.
- 2. Specify the measurement parameters in OPUS. (Note: The standard parameter settings and values are listed in appendix C.)
- 3. Evacuate the spectrometer (optical bench and sample compartment), if not already done. (See section 5.6.3)
- 4. Start a background measurement⁴ (i.e. **without** a sample being in the sample compartment) by clicking in the OPUS *Measurement* dialog on the *Background Single Channel* button.
- Depending on how you intend to prepare your sample (e.g. KBr pellet, mull or sample solution), it is highly recommended to perform the background measurement with either a pure KBr pellet or the pure nujol or the pure solution placed in the sample position. (For detailed information about sample preparation refer to appendix G.)
- 5. Vent only the sample compartment. (See section 5.6.4.)
- 6. Put the sample in the sample compartment by positioning the sample in the measurement position. Close the sample compartment.
- 7. Evacuate the sample compartment. (See section 5.6.3.)
- 8. Start a sample measurement by clicking in the OPUS *Measurement* dialog on the *Sample Single Channel* button.
- Important: Perform both the background measurement and the sample measurement with the same parameter settings in OPUS. Ensure that for both measurements, the ambient conditions (water vapor concentration, temperature etc.) are identical or at least nearly identical.
- Afterwards, OPUS calculates automatically the result sample spectrum by dividing the sample spectrum (acquired in step 8) by the background spectrum (acquired in step 4).

For detailed information about the OPUS functions for data acquisition, manipulation and evaluation refer to the OPUS Reference Manual.

^{1.} PQ test - Performance <u>Q</u>ualification Test

^{2.} OVP - OPUS Validation Program (It is intended for performing spectrometer validation tests like OQ and PQ.)

^{3.} Bruker offers a wide range of accessories designed for special analytical applications. For detailed information about how to perform a measurement with a particular accessory, refer to the User Instructions delivered with the accessory in question.

^{4.} The purpose of the background measurement is to detect the influence of the ambient conditions (level of air humidity, temperature etc.), the auxiliary materials (e.g. solutions), that are required for preparing the sample, and the spectrometer itself on the spectroscopic measurement result. After the subsequent sample measurement, OPUS calculates automatically the result sample spectrum by dividing the sample spectrum (SSC) by the background spectrum (RSC). In doing so, those spectral bands, that result from the ambient conditions, auxiliary materials and/or the spectrometer, are eliminated from the result sample spectrum.

5.6 Evacuating and venting the spectrometer

5.6.1 Activating the vacuum mode in OPUS

The spectrometer can be operated either in the vacuum mode or in the purge mode. To activate the vacuum mode, select in the OPUS *Measure* menu the *Optic Setup and Service* function. Click on the *Devices/Options* tab and make sure that the *Purge Mode* check box is deactivated. See fig. 5.1.

Uptical Bench Devices Options Interferor	eter/AQP Export Options Service Optic Communication Control Panel	
Source Setup	Use login operator name	
Beamsplitter Setup	Automatic Accessory Recognition	
Gotical filter Setup	🗌 🔲 Gain Switch Gain	
Aperture Setup	Multiplexed data	
Iris aperture	Vait for devices ready Setup	
Polarizer Setup	PLL Laser Multiply	
Channel Setup	User signals	
Setup	AQP with Digital Filters	
Setup	Ext. synchronisation (Sonde) Setup	
✓ Preamplifier gain Setup	Mapping device Setup	
Velocity Setup	Transient recorder Setup	
I High Pass Filter Setup	Imaging device Setup	
Low Pass Filter Setup	Correlation mode Setup	
	🗆 Purge Mode	_ vacuum mode
	Setup Besult Spectrum	is activated
Save Settings	Cancel Help	

5.6.2 General information

The flaps as well as the venting and evacuating valves are controlled automatically via the OPUS software. So, evacuating and venting the sample compartment and/or optical bench is done by clicking on the corresponding buttons at the *Basic* page of the *Measurement* dialog window. See fig. 5.2.

Mossurement Deck Signal Basic Deck Signal Experiment Sample name: Sample name: Sample name: Patr: File name: Background Single Drame Sample Single Drame	el Beam Path Dople Canoli DEFAULT rangle rangle some from D-OPPUS & DIMEAS WORK el el Canoli Canoli	Special Range Selection FT Display Eackgound Evacuate Optics Evacuate Optics Evacuate Sample Optics Vented 1010 MPs Eargle Vented 1010 MPs Eargle Vented 1010 MPs Help	Command that is executed by clicking on these buttons. Note: After you have clicked on a button, the labeling of this button changes immediately showing the action that can be performed next (i.e. <i>Evacuate</i> turns to <i>Vent</i> and versa vice). Current state in the optical bench and in the sample compartment including the current pressure readings
Figure 5.2: c	ptical bench and	sample compartment a	are vented.

To prevent OPUS from starting a measurement while the spectrometer is still being evacuated or vented proceed as follows: Click in the *Measurement* dialog window on the *Optic* tab and select in the *Optical bench ready* drop-down list the option *Pressure stable*. See fig. 5.3.

Extend synchronisation Souce setting Defined Filer setting Aprilue setting Defined Filer setting Defined Filer setting Defined Filer setting Defined set	External synchronisation: 00 Source setting: 14/R Quicol Filter setting: 00 Aporture setting: 025 mm Measurement channet: 5 angle Compartment Backgound meas. channet: 5 angle Compartment
	Defector setting Scanner velocity: T0 3Hz Sample igend gain: Background igend gain: Preseig gain: T0 3Hz Sample igend gain: T0 3Hz Defect and the setting Defect and

5.6.3 Evacuating

Let us assume the following initial situation: both the sample compartment and the optical bench are vented. In this case, it is **not** possible to evacuate either only the sample compartment or only the optical bench. So, clicking on either button effects the evacuation of both compartments.

The evacuation process is indicated by the messages *Optics Evacuating* and *Sample Evacuating* that appear in the fields below the buttons. The progress of the evacuation is shown by the permanently updated pressure readings in the lower fields. See fig 5.4.

	Check Signal Rexm Path Spectral Range Selection Check Signal Resm Path Spectral Range Selection Acquintion FT Display Rangeound Experiment Load DEFAULT Operator name Data Sample name Image	
	Background Single Channel Vent Optics Vent Single Vent Single Optics Evacuating 516 HPa Sample Evacuating 516 HPa Sample Single Channel Sample Evacuating 516 HPa	 Message indicat- ing the running evacuation pro- cess and the cur- rent pressure
	Exit Cancel Help	reading
F	Figure 5.4: Optical bench and sample compartment are being evacuated.	
As soon as the evacuation process is completed, the messages *Optics Evacuated* and *Sample Evacuated* appear in the lower fields. See fig. 5.5.

Messurement Dreck Signal Basic E Advan Dipension name Sample forms	Beam Path cod Optic Acquisiton Load DEFAULT Dataut sample sample form	Spectral Range Sele FT Display	ction Background	
Park File name Background Single Charr	D'OPPIS EOMEAS WORK	Vent Optics Vent Sample Optics Evacuated 31Pa Sample Evacuated 31Pa]	
Sample Single Drawal	Caroli	Hebo		
Figure 5.5: C	Dptical bench and are evacuated.	I sample com	partment	

> When the sample compartment is evacuated you cannot open it.

5.6.4 Venting

When both compartments are evacuated you can vent the sample compartment separately (for example, if you want to open the sample compartment in order to exchange the sample) by clicking on the *Vent Sample* button.

F	igure 5.6: Optical bench is evacuated, sample compartment is vented.

When both compartments are evacuated, venting only the optical bench is **not** possible because the pressure ratio inside the spectrometer would damage the flaps. For safety reasons, the instrument does not perform this operation. In this case, clicking on the *Vent Optics* button effects the ventilation of the sample compartment as well. This precaution prevents the instrument from being operated wrongly.

5.7 Optimizing the vacuum

5.7.1 General information

To get optimum measurement results under vacuum conditions, there are some aspects that need to be taken into consideration:

- The thermal conditions in an evacuated optics bench and in a purged optics bench are completely different, i.e., under vacuum there is no thermal conduction at all due to the lack of the purge gas. This aspect has consequences on the reproducibility of the measurement results.
- Water molecules are very polar. Due to this property, they tend to stick at the inner wall of the optics compartment. For this reason, it takes time to get the water vapor pumped off completely.

The purpose of the following advice is to help you in achieving optimum measurement results.

5.7.2 Reproducibility of the measurement results

After you have evacuated the spectrometer, it is highly recommended that you allow the spectrometer to stabilize long enough. An optimally stabilized spectrometer is able to achieve an extreme high 100%-line stability in the sub-%-level with the standard optical components designed for MIR measurements. (Note: A precondition is that the room temperature does not vary by more than 1°C per hour and 2°C per day. Typically, this condition can be fulfilled in an air-conditioned environment.)

Recommendations:

- For demanding experiments, a stabilization period of at least 4 hours is recommended. After this period, the maximum instrument stability is achieved.
- For non demanding experiments, a stabilization time of 0.5 hour is sufficient.
- During a long-term experiment, it is recommended to repeat the background measurement in regular interval, at least every hour.
- Ideally, the spectrometer should be kept under vacuum overnight.

5.7.3 Residual water vapor

The following measures will further reduce the residual water vapor concentration inside the spectrometer:

- longer evacuation times
- a low dew point of the compressed air¹ (The compressed air should have a pressure dew point of at least -20°C; a pressure dew point of less than -50°C would be ideal. However, not the absolute dryness degree of the compressed air is of crucial importance but the long-term constancy regarding the dryness of the supplied compressed air.)
- 1. Note: Compressed air is required for the air bearing of the linear scanner.)

Besides the necessity of a water vapor concentration being as low as possible, there is another aspect regarding water vapor you have to take into consideration: The water vapor line intensity in the sample spectrum does not depend on the absolute residual water vapor concentration in the spectrometer but on the different water vapor concentrations during the background and the sample measurement. Therefore, it is of crucial importance that the residual water vapor concentration is (nearly) identical during both the background measurement and the sample measurement.

5.7.4 Evacuation time

As mentioned above, water molecules are very polar. Due to this property, they tend to stick at the inner wall of the optics compartment, even under vacuum. For this reason, a long evacuation time is recommended. Ideally, the evacuation of the spectrometer should not be interrupted overnight. This action will further reduce the residual water vapor content.

5.7.5 Optimal evacuation procedure

Before acquiring a background spectrum, simulate a sample exchange in the same way as you will do it later for the "real" sample measurement:

- 1. Vent the sample compartment.
- 2. Afterwards, evacuate the sample compartment for about 3 to 5 minutes. (An evacuation time longer than 5 minutes is not necessary because after that period, the final pressure of < 3 hPa (< 3 mbar) will be achieved.)
- As soon as the final pressure is achieved, the message Sample Evacuated and the current pressure value are displayed in the Measure dialog window (fig. 5.7). The achievement of the final pressure is also indicated by the VACUUM LED at the spectrometer top side, i.e. this LED lights green. (See also section 4.1.2.)

Moostroot	Int Check Signal Check Signal E Advanced Op Experiment, Laad D Operatin name, Default Sample name, Sample name, Party D-VOPUS E0W File name, WORK Backgound Single Charnel	Beam Path Ac Acqueillon FT EFAULT EAS	Spectral Range Selection	n aadigound	
	Sample Single Doarnel	Optics E Sangle 1 Cancel	Evocute Sample evocute 104 PPa Evocuted 104 PPa Evocuted 104 PPa Help	-	Current state inside the indi- vidual compart- ments including the current pres- sure reading
Figu	e 5.7: OPUS I	Measurement d	ialog - page	Basic	

Important: The evacuation time before the background measurement and the evacuation time before the sample measurement have to be more or less identical. To ensure reproducible evacuation times, specify in OPUS a *Delay before Measurement*. See the fig. 5.8.

Extend synchroniation: Source retiring Beampätte: Optical Piter setting Acenture setting Measurement Channel: Backgound meas: channel: Delector setting Sconner velsorie	100 w H4R w Vah w Down w Form w Sample Companiest w Rische Companiest w Rische Companiest w Rische Companiest w 11 Octat w	Guent Traumisionshalke 19951910 I Preseppinis (Rud III)	
Semble signal gain: Background signal gain: Delay after dervice change: Delay before measurement: Optical bench ready:	Automatic w Automatic w p p 200 007 w	×	Specifying a mea- surement delay time
Save and Exit	Cancel	Help	

- 3. Acquire a single channel background spectrum.
- 4. Afterwards, vent the sample compartment and place the sample in the sample compartment.
- 5. Evacuate sample compartment for about 3 to 5 minutes.
- 6. Acquire a single channel sample spectrum.
- Take into account that the intensity of the water vapor band in the sample spectrum does not depend on the absolute residual water vapor concentration but results from a water vapor concentration difference during the background and the sample measurement.

With the above described operation conditions and a spectral resolution of 4cm⁻¹, typically a residual water vapor band intensity in the range of significantly less than 0.1%T can be achieved.

5.8 **Purging the spectrometer**

5.8.1 General information

Purging the spectrometer is not necessarily required, especially when you perform measurements under vacuum. If, however, you do not perform the measurements under vacuum, purging is recommended, especially when you frequently open the compartment covers (e.g. due to a detector or beamsplitter replacement or a sample substitution) or if the ambient air humidity content is too high. In these cases purging reduces the level of water vapor, CO_2 or other components of the ambient air inside the spectrometer.

❑ Water vapor, CO₂ and other atmospheric contaminants cause unwanted absorption. For this reason, open the sample compartment, the detector compartment and/or the interferometer compartment only if it is really necessary in order to prevent water vapor, CO₂ or other contaminants from entering the above mentioned spectrometer compartments.

Purge gas requirements

Purge the spectrometer, for example, with dry air or low pressure nitrogen gas. The purge gas supply has to meet the following requirements:

- dry air or nitrogen gas (dew point < -40°C corresponds to a degree of dryness of 128ppm humidity)
- oil-free and dust-free
- min. pressure: 1 bar (14.5 psi)
- max. pressure: 2 bar (29 psi)
- initial purge gas flow rate should not exceed 500 liters/hour
- sustained purge gas flow rate should not exceed 200 liters/hour

A DANGER

Risk of fire because of purging the spectrometer with a flammable gas



Non-observance of the following safety instructions could result in death or serious injury and major property damage.

- Do <u>not</u> feed <u>a flammable gas</u> into the spectrometer. Some spectrometer components become hot during operation. If a flammable gas comes in contact with a hot component, there will be the risk of fire.
- \succ Purge the spectrometer only with dry air or nitrogen gas.

For information about how to connect the spectrometer to a purge gas supply line, see section 3.9.

Preparatory actions

- In case you use an "open" accessory (e.g. A480 Parallel Beam Unit), make sure that the purge gas inlet opening (B in fig. 5.9) in the sample compartment is open.
- In case you want to purge an "enclosed" accessory (e.g. micro ATR unit) you have to close the purge gas inlet opening in the sample compartment in order to ensure a sufficient purge of the accessory. Close the inlet opening (B in fig. 5.9) by screwing on the cap (C in fig. 5.9).
- Attention: For performing measurements under vacuum, do not forget to open the opening (B in fig. 5.9) again by removing this cap! Otherwise, the evacuation of sample compartment via the small purge gas inlet in the QuickLock locking mechanism (A in fig. 5.9) will take too long causing a red VACUUM LED after a certain period of time.



Figure 5.9	Component
A	Purge gas inlet opening for purging an enclosed accessory with a QuickLock baseplate
В	Opening for purging, venting and evacuating the sample compartment
С	Cap for closing the opening (B in fig. 5.9)

5.8.2 Activating the purge mode in OPUS

The spectrometer can be operated either in the vacuum mode or in the purge mode. To activate the purge mode, select in the OPUS *Measure* menu the *Optic Setup and Service* function. Click on the *Devices/Options* tab and make sure that the *Purge Mode* check box is activated. See fig. 5.10.

Source	Setup	🔽 Use login operator name			
🗆 Beamsplitter	Setup	Automatic Accessory Recognition	nition		
Optical filter	Setup	🔲 Gain Switch Gain			
Aperture	Setup	Multiplexed data			
🕅 Iris aperture		Wait for devices ready	Setup		
F Polarizer	Setup	PLL Laser Multiply			
🔽 Channel	Setup	🔲 User signals			
🕅 Sample changer	Setup	AQP with Digital Filters			
Detector	Setup	🔽 Ext. synchronisation (Sonde)	Setup		
🔽 Preamplifier gain	Setup	Mapping device	Setup		
Velocity	Setup	Transient recorder	Setup		
🔽 High Pass Filter	Setup	Imaging device	Setup		
Low Pass Filter	Setup	Correlation mode	Setup	D	
		🔽 Purge Mode 🛛 🔫 💳		Purge mode is	
		Setup Result Spec	trum	activated	
Save Settings	1	Cancel	Help		
Save Settings		Cancel	Help		

5.8.3 Controlling the flaps

The purge mode allows you to control (i.e. open and close) the flaps in order to purge either the sample compartment or the optical bench or both. The flaps are controlled via the OPUS software. The corresponding buttons are at the *Basic* page of the *Measurement* dialog window. See fig. 5.11.

C B Basic Basic	heck Signal Ream Lapariment Diplic Lapariment Load Diplic Lapariment Load DEFAULT Operator name: Sample name: Sample name: Sample name: Sample name: Sample Som Park: D/D/US & 0.0MEAS File name: WORK kground Single Channel ample Single Channel	Path Special Acquisition FT De Close Riss Place Open	Range Selecton Jay Beckground	Command that is executed by clicking on this button. Note: After you have clicked on the button, the labeling of this button changes immediately show- ing the action that can be performed next (i.e. <i>Close Flaps</i> turns to <i>Oper Flaps</i> and versa vice).
	Exit	Cancel	Help	

□ The flaps can be opened or closed only if the pressure difference between the sample compartment and the optical bench falls below the threshold value of 5 hPa.

5.8.4 Special case

Besides the normal purge mode in which the optical bench and/or the sample compartment are only purged, the following special case is also possible: the vented sample compartment is purged while the optical bench is evacuated.

For the realization of this special case, the spectrometer needs to be equipped with windows mounted on either the sample compartment walls or the flaps which are closed in this case. To realize this special case, proceed as follows:

- 1. Make sure that the vacuum mode is activated in OPUS. (See section 5.6.1.)
- 2. Evacuate the optical bench and the sample compartment. (See section 5.6.3.)
- 3. Afterwards, vent the sample compartment again. (See section 5.6.4.)
- In this condition, the flaps are closed.
- 4. Connect the purge gas inlet for the sample compartment (B in fig 3.3) to the local purge gas supply line using a hose. (See section 3.9.)
- 5. Now start the purge gas supply.

5.9 Extending the spectral range

5.9.1 General information

The spectral range in which the spectrometer is capable of detecting a signal is determined by the following optical spectrometer components:

- source,
- beamsplitter,
- sample compartment windows (if installed) and
- detector.

Consequently, extending the spectral range means the exchange of these spectrometer components. For information about how to substitute these optical components refer to the section 5.10, section 5.11 and section 5.12.

After having replaced the one or more of the above listed optical components, it is highly recommended to validate the spectrometer performance by performing a PQ test using OVP. (See OPUS Reference Manual.)

5.9.2 Standard and optional spectral ranges

The standard spectrometer configuration is equipped for data acquisition in the mid IR region (8000 to 350 cm⁻¹). By exchanging the relevant optical components, the following optional spectral ranges are available:

- Far IR / THz: 680 to 5 cm⁻¹
- Near IR: 15,500 to 4,000 cm⁻¹
- Visible: 25,000 to 9,000 cm⁻¹
- Ultraviolet: 50,000 to 25,000 cm⁻¹

The spectral ranges of the available sources, beamsplitters, detectors and sample compartment windows are listed in section 4.2.2 (source), section 4.2.3 (detector), section 4.2.4 (beamsplitter) and section 4.2.7 (sample compartment window).

Make sure that the spectral ranges of the installed optical components correspond with each other!

5.9.3 Automatic component recognition (ACR)

The optical spectrometer components source, beamsplitter and detector are electronically coded enabling the spectrometer firmware to recognize automatically the type of source, beamsplitter and detector that is actually installed. The information about the installed optical components is passed on to the spectroscopy software OPUS. This feature is called ACR (Automatic Component Recognition). Its purpose is to prevent you from selecting a wrong component in OPUS when you set up a measurement experiment. (Note: A wrongly selected component is indicated in OPUS by a red colored entry field of the corresponding drop-down list. See also the OPUS Reference Manual.)

5.10 Exchanging the beamsplitter

5.10.1 General information

The standard spectrometer configuration is equipped with a KBr beamsplitter for measurements in the mid-infrared region. In case your sample requires a different spectral range, the beamsplitter needs to be exchanged among other components. (See also section 5.9.)

In section 4.2.4, all available beamsplitters are listed including the spectral range they cover.



5.10.2 Handling instructions

NOTE

Irreversibly damaged beamsplitter because of improper handling

The beamsplitter is a very delicate component. Observe the following handling instructions to ensure a long service life.

- ➤ Do not touch the optical material of the beamsplitter as this can damage it irreversibly. Take hold of the beamsplitter only by the handle. (See fig. 5.12).
- The optical material of some beamsplitters are hygroscopic. Do NOT expose them to humidity or water vapor. Store the beamsplitter in a sealed container or in a dry environment (e.g. in the storage position inside the spectrometer, see E in fig. 4.4).
- > Do not try to clean the optical material of the beamsplitter as this will definitively damage the beamsplitter irreversibly.
- > Do not expose the beamsplitter (especially KBr beamsplitters) to temperature changes.
- Handle the beamsplitter with care. Avoid any kind of mechanical impact like stroke or falling down.
- Do not try to loosen or fasten the screws as this will impair the optical quality of the beamsplitter.



Operation 5

5.10.3 Manual beamsplitter exchange procedure





Operation 5

Remove the cover of the automatic Cover lock closed Cover lock open beamsplitter changer. To do this, rotate the two locks at both sides of the cover half a turn. 1 Lift off the cover. Tilt the beamsplitter holder in the loading position using the knob (1). (1)Insert the beamsplitter into the holder. 2 Move the beamsplitter holder back to its normal position using the knob. ≻ The automatic beamsplitter changer can be loaded with up to four beamsplitters. The procedure is identical for all beamsplitters. Important: For inserting the fourth beamsplitter, the beamsplitter automatic changer needs to be rotated a quarter turn to move the fourth holder out of the operating position. (Note: With the holder being in the operating position, the beamsplitter cannot be inserted.) For information about how to operate the automatic beamsplitter changer, see section 5.10.5.

5.10.4 Loading the automatic beamsplitter changer



5.10.5 Software-controlled beamsplitter exchange procedure



5.11 Exchanging the detector

5.11.1 General information

The standard spectrometer configuration is equipped with a DLaTGS detector with KBr window for measurements in the mid-infrared region. In addition, the detector compartment allows for mounting a second detector.

In case your measurement requires a different spectral range or another detector sensitivity, you can install another detector into the second detector position, which is an optional spectrometer feature, or exchange the installed DigiTect DLaTGS detector for another DigiTect detector, such as a MCT detector with a higher sensitivity or a NIR detector. In section 4.2.3, all available detectors are listed including the spectral range they cover.

Make sure that the spectral range of the installed optical spectrometer components (source, beamsplitter, detector and sample compartment windows, if installed) correspond with each other! (See also section 5.9.)

5.11.2 Procedure

All available detectors are mounted on a dovetail slide which allows an easy exchange. A re-alignment is not necessary.



3	1 DLaTGS detector MCT detector (1)	Loosen the locking screw (allen screw) that secures the detector using a hex key (size 6mm). Depending on which detector you want to remove, the allen screw is either on the left side of the detector (1) or right side of the detector (2) .
4		Pull the detector straight upwards out of the dovetail guide. Caution: Remove the detector carefully in order not to damage the detector and/ or the mirrors.
5	1	 Insert the other detector into the dovetail guide ① and push the detector downwards until you feel a resistance. ➤ A beep indicates that the detector has been recognized by the electronics. The electrical connections are established automatically.
6	1 2	Fasten the corresponding allen screw (① or ②) using a hex key (size 6mm).

7		Place the cover on the detector compart- ment. Make sure that the four plastic pins in the corners at the bottom side of the detector compartment cover ① engage into the corresponding hole of the spec- trometer case. Note: If there is a MCT detector in the detector compartment do not forget to reinstall the vacuum-tight closure at the filling hole in the detector compartment cover. See section 5.14.3.
8	Check whether a signal is detected and whe section 5.13.)	ther the signal intensity is sufficient. (See

5.12 Replacing a sample compartment window

5.12.1 General information

The windows are either flanged directly to the sample compartment walls or they are mounted on the flaps¹. The precise replacement procedure depends on how the windows are mounted.

5.12.2 Handling instruction

NOTE

Irreversibly damaged sample compartment window because of improper handling

The sample compartment window is a delicate component. Observe the following handling instructions to ensure a long service life.

- > The window is very fragile. Handle it with care. Avoid any mechanical impact.
- Do not touch the window surface. This may lead to irreversible contamination. (Note: Contaminations on the window surface can decrease the IR-transparency significantly.)

5.12.3 Safety note

Some sample compartment windows are of a material which is harmful or (very) toxic. (See section 4.2.7.) During normal spectrometer operation, these materials do not pose any health hazard. However, if such a window should break because of mechanical impact, be extremely careful.

A WARNING



Health hazard because of improper handling of broken harmful or toxic window material

Non-observance of the following safety instructions could result in death or serious injury.

- Avoid generating dust of broken window material. This material is harmful or toxic if swallowed or inhaled.
- ➤ Also avoid skin and eye contact.
- Dispose the harmful or toxic material according to the laboratory regulations and the national regulations.
- > Observe also the safety instructions of the attached safety data sheets.

^{1.} The flaps are vacuum shutters. The purpose of the flaps is to provide an air-tight separation of the sample compartment from the optical bench in case you want to purge, evacuate or vent only either compartment. Note: Flaps are an optional spectrometer feature.

Operation 5

1		Open the sample compartment by taking off the cover (1) .
2		To gain access to the flaps, remove the cover ① by loosening the two hex socket screws ② using a hex key (size 2mm).
3		Remove the window retaining ring ① by loosening the three slotted screws ②.
4	Take out the window and install a new one.	
5		Attach the window retaining ring ① by fastening the three slotted screws ②.
6		Reinstall the cover ① using the two hex socket screws ②.

5.12.4 Replacement procedure for a window mounted on a flap



5.12.5 Replacement procedure for a window flanged to the sample compartment wall

5.13 Checking the signal

5.13.1 General information

Especially after you have replaced a spectrometer component (source, laser, beamsplitter, detector), it is advisable to check whether a signal is detected and to check whether the signal intensity (signal amplitude) is sufficient.

5.13.2 Procedure

- Make sure that there is not any accessory and/or sample in the spectrometer sample compartment.
- 2. Open the software program OPUS.
- 3. Select in the *Measure* menu the *Advance Measurement* function.
- 4. Click in the *Measurement* dialog window on the *Check Signal* tab.
- 5. Make sure that the *Interferogram* option button is activated. (See fig. 5.13.)



For verifying the currently detected signal intensity, compare the amplitude valve displayed in OPUS (fig. 5.13) with the amplitude value stated in the supplied OQ test protocol¹. (See fig. 5.14.)

^{1.} The supplied OQ test protocol documents the result of a factory-performed OQ test. The test has been performed with the spectrometer components being optimally adjusted. You will find the OQ test protocol in the folder supplied with the spectrometer.

Brul	(er OQ T	est Protocol]
-				
Company:	Default			
Operator:	Veraut Veraut	ale Commentation III DL aTCC		
Option Configuration:	Semele Comparts	pie compartment RT-DLaTGS		
Apport Configuration.	Sample Compartin	ent with: Mir, Kbr, RT-DLaTOS [Internal Pos. I]		
Instrument Serial Number:	2007891			
Instrument Firmware Version:	1.510 Mar 7 2008			
OPUS/DB Version:	20080204 / 6.5.6			
Overall Test Result	PASS			
Test expires:	2009/07/10 09:28	28		
Test Date/Time:	2008/07/10 09:28	3:28		
Test Spectra Path:	C:\Programme\OP	US_65\Validation\Data\20080710\092828		
Comment:				
	Resolu	tion Test	\sim	
Water Vapor Band:	1554.35 cm - 1			
Maximum Resolution:	0.40 cm-1	Measured Resolution:	0.37 cm -1	
	Sensitiv	rity Test	\checkmark	
Measurement Region, Start: Minimum S/N:	2200.00 cm - 1 7000	Measurement Region, End: Measured S/N:	2100.00 cm -1 9376.63	
	Energy Dist	ribution Test	\sim	
Minimum Energy Value:	0.10	Energy at 7500.00 cm-1	1.66	
Minimum Energy Value:	0.20	Energy at 370.00 cm-1	0.95	
	4.00			
Energy at 8000.00 cm -1	1.03	Energy at 350.00 cm-1	0.44	
	Wavenumb	er Accuracy lest	\checkmark	
Expected Band:	1554.353 cm-1	Measured Band:	1554.354 cm -1	
Maximum Deviation:	0.010 cm -1	Measured Deviation:	0.001 cm-1	
	Photometric	Accuracy Test	\checkmark	
Maximum Zero Crossing Value:	0.200%	Measured Value:	0.123%	
	Sean T	ime Test	\sim	
Maximum Scan Time:	5.00 Sec	Measured Scan Time:	2.62 Sec	
	Alignm	ent Test	\checkmark	
Interferogram Peak Range:	62000 - 58000	Measured Peak Position: Peak Amplitude:	-20732	_ Amplitude valu
gure 5.14: OQ- Test Pro	otocol			

If there is not any signal detected or if the amplitude value displayed in OPUS (fig. 5.13) deviates significantly from amplitude value of the supplied OQ test protocol (fig. 5.14) check the installation of the spectrometer component(s) you have replaced before. For troubleshooting, see also section 7.5.3.

5.13.3 Saving the interferogram peak position

General information

If the interferogram peak position has shifted in the course of time (i.e. it is no longer in the center of the display as shown in fig. 5.15), you have to save the new peak position.

	Addurrenent	_Shifted interferogram peak position
-	Save and Exit Cancel Heb	
F	Save and Eat Cancel Help Figure 5.15: OPUS Measurement dialog - Check Signal dialog	page

Note: A shifted interferogram peak position is also indicated by the message Peak Position out of range in OPUS. This information message appears when you start a measurement with the interferogram peak position being shifted.

Procedure

- 1. Open the software program OPUS.
- 2. Select in the *Measure* menu the *Advance Measurement* function.
- 3. Click in the Measurement dialog window on the Check Signal tab.
- 4. Activate the Interferogram option button if it is not already activated.
- 5. Press the Save Peak Position button.
- 6. Exit the dialog.
- Note: When you reopen the Check Signal dialog page, the interferometer peak position is now in the center of the display.

5.14 Cooling the MCT detector

5.14.1 General information

For the spectrometer, several MCT detectors are available. See section 4.2.3.

The operating temperature of the MCT detectors is significantly below room temperature. To achieve the required operating temperature, the MCT detector needs to be cooled with liquid nitrogen, i.e. liquid nitrogen is filled in the MCT detector.

The hold time indicates how long the cooling effect of the liquid nitrogen lasts. To ensure an optimum signal detection, the MCT detector needs to be filled with liquid nitrogen in regular intervals. The available MCT detectors have different nominal hold times: 8, 12, or 24 hours.

Indications of a weakened or disappeared cooling effect are a low signal intensity or no signal detection. (See section 5.13.) In case no signal is detected, the OPUS status lamp turns to red. This problem is also indicated by the following instrument status message in OPUS: *Detector not ready.* See also section 7.2.3.

If the actual hold time of the MCT detector is considerably shorter than the nominal hold time, the MCT detector dewar needs to be evacuated. See section 6.3.

5.14.2 Safety notes

The temperature of liquid nitrogen is minus 196°C (minus 320.8°F).

Injury due to improper handling of liquid nitrogen

Non-observance of the following safety instructions may result in an injury.

➤ Risk of frostbites. Avoid skin contact. Handle liquid nitrogen always with care.



- Also the gases escaping from the liquid nitrogen are extremely cold and can cause frostbite. The delicate eye tissue can be damaged if exposed to this cold gas even for a short time. Protect your eyes by wearing a face shield or safety goggles! Note that goggles without side shields do not provide adequate protection!
- High nitrogen gas concentrations in an enclosed area can cause asphyxiation! Use liquid nitrogen only in well-ventilated areas. Nitrogen gas is colorless, odorless and tasteless. Therefore, it can not be detected by human senses and will be inhaled as if it were normal air.

5.14.3 Preparing the detector compartment cover

General information

To fill the detector with liquid nitrogen you need neither to take the detector out of the spectrometer nor even open the detector compartment. A supplied funnel facilitates the filling in of liquid nitrogen in the MCT detector.

In case the MCT detector has been delivered together with the spectrometer, the detector compartment cover is already prepared for the funnel insertion. If the MCT detector has been ordered at a later date you need to prepare the cover as described below.

In accordance with the number of detectors that can be installed in the detector compartment of the spectrometer, there are two filling holes in the cover. These holes are intended to accommodate the funnel. (Note: The funnel is included in the delivery scope of the MCT detector.) Upon delivery, these holes are closed vacuum-tightly by a cap plus O-ring.

Procedure

1		Take off the detector compartment cover. ①.
2	Open filling hole	Turn the detector compartment cover upside down and remove the cap from the filling hole that corresponds with the position of the MCT detector in the detec- tor compartment. To do this, loosen the nut using a wrench (size 24mm). Remove the O-ring and the cap.



Operation 5

·		1
1		Open the filling hole by removing the plug ①.
		 Insert the funnel (2) instead. The funnel is included in the delivery scope of the MCT detector.
2		Pour slowly liquid nitrogen in the funnel. Avoid spilling the liquid on the spectrome- ter housing. At first the liquid nitrogen evaporates and streams out again.
		Liquid nitrogen boils and splashes when it is filled a warm container. Especially at the beginning, when the temperature dif- ference between the detector dewar and the liquid nitrogen is still very large, the liquid nitrogen may squirt out forcefully due to the boiling delay. Therefore, fill in the liquid nitrogen slowly to minimize boil- ing and splashing. Stand clear of boiling and splashing liquid nitrogen and its issuing gas! Be aware that during the entire filling process, liquid nitrogen can squirt out of the detector dewar from time to time.
		Wait until the funnel is empty before refill- ing. When the liquid nitrogen stops streaming out the detector dewar has reached liquid nitrogen temperature. Then, pour again liquid nitrogen in the funnel.
		Repeat this procedure until the detector has been filled to maximum. (As a rough rule of thumb for the standard MCT detector: the maximum capacity is about the quantity of two to three funnel fillings. Note that the first two funnel filling will evaporate almost completely.) Avoid overfilling! In this case the liquid flows out of the filling port.

5.14.4 Filling the MCT detector with liquid nitrogen



6 Repair and Maintenance

6.1 General information

The spectrometer is a low-maintenance instrument. For detailed information about how to maintain the vacuum pump, refer to the user manual provided by the vacuum pump manufacturer.

Only a few spectrometer components have a limited service life (e.g. laser, IR source). These components are easy to replace.

The following maintenance and repair works can be performed by the user:

- Restoring the MCT detector dewar vacuum
- Replacing the IR source
- Replacing the sample compartment windows
- Cleaning the spectrometer

Perform only those maintenance and repair works which are described in this manual. Adhere strictly to the described procedures and observe all relevant safety precautions. Otherwise, personal injury and/or spectrometer damage can be the result. In this case, Bruker does not assume any liability. Maintenance and repair works which are not described in this manual have to be performed by Bruker service personnel only. For the Bruker service contact data, see section 1.6.

NOTE

Damage to ESD-sensitive electronic spectrometer components because of accidental electrostatic discharges (ESD)



Make sure that you are electrostatically discharged before you touch any electronic spectrometer component. Either use a grounded wrist strap or touch a grounded object (e.g. radiator). Note: The grounded wrist strap is the most effective (and the preferred) grounding method.

6.2 Performing an OQ test¹ using OVP²

After the replacement of a defective optical component³ (source, beamsplitter or detector), it is highly recommended to perform an OQ test to ensure that the spectrometer achieves the specified parameter values⁴. (For detailed information about how to perform an OQ test refer to the OPUS Reference Manual.)

- The resolution test, which is part of the OQ test protocol, requires a gas cell filled with CO at low pressure. If you do not have such a gas cell at your disposal, contact the Bruker service. (See section 1.6.)
- 1. OQ test Operational Qualification Test
- 2. OVP <u>O</u>PUS <u>V</u>alidation <u>Program</u> (It is intended for performing spectrometer validation tests like OQ and PQ.)
- 3. Perform the OQ test only after the replacement of a defective component, but NOT after exchanging an optical component for the purpose of extending the spectral range, for example.
- 4. In the course of the OQ test, the following parameters are tested: resolution, sensitivity, energy distribution, wavenumber accuracy, photometric accuracy, scan time, peak position and peak amplitude.

6.3 Restoring the detector dewar vacuum

6.3.1 General information

The operating temperature of the MCT detectors is significantly below room temperature. To achieve the required operating temperature, the MCT detectors are cooled down with liquid nitrogen. The available MCT detectors have different nominal hold times¹: 8, 12 or 24 hours. To provide for the longest possible hold time, the MCT detector is integrated in a dewar. So, the actual hold time strongly depends on the quality of the vacuum in the detector dewar.

If the actual hold time decreases considerably with regard to the nominal hold time, the detector dewar vacuum needs to be restored. The existence of condensation water on the detector outside indicates that the vacuum must be stored soon. Another indication that a vacuum restoration is required is a failed *Ice Band Test*². If the MCT detector outside is iced the detector dewar vacuum must be restored immediately.

Regarding the liquid-nitrogen-cooled detectors MCT with dewar, there are the following technical designs:

- The detector element is mounted in an evacuable dewar. In this case, the dewar vacuum is restored by evacuating the detector dewar with a vacuum pump. (See section 6.3.2.)
- In case of the PERMAVAC-type MCT detector, the dewar vacuum is regenerated. (See section 6.3.3.)

6.3.2 Evacuating the MCT detector dewar

Required evacuating equipment

- Vacuum pump (turbo molecular pump or oil-free high-vacuum pump that is capable of generating a vacuum of at least < 10⁻⁵mbar)
- Adapter for connecting the vacuum pump to the MCT detector dewar
- Shut-off valve
- 2x flexible metal hoses
- **1** The above listed evacuating equipment is NOT included in the standard delivery scope of the MCT detector. If desired, Bruker offers suitable evacuating equipment (part number S105-V2, D126 and I10290). Alternatively, Bruker also offers the service of evacuating the MCT detector dewar (part number SD128). This option requires the removal of the MCT detector from the spectrometer and the sending of the complete MCT detector to Bruker for evacuation.

^{1.} The hold time indicates how long the cooling effect of the liquid nitrogen lasts.

^{2.} The *Ice Band Test* checks whether there is a thin ice layer on the detector element. This in turn is an indication of the vacuum quality in the MCT detector dewar. The *Ice Band Test* is part of the PQ test protocol. For detailed information, refer to the OPUS Reference Manual.



Fig. 6.1	Component
А	Connecting adapter (for connecting the vacuum pump to the detector dewar)
В	Flange
С	Flexible metal hose
D	NW 25 flange (for connecting to the vacuum pump)

Procedure

- Before starting to evacuate the MCT detector dewar, make sure that the dewar does not contain any more liquid nitrogen and that the detector has warmed up to room temperature. Take into consideration that the detector warming-up from operating temperature to room temperature takes at least 3 hours after the residual liquid nitrogen has been emptied.
- 1. Remove the MCT detector from the spectrometer. See section 5.11.2.
- 2. Connect the adapter to the vacuum pump by flanging a flexible metal hose to the connecting piece of the adapter (E in fig. 6.3) and to the vacuum pump. See fig. 6.1b. (Note: The connecting piece of the adapter has an OD of 9.7mm.) In addition, install a shut-off valve between adapter and vacuum pump.
- 3. Make sure whether the shut-off valve is closed. Switch on the vacuum pump. Leave the pump running until it has reached its operating temperature.
- 4. Inspect the O-ring inside the adapter (C in fig. 6.3) for signs of wear.
- The O-ring inside the adapter is a wearing part that needs to be replaced after 4 or 5 evacuations at maximum.

- 5. Remove the cap from the connection nozzle of the detector. (See fig. 6.2a.)
- 6. Pull the adapter knob (G in fig. 6.3) to the open position and loosen the coupling nut (A in fig. 6.3).
- 7. Push the adapter carefully over the connection nozzle of detector dewar and fasten the coupling nut (A in fig. 6.3 hand-tight while holding the adapter and the detector as shown in fig. 6.2b. (A hand-tight tightening of the coupling nut is sufficient.)
- Hold the adapter and the detector always as shown in fig. 6.2b when you have to carry out the following tasks: opening and closing the evacuation valve by pushing or pulling the adapter knob (step 8, 12, 14 and 17), screwing the threaded adapter rod in or out of the connection thread of the dewar evacuation valve (step 11 and 15) and loosening the coupling nut (step 18).



- 8. Push the adapter knob (G in fig. 6.3) in the closed position until the threaded rod (D in fig. 6.3) of the adapter is in contact with the sealing plug of the dewar evacuation valve.
- 9. Before you begin to evacuate the detector dewar, check the connections for leak tightness by evacuating the section between vacuum pump and detector at first. To do this, open the shut-off valve. If a vacuum of 10⁻⁴mbar is generated within a few minutes it is an indication of the leak tightness of this section.
- 10. Close the shut-off valve again.
- 11. Screw the threaded rod of the adapter (D in fig. 6.3) in the connection thread of dewar evacuation valve by turning the adapter knob (G in fig. 6.3) clockwise; 2 to 3 rotations are sufficient. Attention: In case of more than 2 or 3 knob rotations there is a risk that the threaded connection becomes inseparable! That means the threaded rod of the adapter cannot be screwed out of the connection thread of the dewar evacuation valve again.
- 12. Pull the knob (G in fig. 6.3) to the open position in order to open the dewar evacuation valve.
- 13. Begin to evacuate the detector dewar by opening the shut-off valve.

- We recommend an evacuation time of at least 3 days to allow for generating an optimal vacuum inside the dewar. The final pressure in the detector dewar should be less than 10⁻⁵ mbar.
- 14. When the optimal vacuum is achieved, close the dewar evacuation valve by pushing the adapter knob (G in fig. 6.3) to the closed position. Press the adapter knob firmly to the stop position to ensure that the dewar evacuation valve is sealed airtightly.
- 15. Screw the threaded rod of the adapter (D in fig. 6.3) out of the connection thread of the dewar evacuation valve by rotating the adapter knob (G in fig. 6.3) several turns counterclockwise until you sense that the threaded adapter rod and the connection thread of the dewar evacuation valve are not joint any more. Be careful in order to prevent an unintentional opening of the evacuation valve and consequently to prevent the detector dewar from being vented again.
- 16. Vent the section between vacuum pump and adapter.
- 17. Pull the knob (G in fig. 6.3) to the open position. Attention: Make sure that the sealing plug of the evacuation valve is NOT pulled out! This may occur when you have screwed the threaded adapter rod too far in the connection thread of the dewar evacuation valve. (See step 10.) In this case repeat the dewar evacuation. If you do not succeed in closing the evacuation valve at all you have to send the detector in to Bruker.
- 18. Loosen the coupling nut (A in fig. 6.3) and remove the adapter from the connection nozzle of the detector dewar.
- 19. Reinstall the MCT detector in the spectrometer. See section 5.11.2.
- If a tiny amount of air should unawares get into the detector dewar during the evacuation procedure (e.g. when you close the evacuation valve) you can perform measurements with this MCT detector for the moment but after a relatively short period of time you have to repeat the detector evacuation.



Figure 6.3: Connecting adapter - Cross section

Fig. 6.3	Components of the connecting adapter
А	Coupling nut
В	O-ring retainer
С	O-ring
D	Threaded rod (to remove the valve closure of the detector dewar)
E	Connecting piece for vacuum pump (OD = 9,7mm)
F	Washer and O-ring packing
G	Knob
6.3.3 Regenerating the vacuum of a PERMAVAC-type MCT detector

General information

In case of the PERMAVAC-type MCT detector, the dewar vacuum is regenerated. For the vacuum regeneration, the PERMAVAC-type MCT detector does not need to be removed from the spectrometer.

The vacuum regeneration is initiated by the user on the detector diagnostics page of the spectrometer firmware¹. Once the user has initiated the vacuum regeneration process, it cannot be interrupted or stopped. The vacuum regeneration takes about 10 minutes.

Regenerating the dewar vacuum becomes necessary if the hold time² decreases significantly (i.e. a hold time of less than four hours). Another indication of a required vacuum restoration is a failed *Ice Band Test*³.

NOTE

- ➤ The dewar vacuum can be regenerated only 5 to 6 times. For this reason, regenerate the detector dewar vacuum only if it is really necessary!
- If you are not absolutely sure whether the dewar vacuum needs to be regenerated contact the Bruker service. (See section 1.6.)

The anticipated vacuum regeneration interval is between 1.5 to 2 years. In case you intend to regenerate the dewar vacuum before the factory-defined minimum time period is elapsed, the following message is displayed on the Detector Diagnostics Page.

		Me	ssage			
Minimum	n time inter	val has not y	et elapsed s	ince the	last regene	ration
VERTEX 80V Back Ratash Messages Tamestamp Code L 2000/12 21011 W	SN_679 DTC Dia	agnostics Command	door are Visions for several	Message an not yet elapsed si	ur fir lat represention	
LN-MCT Mid VP (I	Internal Pos.1]					
Detector selected	YES	DTC=0s4020	PIC Ven 4.5	SNo. MCM1275	ECL00	BoardType 017
Analog board sottings	MUX-IR Enter Level Error Insuediately	TRW=OFF Channel right = Pressay A	HPF=OFF Max Data Rate=160000 Hz	GNS=1	SG2=1	
Preamp board status	NOT READY Digits Blass Correst 141	PerampPower=ON Digits Bias Voltage: 103	PGN=3 (0.3)			
Detector properties	Range 800 12000 Gaine 1.0.3.2.10.0.31.9	Vels 0.20000.160000 Delays 1000/1100/1200/1300as	NL coef 500wa, 0.900	Recov time 1s		
PermaVac status	Ok	Date of last regramation= 08 Feb 2008	Mainum regenerations interval= 0 days	No. of regeneration= 1	Start Regularation	1

Note: Despite this message, you can initiate the vacuum regeneration as described in the following section.

- 1. Diagnostics pages for relevant spectrometer components are provided by the spectrometer firmware. These pages contain all relevant information about the current operating state of the respective spectrometer component. For information about the diagnostics pages, see section 7.2.4.
- 2. The hold time indicates how long the cooling effect of the liquid nitrogen lasts. Note: The PERMAVAC-type MCT detector has a nominal hold time of ca. 8 hours.
- 3. The *Ice Band Test* checks whether there is a thin ice layer on the detector element. This in turn is an indication of the vacuum quality in the MCT detector dewar. The *Ice Band Test* is part of the PQ test protocol. For detailed information, refer to the OPUS Reference Manual.

Procedure



5	VERTEX 80V SN_679 DIC Diagnostics Image Analysis Testing Cols Line1 Refer Lawrer Cananal Manage Distingt Cols Line1 Refer Lawrer Cananal Manage Distingt Cols TOX-000 PIC-Ves (J. No. MCM2121 BCL00 Bord Cols Analy Lawr Mix.Coll TOX-001 PIC-Ves (J. No. MCM2121 BCL00 Bord Coll Analy Lawr Mix.Coll TOX-001 PIC-Ves (J. No. MCM2121 BCL00 Bord Coll Promp land toxing Mix.Coll TOX-001 Bord Coll (D. 1) Bord Coll (D. 2) Bord	Click on the Start regeneration button.
	Start Regeneration	
	Meldung von Webseite	The following message appears.
	Do you want to perform regeneration? Attention! The number of	Click on <i>OK</i> .
6	OK	Thereupon, the vacuum regenera- tion starts. Once the regeneration has been started, it cannot be stopped.
	VERTEX 80V SN_679 DTC Diagnostics	The vacuum regeneration process takes
7	Message Message Standardig Extender Natures Message Distance reduced TE DTO-fox100 PIC Vent 4.5 Nine MCM275 ECL00 Bit-off (pre- sign 2) Anding Saved TEW-OFF PIC Vent 4.5 Nine MCM275 ECL00 Bit-off (pre- sign 2) Notice and table TEW-OFF PIC Vent 4.5 Nine MCM275 ECL00 Bit-off (pre- sign 2) Notice and table TEW-OFF PIC Vent 4.5 Nine MCM275 ECL00 Bit-off (pre- sign 2) Preserve based status TEM-OFF Pice Vent 10 Pice Vent 10 ECl00 Preserve based status Tem Into Concerve Pice Vent 10 Pice Vent 10 Pice Vent 10 Parametric Tem Into Concerve Pice Vent 10 Pice Vent 10 Pice Vent 10 Parametric Tem Into Pice Vent 101 Pice Vent 101 Pice Vent 101 Pice Vent 101 Parametric Tem Into Pice Vent 101 Pice Vent 101 Pice Vent 101 Pice Vent 101	The progress of the vacuum regeneration process is displayed at the Detector Diagnostics Page.
	Duration [minutes]: 10.0 Done [%]: 18.5	
	VERTEX 80V SN_679 DTC Diagnostics	The counter shows how often the dewar vacuum has already been regenerated.
8	Destingent of Lord Instant Cold Manage LNANT MM VF [Incread Null] DTC-0x8120 PIC Ven 6.5 Non-MCR127 SCL00 Bary of Type Andrig Name Max Ord TDTC-0x8120 PIC Ven 6.5 Non-MCR127 SCL00 Bary of Type Andrig Name Max Ord TDTC-0x8120 PIC Ven 6.5 Non-MCR127 SCL00 Bary of Type Andrig Name Max Ord TDTC-0x8120 PIC Ven 6.5 Non-MCR127 SCL00 Bary of Type Pressign hand Max Ord TDTC-0x8120 PIC Ven 6.5 Non-MCR127 SCL00 Bary of Type Pressign hand Max Ord TDTC-0x8120 Max Non Type Non-Non-Non-Non-Non-Non-Non-Non-Non-Non-	Note: The number of vacuum regenera- tion processes is limited!
	Counter: 3	

6.4 Replacing a defective IR source

6.4.1 General information

The standard MIR source and the optional NIR source have a limited service life. When the end of the specified service life is nearly reached, the following message is displayed in OPUS: *End of average lifetime is nearly reached, spare part will be required*. When a source is defective, the following message is displayed in OPUS: *Source is broken or not connected*. (See also section 7.2.3.) In these cases, order a replacement source. For the order number, refer to appendix B.

6.4.2 Safety notes



Risk of skin burn

Non-observance of the following safety instructions may result in minor injury.

- Take into consideration that the IR source becomes very hot during operation. Do not touch a hot IR source.
- > Wait until the IR source has cooled down sufficiently before you remove it.

6.4.3 Procedure

The replacement procedure, as described in the following, is identical for both sources - the standard MIR source and the optional NIR source. Both sources are installed inside the spectrometer. See fig. 6.5



1	Name Name <th< th=""><th>Switch off the source using the OPUS software program. To do this, select in the OPUS <i>Measure</i> menu the <i>Advanced Measurement</i> function. Open the <i>Optic</i> page of the <i>Measurement</i> dialog. Select in the <i>Source setting</i> drop-down list the option <i>Off</i> (1).</th></th<>	Switch off the source using the OPUS software program. To do this, select in the OPUS <i>Measure</i> menu the <i>Advanced Measurement</i> function. Open the <i>Optic</i> page of the <i>Measurement</i> dialog. Select in the <i>Source setting</i> drop-down list the option <i>Off</i> (1).
2	Balancest Same Pail Same Pail Balancest <td>Vent the spectrometer, if not already done. To do this, click on the <i>Vent Optics</i> button ①. See also section 5.6.4.</td>	Vent the spectrometer, if not already done. To do this, click on the <i>Vent Optics</i> button ①. See also section 5.6.4.
3		Take off the interferometer compartment cover ①. Caution: When the interferometer compartment is uncovered, laser class 2 radiation is accessible. Do not stare into the beam! Risk of eye injury! An exposure time > 0.25 sec. will cause eye injury. Caution: Before you proceed with the next step, wait until the MIR source has cooled down sufficiently. Do not touch a hot IR source! Risk of skin burn!
4	2 1	Loosen the knurled thumb screw ① of the release lever ② (approx. one turn).

5		Press the source slightly downwards while swiveling the release lever aside.
6	MIR	Take out the source.
7		Insert the replacement MIR source into the seating hole. Note that the pins snap into the corre- sponding holes at the MIR source bottom side to ensure an exact source position.
8		 Press the source downwards and swivel the release lever over the source to secure it. ➤ A beep indicates that the source has been recognized by the spectrometer electronics.

9	1	Tighten the knurled thumb screw ① of the release lever.
10		Close the interferometer compartment by placing the cover (1) on it.
11	Name Note Note Image: State of the state o	Switch on the source using the OPUS software program. To do this, select in the OPUS <i>Measure</i> menu the <i>Advanced Measurement</i> function. Open the <i>Optic</i> page of the <i>Measurement</i> dialog. Select in the <i>Source setting</i> drop-down list the option <i>MIR</i> (1) or <i>NIR</i> .
12	Reset the source operating hours counter. (Se	e section 6.4.4.)
13	Check whether a signal is detected and whe section 5.13.)	ther the signal intensity is sufficient. (See
14	Perform an OQ test. (See also section 6.2. For an OQ test refer to the OPUS Reference Manu If the OQ test fails, see section 7.5.4 for the	detailed information about how to perform al.)

6.4.4 Resetting the source operating hours counter

After having replaced the source, do not forget to reset the source operating hours counter. To do this, proceed as follows:

1	The second secon	 Open the OPUS software program, if not already done. Either select in the OPUS <i>Measure</i> menu the <i>Optics Diagnostics</i> function ① or click on the OPUS status light ②. ➤ Thereupon, the <i>Instrument Status</i> dialog opens.
2	Image: second	 Click on the source icon ①. ➤ Thereupon, the <i>Instrument Status Message</i> dialog opens.
3	Image: Section of the first sectio	 Click on the Service Info button ①. ➤ The source diagnostics page of the spectrometer firmware opens.
4	VERTEX 80V SN_V80v.0010 SRC Diagnostics Basic Message Source Decide and set: MR (SBC-101) READY Betable of Source(2) Betable of Source(2) MR (SBC-101) OFF MR (SBC-101) OFF MR (SBC-101) OFF MR (SBC-102) OFF MR (SBC-103) OFF	Click on the RESET button ① of the source in question.

6.5 Replacing a broken or opaque sample compartment window

In case a sample compartment window has got broken or its opaqueness has reached such a degree that the transparency (infrared transmittance) is seriously reduced, it needs to be replaced. For detailed information about how to replace a sample compartment window, see section 5.12.

When installing a new sample compartment window, make sure that its transmission range corresponds with the spectral range of the other installed spectrometer components: source, beamsplitter and detector. (See also section 5.9.)

6.6 Cleaning the spectrometer

If required, you can clean the outer spectrometer housing with a dry or damp cloth.



7 Troubleshooting

7.1 General information

This chapter deals mainly with the most common spectrometer problems that may occur as experience has shown. It provides information about possible causes of the problem and presents solutions for troubleshooting. If the solutions listed in this chapter do not eliminate your spectrometer fault contact the Bruker service. For the Bruker service contact data refer to section 1.6.

Depending on how a spectrometer problem becomes apparent, they are divided in the following categories:

- Spectrometer problem indicated by a red LED of the status indicator board
- Spectrometer problem indicated by an instrument status message in OPUS
- Spectrometer problem indicated by one of the various diagnostic LEDs at the spectrometer rear side (e.g. ERR LED, voltage status LEDs)
- No communication between spectrometer and computer
- A signal check in OPUS reveals that no signal is detected or that the signal intensity is too low.
- A failed validation test (e.g. PQ test)

The available diagnostic means (e.g. spectrometer status indicator board, instrument status messages in OPUS, diagnostics pages of the spectrometer firmware) enable the operator to identify many spectrometer problems, or at least to narrow down a problem. (The available diagnostic means are described in detail in section 7.2.) In addition, there is the possibility of a remote fault diagnosis by the Bruker service. See section 7.4.

Due to easy-to-replace spectrometer components, the operator can solve many problems himself. The holders and/or locking mechanisms for the spectrometer components source, beamsplitter and detector ensure a correct installation position of these components, i.e. after the replacement of these components, a realignment is not required.

7.2 Diagnostic means

For a spectrometer fault diagnosis, the following diagnostic means are at your disposal:

VACUUM C LASER STATUS	Status indicator board on the spectrom- eter top side (See section 7.2.1.)
	OPUS dialog window <i>Instrument Status</i> (See section 7.2.2.)
Denverd Max	Instrument status messages in OPUS (See section 7.2.3.)
VERTEX 80V SN_V80v.0010 SRC Diagnostics Back Rebash Message No error Searce Divide of the Searce(s) Divide of the Searce(s) Total run time IR Searce (spc Carrent state NR (SRC-100) ON Age of the Searce(s) Fit 20 Oct 2010 122601 NR (SRC-100) ON Page generated on Tue, 30 Age 2013 151802	Diagnostics pages of the spectrometer firmware (See section 7.2.4.)
	Several diagnostic LEDs at the spec- trometer rear side (See section 7.2.5.)

7.2.1 Status indicator board

The color in which the six status indicator board LEDs light up gives a general indication of the operating status of the corresponding spectrometer component. For detailed information about the status indicator board, see section 4.1.2.

Basically, a red status indicator board LED indicates a spectrometer problem.

VACUUM

A red VACUUM LED indicates the following problem: When the spectrometer is being evacuated, but a certain threshold pressure value is not reached within a certain period of time (i.e. the ultimate vacuum is not achieved). See section 7.5.1.1 for troubleshooting.

LASER

Normally, a red LASER LED indicates a laser problem, for example:

- Laser power is too weak or
- Laser beam is blocked or
- · Laser module is defective or
- Laser module is out of alignment.

See section 7.5.1.2 for troubleshooting.

Important note: This LED also lights up red during the spectrometer initialization phase. In this case, there is not any laser problem. After the spectrometer initialization is completed successfully, this LED turns automatically to green.

STATUS

Normally, a red STATUS LED indicates a spectrometer problem. See section 7.5.1.3 for troubleshooting.

Important note: This LED also lights up red during the spectrometer initialization phase. In this case, there is not any laser problem. After the spectrometer initialization is completed successfully, this LED turns automatically to green.

PRESSURE

A red PRESSURE LED indicates that there is not sufficient air pressure for the air bearing of the linear scanner. In this case, measuring is not possible. See section 7.5.1.4 for troubleshooting.

FLAPS

A red FLAPS LED indicates a flap malfunction or an error regarding the flaps. See section 7.5.1.5 for troubleshooting.

Note: The flaps are vacuum shutters. They are an optional spectrometer feature.

BMS

A red BMS LED indicates a beamsplitter problem, for example:

- There is not any beamsplitter installed in the operating position.
- The beamsplitter is not installed properly (i.e. it is not locked).
- See section 7.5.1.6 for troubleshooting.

7.2.2 OPUS dialog Instrument Status

The OPUS dialog window *Instrument Status* allows you to diagnose which spectrometer component has caused the failure or to find out whether an OVP test has expired or failed. To perform a fault diagnosis, proceed as follows:

1. Either click on the OPUS status light or select in the OPUS *Measure* menu the *Optics Diagnostics* function. The following dialog window opens:

	Instrument Status
Α =	
B =	
	Send Report Daily Quit Add Last Data
	Figure 7.1: Optics Diagnostics - Instrument Status dialog

A) The status of the hardware components, e.g. source, laser, interferometer etc. is displayed in the upper icon line. The status can be as follows:

	OK Component is okay.
	WARNING The exact meaning of a warning depends on the compo-
SOURCE WARNING	nent in question. For example, in case of the source, a warning means:End of the specified lifetime of the component is nearly reached. In this case, measuring is still possible.
SOURCE ERROR	ERROR Component is defective. In this case, measuring is no lon- ger possible.

B) The second row of icons refer to the possible active test channel and indicates the result of the last OVP¹ test performed. The results can be as follows:

MIR	INACTIVE (yellow): The single tests of the particular test category are disabled.
MIR PASSED	PASSED (green): OVP test passed. Test is still valid.
	EXPIRED (light blue):
MIR EXPIRED	The validity period of an OVP test has expired. What to do in this case? Perform the OVP test in question. (See OPUS Reference Manual.)

2. To perform a fault diagnosis of a particular spectrometer component click on the respective icon in the first row of the *Instrument Status* dialog. The *Instrument Status Message* dialog opens. (See fig. 7.2.)

 [&]quot;Validation test" is a collective term for all tests (e.g. OQ - <u>Operational Qualification</u>, PQ - <u>Performance Qualification</u>) that can be performed with OVP in order to validate the spectrometer. OVP (<u>OPUS Validation Program</u>) is part of OPUS. The general purpose of these validation tests is to check whether the spectrometer system achieves the specified performance or not. For information about OVP refer to the OPUS Reference Manual.

7.2.3 Instrument status messages in OPUS

Some spectrometer problems are indicated additionally by a corresponding instrument status message displayed in OPUS. ((See fig. 7.2.) These messages appear when you click on the icon of the optical component in question in the *Instrument Status* dialog.



7.2.4 Diagnostic pages of the spectrometer firmware

When you click on the *Service Info* button (see fig. 7.2), the diagnostics page for the component in question opens. The diagnostics pages of the spectrometer firmware contain all relevant information about the current operating state of the respective spectrometer component. In the following figures, the information relevant to fault diagnostics are highlighted by a rectangle.

The following figures (fig.7.3 to fig. 7.8) show the diagnostics pages of the following spectrometer components:

- Laser (HeNe-Laser Diagnostics Page)
- Source (SCR Diagnostics)
- Interferometer (Scanner Diagnostics)
- Detector (DTC Diagnostics)
- Electronic (Instrument Ready Diagnostics)
- Automation (Automation units Diagnostics)
- The explanation of the diagnostic pages is restricted to the most important pieces of information which are relevant to the user for troubleshooting.



Fig. 7.3	Explanation
A	Possible error message Note: They are identical to the instrument status message in OPUS.
В	Current state: Current switch state of the laser Desired state: State selected by user
С	Total run time: Current reading of the laser operating hours counter
D	Date of putting the laser into operation for the first time



Fig. 7.4	Explanation
A	Possible error message Note: They are identical to the instrument status message in OPUS.
В	Desired state: State selected by user
С	IR source type: Currently installed source(s) are listed
D	Current state: Current switch state of the source(s)
E	Total run time: Current reading of the source operating hours counter(s)
F	In use since: Date of putting the source in question into operation for the first time



Fig. 7.5	Explanation
А	Possible error message Note: They are identical to the instrument status message in OPUS.

VERTEX 80	V SN_V80v.001	0 DTC Diagnostics							
Back Refresh	A c-Reload								
Messages	.								
Change State (31)	The second se								
Detector selected	NO	T/TC=0+4060	PIC Vers 2.7	SNo CLE0227	ECL01				
Ana15 board setting	MUX-IR	TRW=OFF	HPF=OFF	GNS#2	532=1				
Preamp board status	READY	PreampPowerwOFF	PGN=3 (0, 3)	1	STREET.				
Detector properties	Range 0 15800wn	Velr 0. 10000. 320000	Hr NL coef 600wn, 0.900	Recov. time: 1s					
	Gaint 1 0/10 0/100 0/1	1000.0 Delays: 0/0/0/0m	Error Level Error mmediateh						
Classic Style Ch2	Classic Style Ch2 [External]								
Detector selected	NO	DTC=0x4061	PIC Vers 2.7	SNo. CLE0227	1 ECL01				
Ana15 board setting	MUX-IR.	TRW=OFF	HPF=OFF	GNS=2	\$G2=1				
Preamp board status	READY	PreampPower=OFF	PGN=3 (0.3)						
Detector properties	Range: 0.15800wn	Vels: 0. 10000. 320000 1	Hz NL coef Own, 1 000	Recov. time: 1s					
	Gam: 1.0/10.0/100.0/1	1000.0 Delays: 0/0/0/0ea	Error Level Error mmediately	y					
RT-DLaTGS [Inte	rnal Pos 1]								
Detector selected	NO	DTC=0±4020	PIC Vers 2.7	SNo. DTR0539 1	SCL03				
Ana15 board setting	MUX=IR	TRW=OFF	HPF=OFF .	GNS=4 d	932#1				
Preamp board status	READY	PreampPower=OFF	PGN=0 (0.0)	0)					
Detector properties	Range: 180. 10000wm	Vels: 400, 10000, 20000 Hz	NL coef 0wn, 1.000	Recov. time: 3s					
1	Gam: 1.0/1.0/1.0/1.0	Delays: 7500/7500/7500/7500m	Error Level Error mmediately						
RT-Si Diode [Inter	mal Pos 2]	wanter water							
Detector selected	YES	DTC=0::4040	PIC Vers 2.7	SNo SI	:0036 ECL02				
Ana15 board setting	MUX=IR	TRW=OFF	HPF=OFF	GNS=16	S02=1				
Preamp board status	READY	PreampPower=ON	PGN=0 (0.3)						
Detector properties	Range: 9500 .25000ws	Vels 400. 20000. 40000 Hz	NL coef 0wn, 1.000	Recov. te	ne: 1s				
	Gaint 1.0/10.0/100.0/0	4 Delays: 5000/36000/40000/2	2250ns Error Level No Error Mo	estages					

Fig. 7.6	Explanation
A	Possible error message Note: They are identical to the instrument status message in OPUS.
В	Channels for possible externally connected detectors
С	Internally installed detectors
D	Detector selected: (YES or NO): status of the current selection Note: The detector is selected in OPUS by the user.



Fig. 7.7	Explanation
А	Possible error message Note: They are identical to the instrument status message in OPUS.
В	Function: Parameters which define the readiness of the spectrometer to measure
С	Current state: Current switch state of readiness of the parameters in question

VERT	EX 80V	SN_V80v.001) Autom:	ation uni	ts Diaș	gnostics					
Messag	es .										
No erro	1										
CAN D	evices										1
Mot Numb	er Addres	a Type	Use	d Current Pos	Timeout	Status Ready	Error Running	luitiali	red Connected	Firmware version	
36	0xA400	Motor		0	30						
37	0xA500	Motor	100.00	0	60						
14	0x8E00	Sample Changer	SNR	0	15						
15	0x8F00	Motor	100.000	0	15						
10	019000	Sample Changer	SNR	0	15						
17	059100	Motor		0	15						
38	054600	Motor		0	20						
39	0-8000	Motor		2	10						
40	0-8100	Mature		-	140						
56	0-2600	Detector Setting	DTC	61	30						
1308	0=6010	Econor MER (66)	520	1	4	PEADY		N.	v	24	
90	0-DA00	Beamprilitter (DB)	RMS	1	60	READY		x	x	14	
1090	0xDA20	(55)		0	4	100000		x	x	14	
2090	0xDA40	(5E)		0	5			x	x	14	f
3090	0xDA60	(5E)		0	5			x	x	14	
4090	0xDA80	(5E)		0	5			x		14	
5090	0xDAA0	Beamsplitter Chang Rotate (DB)	er BCR	0	60			x	х	14	
6090	0xDAC0	Beamsplitter Chang Rotate (DB)	er BCR	0	15			x	х	14	
7090	0xDAE0	Beamsplitter Chang Rotate (DB)	er BCR	. 0	15			х	х	14	
58	0x8A00	Motor (1)		0	60			X	X	42	
2162	0x2240	CAN-ADI ADC 1		0	5						
3162	0x2260	CAN-ADI ADC 2		0	5						
4162	0x2280	CAN-ADI DAC 1		0	5						
5162	0x22A0	CAN-ADI DAC 2		0	5						
6162	0x22C0	CAN-ADI Digout		0	5						
7162	0x22E0	CAN-ADI Digin		0	5						
Vacuum C	ontrol Status										ñ
L	ocation	Current State Pre	ssure [hPa]								
Interferome	ter Compartm	ent Vented 105	50								
Sample Co	opartment	Vented 105	50								
Flaps		Open									

Fig. 7.8	Explanation
A	Possible error message Note: They are identical to the instrument status message in OPUS.

7.2.5 Diagnostic LEDs at the spectrometer rear side



At the spectrometer rear side, there are the following diagnostic LEDs:

Figure 7.9	Component	Explanation
A	ERR LED (red)	A red ERR LED indicates an interferometer error (e.g. a missing laser signal, a beamsplitter problem). As long as this LED lights, measurement is not possible.
B and C	SR LED (red) and SG LED (green)	These two LEDs indicate the internal operating state of the spectrometer communication processor. (The abbreviation SR stands for 'Status Red' and SG for 'Status Green'.)
D and E	RX LED (green) and TX LED (yellow)	These LEDs indicate the data transfer direction between spectrometer and PC. In case of the stand-alone operation, the green RX LED signals that the spectrometer receives data. In case the spectrometer is connected to an Ethernet network, the green RX LED indicates that a data packet is transmitted on the Ethernet. (This does not necessarily mean that the data packet is destined for the spectrometer!) The yellow TX LED lights when the spectrometer transmits a data packet, i.e. the spectrometer is accessed by a com- puter. The abbreviation RX stands for 'transmit data' and TX stands for 'receive data'. These LEDs can be used for testing the communication between spectrometer and PC.
F	Voltage status LEDs	The voltage status are labeled +5V, +12V and -12V. They indicate the state of the secondary voltages of the electronics unit.

7.3 General information about how to diagnose a fault

In many cases, a problem caused by a spectrometer component, that is either defective or not properly installed or not in operating condition, becomes apparent in several different ways. For example:

- You have started a measurement but OPUS does not display any measurement result. (Reason: OPUS did not start the measurement at all because OPUS has recognized a spectrometer component error.)
- No signal detection or signal intensity is too low. (See section 5.13.)
- You have started a validation test but OVP does not display a PQ or OQ test protocol. (Reason: OVP did not start the validation test at all OPUS has recognized a spectrometer component error.)
- A failed OQ test or PQ test.

To find out the concrete cause of a spectrometer problem, it is advisable to narrow down the trouble source in a systematic way. We recommend the following fault diagnosis procedure:

1		First check whether the STATUS LED ① on the spectrometer top side or the status lamp ② in OPUS indicate a spectrometer problem. ➤ Are they red?
2		If so, open the OPUS dialog window <i>Instrument Status</i> and check whether there is a component having the status WARNING or ERROR.
3	Instrument Status Message Source Source is broken or not connected Ignore Help Service Info Disable	If so, double-click on the component icon in question to look up whether an instrument status message ① is displayed in OPUS. For information about the meaning of the instrument status messages refer to section 7.5.2.
4	VERTEX 80V SN_V80v.0010 SRC Diagnostics tmail Message Message Message News Dealer of message Dealer of message Concerning Message Dealer of message Dealer of message Offer of message ND (dot-onit) Offer offer offer ND (dot-onit) Offer offer offer ND (dot-onit) Offer offer offer ND (dot-onit) Dealer off offer offer ND (dot-onit) Dealer offer offer	For more information about the component in question, open the corresponding diagnostic page of the spectrometer firmware and try to find a hint for the cause of the spectrometer problem. (See section 7.2.4.)

For information about how to eliminate a certain fault, see section 7.5. If the solutions listed in this section do not eliminate a fault contact the Bruker service. (See section 1.6.)

7.4 Remote fault diagnosis

Remote fault diagnosis means that you send a complete spectrometer status report - a so called *Full Report* - by e-mail to Bruker. This report enables a Bruker service technician to perform a first remote fault diagnostics.

Depending on whether your spectrometer is connected to a network or network computer or a stand-alone computer, the procedure for sending the report is different. (For detailed information about the possible connection variants, see section 3.10.2.)

If your spectrometer is connected to a network computer or directly to a network...

With OPUS version 6 or higher, it is possible to send the full report by e-mail to Bruker with just the click of a button. **Important:** The usage of this function requires an e-mail program installed on the network computer and a set-up mail account.

Open the OPUS software program, if not already done. (1)Either select in the OPUS *Measure* menu the Optics Diagnostics function (1) or 1 click on the OPUS status light (2). Thereupon, the Instrument Status ≻ dialog opens. **__** (2) Click on the Send Report button (1). As a result of this, the report is sent ≻ automatically by e-mail to opusreports@brukeroptics.de. 2 Note: In addition, you can define \succ conditions (2) for sending the full report automatically. (1)(2)

Proceed as follows:

If your spectrometer is connected to a stand-alone computer, proceed as follows:

- 1. Generate a full report manually and save it. (See description below.)
- 2. Transfer the full report file to a network computer.
- Note: The network computer requires an e-mail program and a set-up mail account.
- 3. Send the full report by e-mail as an attached file to opusreports @brukeroptics.de.

Generating and saving a Full Report

It is highly recommended to generate and save the full report instantly after a spectrometer problem or failure has occurred. Otherwise, important information may be overwritten by newer ones.

1	Image: A constrained to be constrained to constrained t	 Open the web browser and enter the spectrometer IP address into the address field of the web browser ①. I^{III} For the spectrometer IP address, see the label ② at the spectrometer rear side. ➤ Note: The spectrometer IP address depends on the realized connection variant. See section 3.10.3.
2	Antep://10.10.0.1/ Antep://10.10.1/ Antep://10.1/ Antep://10.1/ Antep://1	 Thereupon, the spectrometer home page opens. Click on Service 1.
3	Control data files Control data file	Click on <i>Full Report</i> ①.
4	Bit Stream Print	Save the full report as *.htm file for send- ing it as an e-mail attachment. Send the full report by e-mail as an attached file to <i>opusreports</i> @ <i>brukerop-</i> <i>tics.de</i> .

7.5 **Problem - possible cause - solution**

7.5.1 Spectrometer problem indicated by a red status indicator board LED

7.5.1.1 Red VACUUM LED

During a spectrometer evacuation, a red VACUUM LED indicates that the ultimate vacuum inside the spectrometer is not reached (i.e it lights up red if a certain threshold pressure value is not reached within a certain period of time).

Possible causes	Solutions
 There is a leakage that allows air to enter the spectrometer. During the evacuation, a leakage may become apparent by a hiss. Possible leakages are: sample compartment cover has not been placed correctly on the spectrometer, flaps do not close properly or the wing-shaped cover is not secured properly (after the beamsplitter has been exchanged) or a IR beam port cover is not reinstalled properly (after an optional accessory / component has been removed from an IR beam port). 	Find the leakage and close it. In case of defective flaps, contact the Bruker service. (See section 1.6)
Vacuum pump is defective.	See the user manual of the vacuum pump.
Vacuum pump is not connected properly.	Check the vacuum pump connection. (For information about how to connect the vacuum pump to the spectrometer, see section 3.8.)
Venting valve(s) do(es) not close. This problem is accompanied by a hissing sound at the spectrometer rear side.	Contact the Bruker service. (See section 1.6)

7.5.1.2 Red LASER LED

Possible causes	Solutions
Spectrometer is still initializing.	In this case, there is not any spectrometer problem. Wait until the spectrometer has completed the initialization successfully. Afterwards, the LASER LED turns automatically to green.
Laser beam inside the interferometer compartment is blocked. In this case the following error message appears: <i>HeNe-Laser is off or no laser signals.</i>	Contact the Bruker service. (See section 1.6)
Laser tube is not installed correctly.	Contact the Bruker service. (See section 1.6)
Laser is defective. In this case the fol- lowing error message appears: <i>HeNe-</i> <i>Laser is off or no laser signals</i> .	Contact the Bruker service. (See section 1.6)
Laser signal is too weak because the average laser lifetime is nearly over. In this case the following error message appears: <i>End of average lifetime is</i> <i>nearly reached, spare part will be</i> <i>required.</i> (Note: If the laser has been in opera- tion for more than 2 years, a decreased laser performance might be the cause of the problem.)	Look up when the laser was put into opera- tion for the first time. You find this informa- tion at the laser diagnostics page. See section 7.2.4. If the average laser lifetime is exceeded (significantly), the laser module needs to be replaced. Contact the Bruker service. (See section 1.6)

7.5.1.3 Red STATUS LED

A red STATUS LED indicates a spectrometer problem which can be caused by a number of spectrometer components (e.g. laser, source, detector). In order to be able to narrow down the problem, it is highly recommended to open the OPUS dialog window *Instrument Status*. See section 7.2.2.

Possible causes	Solutions				
Spectrometer is still initializing.	In this case, there is not any spectrometer problem. Wait until the spectrometer has completed the initialization successfully. As soon as the spectrometer initialization is completed successfully, the STATUS LED turns automatically from red to green.				
 If the laser is the cause of the problem either: the laser beam is blocked (e.g. due to an improperly installed laser) or the laser power supply cable is not connected and/or secured properly or the laser is defective. ► Note: These causes are also indicated by a red LASER LED and by the instrument status message: <i>HeNe-Laser is off or no laser signals.</i> ► Note: The laser has a limited service lifetime of about 25,000 operating hours. Look up the actual service lifetime of the installed laser at the <i>Laser Diagnostics Page</i>. See fig. 7.3.) 	Contact the Bruker service. (See section 1.6.)				
 If the source is the cause of the problem either: the selected source is not installed or the selected source is not installed properly or the selected source is defective. ➤ Note: This problem is indicated by the instrument status message Source is broken or not connected. 	 Missing source: Install the source. Improperly installed source: Check whether the source is installed properly and correct it, if required. Defective source: Order a replacement source. (For the order number refer to appendix B.) After receiving the replacement source, replace the defective source. Image: For the replacement procedure, see section 6.4. 				

Possible causes	Solutions
 If the detector is the cause of the problem: either the detector is not installed correctly or Note: This problem is indicated by the instrument status message Device not connected. No analog board selected. the MCT detector is not cooled down to its operating temperature. Note: This problem is indicated by the instrument status message Detector not ready. 	Improperly installed detector: Check whether the detector is installed correctly and correct it, if required. See section 5.11. MCT detector temperature is too high: Fill liquid nitrogen into the MCT detector dewar. (See section 5.14.)
 If the interferometer (scanner) is the cause of the problem there are a number of possible causes. For example: In case of a manually exchangeable beamsplitter, the beamsplitter is not locked. Note: This problem is indicated by the instrument status message <i>BMS door is open</i>. In case of the automatic beamsplitter changer, a beamsplitter holder is not in its normal position. So the automatic beamsplitter is not able to move the selected beamsplitter in the operating position. Note: This problem is indicated by the instrument status message <i>BMS door is open</i>. 	 Unlocked beamsplitter: Lock the beamsplitter. See section 5.10.3. Beamsplitter holder still in loading position: Move the beamsplitter holder back to its normal position. See section 5.10.4. In case of a different cause, try to narrow down the trouble source by consulting the <i>Scanner Diagnostics Page</i>. (See fig. 7.5.) For error messages regarding the interferometer, see section 7.5.2.3. If you can not solve the problem, contact the Bruker service. See section 1.6.
If the automation is the cause of the problem there are a number of possible causes.	Try to narrow down the trouble source by consulting the <i>Automation Units Diagnos-</i> <i>tics Page</i> . (See fig. 7.8.) For error mes- sages regarding the automation, see section 7.5.2.4. If you can not solve the problem, contact the Bruker service. See section 1.6.

Possible causes	Solutions
If the electronics is the cause of the problem there are a number of possible causes. For example:	First of all, check whether the voltage sta- tus LEDs (labeled +5V, +12V and -12V; F in fig. 7.9) at the spectrometer rear side are on (See section 7.5.5.)
 the electronics unit is defective or there is a short circuit. 	Defective power supply unit: Contact the Bruker service. (See section 1.6.)
	Short circuit: Interrupt the mains power supply of the spectrometer immediately! If there are external accessories and/or components connected to the CAN bus port or any other spectrometer port, discon- nect them. Then reconnect the spectrome- ter to the mains supply. If this action solves the problem the external circuitry has caused the short circuit. Otherwise, it is an internal problem of the spectrometer elec- tronics. Contact the Bruker service. (See section 1.6.)

7.5.1.4 Red PRESSURE LED

Possible causes	Solutions
The air bearing pressure has fallen below the threshold value of 0.8 bar (11.6 psi) because there is something wrong with the compressed air sup- ply.	Check the compressed-air supply. For infor- mation about the compressed-air supply requirements and the connection proce- dure, see section 3.7.
An internal air hose is defective.	Contact the Bruker service. (See section 1.6.)
Internal pressure loss.	Contact the Bruker service. (See section 1.6.)

7.5.1.5 Red FLAPS LED

Possible causes	Solutions
Upon closing the flaps, they are blocked by an object. (For example, an object has got in the opening while you have worked in the sample com- partment.)	Check whether there is something that blocks the flaps. If so, remove it.
Flaps malfunction (i.e. one or both flaps do not open / close properly.)	Contact the Bruker service. (See section 1.6.)

7.5.1.6 Red BMS LED

Possible causes	Solutions
No beamsplitter is installed in the oper- ating position.	Install a beamsplitter in the operating posi- tion. (See section 5.10.3.)
In case of a manually exchangeable beamsplitter, the beamsplitter is not locked.	Lock the beamsplitter in position. (See section 5.10.3.)
In case of the automatic beamsplitter changer, a beamsplitter holder is not in its normal position (i.e. it is still in the loading position). So the automatic beamsplitter changer is not able to move the selected beamsplitter in the operating position.	Move the beamsplitter holder back to its normal position. See section 5.10.4.

7.5.2 Spectrometer problem indicated by an instrument status message in OPUS

7.5.2.1 Instrument status message regarding the laser

Instrument status message	Possible causes	Solutions
HeNe laser is off or no laser signal.	Laser tube is not orientated correctly. OR Power supply to the laser is interrupted. OR Laser is defective.	Contact the Bruker service. (See section 1.6.)
End of average lifetime is nearly reached, spare part will be required.	The end of the specified life- time of the laser is nearly reached.	The laser needs to be replaced in the near future. Contact the Bruker service. (See section 1.6.)
		Note: Despite this warning message, measuring is still possible. To turn the OPUS status light green again click on the <i>Ignore</i> button in the <i>Instrument Status Message</i> dialog (fig. 7.2). The mes- sage will be repeated in cer- tain intervals until the laser module has been replaced.

7.5.2.2 Instrument status message regarding the source

Instrument status message	Possible causes	Solutions
Source is broken or not con- nected.	Source is not installed at all or not installed properly.	Install the source as described in section 6.4.
	Source is defective (e.g. burnt out).	Order a spare source. (For the order number refer to appendix B.) After receiving the replacement source, replace the defective source. (See section 6.4.)
End of average lifetime is nearly reached, spare part will be required.	The end of the specified life- time of the source is nearly reached.	The source needs to be replaced in the near future. Order a spare source. (For the order number refer to appendix B.) After receiving the replacement source, replace the defective source. (See section 6.4.)
		Note: Despite this warn- ing message, measuring is still possible. To turn the OPUS status light green again click on the <i>Ignore</i> button in the <i>Instrument</i> <i>Status Message</i> dialog (fig. 7.2). The message will be repeated in certain intervals until you have replaced the source.

7.5.2.3 Instrument status message regarding the interferometer

Instrument status message	Possible causes	Solutions
Scanner initialization mode.	 This error message appears only if you try to start a measurement while the spectrometer is still initializing. ➤ Also other error messages can be displayed. As in this case there is not a spectrometer problem so you can ignore them. 	 Before starting a measurement, wait until the spectrometer has completed the initialization successfully. ➤ As soon as the initialization is completed successfully, the red STATUS LED of the spectrometer indicator board turns automatically to green. Now you can start to measure.
BMS door is open.	Beamsplitter is not installed properly (i.e. the beamsplitter is not in the locked position).	Lock the beamsplitter in position. See section 5.10.3.
Cassette is open.	In case of the automatic beam- splitter changer, a beamsplitter holder is not in its normal posi- tion (i.e. it is still in the loading position). So the automatic beamsplitter changer is not able to move the selected beamsplit- ter in the operating position.	Move the beamsplitter holder back to its normal position. See section 5.10.4.
Scanner air bearing pres- sure is too low.	Spectrometer is not connected to a compressed-air supply line at all. OR	Connect the spectrometer to a compressed-air supply line. See section 3.7.
	Spectrometer is not connected properly to a compressed-air supply line. OR	Correct the connection to the local compressed-air supply line. See section 3.7.
	Insufficient pressure.	Make sure that the pressure of the local compressed-air sup- ply is sufficient. The scanner air bearing requires a pressure between 1 to 2 bars.

Instrument status message	Possible causes	Solutions
Laser-A timing error / Laser-B timing error OR Laser-A modulation too small / Laser-B modula- tion too small OR Laser signals modulation too small OR Laser period too slow or modulation too small	Interferometer is out of adjust- ment caused by strong vibra- tions, for example.	Contact the Bruker service. (See section 1.6.)

7.5.2.4 Instrument status message regarding an automation unit

Instrument status message	Possible causes	Solutions
 Pressure in interferometer compartment is unstable. / Pressure in sample compartment is unstable. These messages are displayed if the defined ultimate pressure is not reached in the compartment in question when evacuating or venting it. 	A valve jams. OR Vacuum pump is defective / does not work properly. OR There is a leakage that allows air to enter the interferometer compartment. During the evacu- ation, a leakage may become apparent by a hissing sound. Possible leakages are: • detector compartment cover /	Contact the Bruker service. (See section 1.6.) See the user manual of the vac- uum pump. Find the leakage and close it. In case of defective flaps contact the Bruker service. (See section 1.6.)
	 sample compartment cover has not been placed correctly on the spectrometer or the flaps do not close properly or the wing-shaped cover is not secured properly (after a beamsplitter exchange) or an IR beam port cover is not reinstalled properly (after an accessory removal). 	

7.5.2.5 Instrument status message regarding the detector

Instrument status mes- sage	Possible causes	Solutions
Detector not ready.	The MCT detector is not cooled down to its operating temperature.	Cool down the MCT detector by filling liquid nitrogen into the detector dewar. (See section 5.14.)
Device not connected. No analog board selected. OR No analog board found.	Detector you have selected in OPUS is not installed in the spectrometer.	Install the detector. (See section 5.11.)

7.5.3 No signal is detected or signal intensity is too low

Provided that the spectrometer and the PC are properly connected and switched on and the computer can access the spectrometer, this problem can have the following possible causes:

Possible Causes	Solutions
Beam path is blocked.	Check whether the IR beam is blocked in the sample compartment by an accessory or a sample or another object. Remove the sample / object and check the signal again.
In case of a MCT detector or a thermo- electrically cooled detector, the detector temperature is too high.	MCT detector: Fill liquid nitrogen into the MCT detector. (See section 5.14.) Thermoelectrically cooled detector: Contact the Bruker service. (See section 1.6)
This problem is indicated by the instrument status message Detector not ready.	
Detector is not or not properly installed / connected.	Internal detectors: Install the detector properly. (See section 5.11.)
This problem is indicated by the instrument status message Device not connected. No analog board selected.	External detectors: Examine the cable connection at the detector as well as at the spectrometer rear side.
Detector oversaturation or A/D con- verter overflow	Either reduce the source intensity by using a smaller aperture or reduce the gain set- tings.
	Both parameters (aperture and gain) are set in the OPUS dialog <i>Measure-</i> <i>ment</i> . See the OPUS Reference Man- ual.

Possible Causes	Solutions
 Source is not or not properly installed or it is defective. These problems are indicated by the instrument status message Source is broken or not connected. 	Install the source properly. (See section 6.4.) If the source is defective, order a replace- ment source. (For the order number refer to appendix B.) After receiving the replace- ment source, replace the defective source. (See section 6.4.)
 Beamsplitter is not locked in position. This problem is indicated by the instrument status message BMS door is open. 	Lock the beamsplitter in position. (See section 5.10.3.)
Beamsplitter is damaged or has become opaque.	Order a replacement beamsplitter. After receiving replacement beamsplitter, replace the beamsplitter. (See section 5.10.3.)
 Beamsplitter is not properly installed. This problem is indicated by the instrument status message NOT SCANNING. Laser-A modulation too small, Laser-B modulation too small, Laser signal modulation is to small. 	Install the beamsplitter properly. (See section 5.10.3.)
• In case of the automatic beamsplitter changer, a beamsplitter holder is not in its normal position. So the auto- matic beamsplitter changer is not able to move the selected beamsplitter in the operating position.	Move the beamsplitter holder back to its normal position. See section 5.10.4.
Note: This problem is indicated by the instrument status message Cassette is open.	
A temporary or permanent optics mis- alignment caused by strong shock.	Place the spectrometer on a vibration-free surface. In case of a temporary optics mis- alignment, this action can solve the prob- lem. If this action does not solve the problem contact the Bruker service. (See section 1.6.)

Possible Causes	Solutions
If the laser is the cause of the problem either:the laser beam is blocked (e.g. due to an improperly installed laser) or	In case the laser is the cause of the prob- lem, contact the Bruker service. (See section 1.6.)
 the laser power supply cable is not connected and/or secured properly or the laser is defective. 	
These causes are also indicated by a red LASER LED and by the instrument status message: HeNe- Laser is off or no laser signals.	
The laser has a limited service life- time of about 25,000 operating hours. Look up the actual service lifetime of the installed laser at the laser diagnostics page. (See fig. 7.3.)	

7.5.4 A failed validation test

Validation test is a collective term for all tests (e.g. OQ test¹, PQ test²) that can be performed with OVP³ for the purpose of the spectrometer validation⁴. (For detailed information about OVP refer to the OPUS Reference Manual.)

Important note regarding the OQ test

The resolution test, which is part of the OQ test protocol, requires a gas cell filled with CO at low pressure. If you do not have such a gas cell at your disposal, contact the Bruker service. (See section 1.6.)

Possible causes	Solutions
During the validation test measurements, an object (e.g. a sample) in the sample compartment has blocked the IR beam.	Take the sample / object out of the sample compartment and repeat the OVP test.

^{1.} OQ - Operational Qualification (Normally, this test should be performed once a year or at least after the replacement of an optical spectrometer component.)

^{2.} PQ - <u>Performance Qualification</u> (Normally, this test should be perform each day before you start your analytical work and after the replacement of an optical spectrometer component for the purpose of extending the spectral range.

^{3.} OVP - <u>O</u>PUS <u>Validation Program</u>

^{4.} Validating the spectrometer means to check whether the spectrometer system achieves the specified performance parameter values. The spectrometer validation ensures that the measurement results delivered by a validated spectrometer system are correct.
Possible causes Solutions	
 Source performance has decreased significantly because the end of its service lifetime is nearly reached. This problem is indicated by the following message End of average lifetime is nearly reached, spare part will be required. 	Order a replacement source. (For the order number refer to appendix B.) After receiving the spare part, replace the source as described in section 6.4.
Note: To find out of which component - either laser or source - the end of the average lifetime is nearly reached, open in OPUS the <i>Instru-</i> <i>ment Status</i> dialog window. The com- ponent in question has the status WARNING.	
Sample compartment windows (if installed) are dirty or have become opaque.	Order replacement windows. After receiving them, replace them as described in section 5.12.
Beamsplitter is dirty, opaque or damaged.	Order a replacement beamsplitter. After receiving it, replace the beamsplitter as described in section 5.10.
The spectral ranges of selected optical components (source, beamsplitter and detector) are different.	Select source, beamsplitter, detector and windows (if installed) of a matching spectral range and repeat the OVP test.
In case the spectrometer is equipped with optional sample compartment windows, the spectral range of the windows does not match with the spectral range of the selected optical components (source, beamsplitter and detector).	See also section 5.9. For information about the spectral range of the available sources, detectors, beamsplitters and sample compartment windows refer section 4.2.2, 4.2.3, 4.2.4 and 4.2.7.)
After you have filled liquid nitrogen in the MCT detector, you start the OVP test with- out waiting until the detector has reached its operating temperature.	Wait until the detector has reached its operating temperature. Then, repeat the OVP test.
 Ice formation on the MCT detector dewar. This problem becomes apparent by a failed ice band test. This test is part of the PQ test procedure. 	Evacuate the MCT detector dewar. (See section 6.3.) Afterwards, repeat the OVP test.
 Air humidity content inside the spectrometer is too high. ➤ Note: This problem becomes apparent by a failed water vapor test. This test is part of the OQ test procedure. 	Reduce the air humidity content inside the spectrometer by either evacuating the spectrometer or purging it with dry air or nitrogen gas. Afterwards, repeat the OVP test. For evacuating the spectrometer, see section 5.6. For purging the spectrome- ter, see section 5.8.

Possible causes	Solutions
Interferogram peak position has shifted.	Save the new peak position using the OPUS software. See section 5.13.3 Afterwards, repeat the OVP test.
If a failed OVP test has a different cause (e.g. detector sensitivity has weakened or interferometer is out of adjustment due to shock etc.)	contact the Bruker service. (See section 1.6)

7.5.5 Spectrometer problem indicated by the voltage status LEDs

The voltage status LEDs (F in fig. 7.9) are at the spectrometer rear side, labeled +5V, +12V and -12V. These LEDs indicate the state of the secondary voltages of the electronics unit.

7.5.5.1 All voltage status LEDs are off

Possible causes	Solutions
Spectrometer is off.	Switch on the spectrometer. (See section 5.2.)
Spectrometer is not connected to the power supply.	Connect the spectrometer to the power supply. (See section 3.6.)
No voltage is applied.	Check whether the local power supply ful- fills the requirement. (See section 3.5.)
Short circuit in the power supply unit of the spectrometer.	Typically, a short circuit is accompanied by a "ticking" sound in the power supply unit. Interrupt the mains power supply immedi- ately! If there are external accessory and/or com- ponents connected to the CAN bus port or any other spectrometer port, disconnect them. Then reconnect the spectrometer to the mains supply. If this action solves the problem the external circuitry has caused the short circuit. Otherwise, it is an internal problem of the spectrometer electronics. Contact the Bruker service. (See section 1.6.)
Defective power supply unit.	If the voltage status LEDs do not light cor- rectly, probably the power supply unit needs to be replaced. If they do not light at all, contact the Bruker service. (See section 1.6.)

7.5.5.2 One voltage LED is off

Possible causes	Solutions
An external accessory / component causes a short circuit in the power supply unit of the spectrometer.	Switch off the spectrometer and disconnect all externally connected accessories and/or components from the CAN bus port or any other port at the spectrometer rear side. Then switch on the spectrometer. (See section 5.2 and 5.3.)
Temporary short circuit in the spec- trometer.	Switch off the spectrometer, wait about 30 seconds and switch it on again. (See section 5.2 and 5.3.)
A defective LED.	In this case there is no spectrometer mal- function and the spectrometer operates properly. Only the defective LED should be replaced. In case of doubt, contact the BRuker ser- vice. (See section 1.6.)

7.5.6 Spectrometer problem indicated by a red ERR LED

A red ERR LED indicates a scanner malfunction, i.e. all components and/or conditions that are involved in the scanner functioning (laser, beamsplitter, air bearing pressure etc.) can cause a red ERR LED.

Possible causes	Solutions
 If the laser is the cause of the problem either: the laser beam is blocked or the laser tube is not installed correctly or the laser is defective. ➤ These causes are also indicated by a red LASER LED. 	Contact the Bruker service. (See section 1.6.)
In case the beamsplitter is the cause of the problem either:	Missing beamsplitter: Install a beam- splitter. (See section 5.10.)
• no beamsplitter is installed in the oper- ating position or	Unlocked beamsplitter: Lock the beam- splitter in position. (See section 5.10.3.)
 the beamsplitter is not locked in position or it is damaged or has become opaque. 	Damaged or opaque beamsplitter: Order a replacement beamsplitter. After receiving, install the beamsplitter. (See
The first two causes are also indi- cated by a red BMS LED.	section 5.10.)

Possible causes	Solutions	
Air bearing pressure is fallen below the threshold value of 0.8 bar (11.6 psi) because either there is something wrong with the local compressed air supply or an internal hose is defective.	Insufficient air bearing pressure: Check the pressure of the local compressed-air supply. Make sure that the pressure of the compressed air is at least 1.0 ba (14.5 psi). (See also section 3.7.)	
 These causes are also indicated by a red PRESSURE LED. 	Defective internal air hose: Contact the Bruker service. (See section 1.6.)	
Strong mechanical shocks have caused a permanent optics misalignment.	Contact the Bruker service. (See section 1.6.)	

7.5.7 The SR LED lights permanently

As long as the SR LED¹ (B in fig. 7.9) lights, the spectrometer is busy and not available for communicating with the PC.

Possible causes	Solutions
Spectrometer is still in the initialization phase.	In this case, there is not any spectrometer problem. Wait until the spectrometer initial- ization is completed.
	As soon as the spectrometer initializa- tion is completed successfully, the STA- TUS LED at the status indication board of the spectrometer turns automatically from red to green.
Spectrometer control hangs.	Reset the spectrometer using the reset but- ton (R in fig. E.1) at the spectrometer rear side and wait for initialization to terminate. If this action does not solve the problem, con- tact the Bruker service. (See section 1.6.)

7.5.8 No communication between spectrometer and computer

In case of communication problems between the spectrometer and the PC, the troubleshooting procedure depends on the actually realized connection variant. For detailed information about this topic, see section 3.10.

The direction of the data transfer is indicated by the LEDs RX and TX at the spectrometer rear side. The TX LED (E in fig. 7.9) lights during the spectrometer sends data and the RX LED (D in fig. 7.9) lights during the spectrometer receives data. (See also section 7.2.5.

^{1.} The SR LED together with the SG LED indicate the internal operating state of the spectrometer communication processor. (The abbreviation SR stands for *Status Red*.)

7.5.8.1 The green RX LED does not light at all

This indicates a problem with regard to the physical connection between the spectrometer and the PC or the network.

Possible causes	Solutions
With regard to the existing connection variant, the wrong data cable type is used.	The data cable type (cross-over or straight), which has to be used, depends on the realized connection variant. (For information about which data cable type has to be used for which connection variant, see section 3.10.1.) Procure a data cable of the correct type. and replace the data cable.
Data cable connector is loose.	Check both data cable connectors for tight fit, i.e. at the Ethernet port at the spectrom- eter rear side and at the PC. Connect the data cable properly. (See section 3.10.1.)
Data cable is damaged.	Check the data cable for damages. If it shows signs of damages, replace it.
Spectrometer does not start up.	Check whether the spectrometer is con- nected to a mains socket outlet. (See section 3.6.) Check whether the mains supply meets the requirements. (See section 3.5.) Check whether the spectrometer is switched on. (See section 5.2.) If these actions do not solve the problem contact the Bruker service. (See section 1.6.)

7.5.8.2 During connection establishment the RX LED lights but the TX LED does not

This indicates that there is no logical connection between the spectrometer and network or computer.

Possible causes	Solutions
With regard to the realized connection variant, the wrong IP address has been assigned to the spectrometer. Note: The correct spectrometer IP address depends on the existing connection variant. (See section 3.10.3.)	Assign the correct IP address to the spec- trometer. (See section 3.10.4.)
TCP/IP settings mismatch between spectrometer and computer/network.	Refer to the documentation of the operat- ing system Windows.

Hint: If you do not succeed in solving the communication problem between spectrometer and PC, consult your network administrator. To provide the network administrator with the relevant information, proceed as follows:

- 1. Click in the Window desktop on the *Start* button.
- 2. Select Run.
- 3. Enter cmd and click OK.
- 4. Enter route print and press the ENTER key.
- 5. Then, enter ipconfig/all and press the ENTER key again.
- 6. Take a screenshot of the dialog (fig. 7.10) and provide it for your network administrator.

CC Copyright 3002-2001 Ricewalt Copy. C: Copyright 3002-2001 Ricewalt Copyright Signal Ricewalt Ricewal
C:\Dokuments und Einstellungen\mafebrack C:\Dokuments und C:\Dokuments und Einstellungen\mafebrack C:\Dokuments und C:\Dokuments und Einstellungen\mafebrack C:\Dokuments und C:\Dokument
<pre>School:tittellenliste School:tittellenliste School:tittellingenvafe> Schoo</pre>
Bh2 B# 211 So 101 Sol 101 Sol 101 Sol 101 F1 Long X5000 FGM - Poketplaner-Hinipometry Bh2 B 21 So 201 Sol
n. J
Action Rescuent 0.8.8.0 0.8.8.0 149.236.31.1 149.236.31.1 220 1.9.9.2 0.8.9.0 149.236.31.1 149.236.31.1 220 1.9.9.2 0.8.9.0 149.236.31.1 149.236.31.1 220 1.9.9.2 0.9.9.0 149.236.31.1 149.236.31.1 220 1.9.2 0.9.9.0 149.236.31.1 149.236.31.1 220 1.9.2 0.9.5.2 0.9.5.2 129.0 1.9.1 200 1.9.2 0.9.5.2 0.9.5.2 0.9.5.2 1.9.2 1.9.2 1.9.2 2.5.2.5 0.55.2 0.55.2 0.55.2 1.9.2 1.9.2 1.9.2 1.9.2 2.5.2.5 0.55.2 0.55.2 0.55.2 1.9.
Metrumpkisi Metrumphasis 49 Gateway Schnittzella Annaha 127:08.01<
Ständige Bouten: Krino C:Dokumente und Einstellungen\nafe>igconfig/all Vindows-IP-Konfiguration Prisses DBS-Sufix: LTOP221 Prisses DBS-Sufix: Höpti Kontentyp
C:\Dokumente und Einstellungen\mafe>ipcall Vinduow -offsuretion Poissene
Undows-1P-Konfiguration Hestame Probave DNS-Saffix
Hostname. Dis-Suffix: ITOP231 Prinkies Dis-Suffix: 207118.LGN Inconstructor
Ethernetadapter Drahtlose Netzwerkwerhindung:
server and poet of directory internet stational -
Medienstatus : Es hesteht keine Verbindung Reschreibung. : IntelXRN ViFi Link S300 AGN Physikalische Adresse : 00-21-64-00-00-00
Ethernetadapter LAN-Verbindung:
Verbindungsspezifisches DNS-Suffix: optik.lan Beschreibung: Intel(R) 82567LH Gigabit Network Con nection
Physical isote fideesse 109-21-66-82-95-P2 BRCP ack isotert da Appland functions it isotert 149-236-21, 121 Subscreaming functions isoters 129-236-21, 121 Subscreaming functions isoters 129-236-21, 121 Subscreaming functions 129-236-21, 121 BRCP for ever 149-236-21, 11 BRCP for ever 149-236-21, 11 BRCP for ever 149-236-30, 11
Primarer VINS-Server : 149.236.30.10 Sekundårer VINS-Server : 149.236.30.11
Lease crhalten
17 Lease lauft ab Donnerstag, 26. November 2007 08:28:
Lease läuft ab : Donnerstag, 26. November 2009 08:28:

A Specification

A.1 Spectrometer

Parameter	Specification
Weight	Basic spectrometer configuration: approx. 120 kg (Note: The concrete weight depends on the individual instrument configuration.)
Dimensions	85cm (W) x 70cm (D) x 30cm (H)
Spectral range	standard: With the standard optical components (KBr beamsplitter, DLaTGS detector and MIR source) the following spectral range is achieved: MIR: 8,000 to 350cm ⁻¹
	optional: With the corresponding optional optical components, the following spectral ranges can be achieved: Far IR/THz: 680 to 5cm ⁻¹ Near IR: 15,500 to 4,000cm ⁻¹ Visible: 25,000 to 9,000cm ⁻¹ Ultraviolet: 50,000 to 25,000cm ⁻¹
Spectral resolution	standard: better than 0.2cm ⁻¹ optional: better than 0.06cm ⁻¹
Wavenumber accuracy	better than 0.01cm ⁻¹ @ 2,000cm ⁻¹
Photometric accuracy	better than 0.1% T
Scan speed	standard: 12 velocities from 1.6 to 160kHz (1.0 to 100mm/sec opd ^a) optional: 5 additional velocities (200 kHz, 240 kHz, 280 kHz, 300 kHz and 320 kHz)
Detector	standard: High sensitivity DLATGS detector with KBr window optional: various detectors for measurements in the NIR, MIR, FIR, UV and VIS region (See also section 4.2.3.)
Laser	VERTEX 80v is a laser class 2 product containing a laser class 3R laser according to EN 60825-1:2007. Divergence angle: 0.2 mrad
Interferometer	Actively aligned UltraScan interferometer with linear air bearing scanner

Parameter	Specification
Sample compartment	Dimension: 25.5cm (W) x 27.0cm (D) x 16.0cm (H) The sample compartment is evacuable and purgeable. Optionally, sample compartment can be separated from the optical bench by windows mounted on either the flaps or the sample compart- ment walls. Alternatively, the sample compartment can be separated from the optical bench by flaps without windows.
Electronics	Microprocessor-controlled optics bench with digital speed control, sys- tem diagnostics, advanced system check, 96 kHz A/D converter with 24 bit dynamic range. Industry standard Ethernet connection
Housing	Vacuum-tight cast aluminum housing
Vacuum	Evacuable below 5mbar

a. opd - optical phase difference

A.2 Power supply

Parameter	Specification
Voltage	Spectrometer: 100 - 240 VAC ± 10%; 50 - 60 Hz
Power consumption (basic spectrometer configuration)	80W typical, 180W max.
Overvoltage category	II according to EN 61010-1 or IEC 60664-1
Pollution degree	2 according to EN 61010-1 or IEC 60664-1
Protection class	I according to IEC 61140

For the power supply specifications of the vacuum pump and the data system, see the corresponding user manual.

A.3 Compressed air supply

Parameter	Specification
Compressed air properties	air or nitrogen gas dry and clean (oil-free and dust-free) dew point below -15°C,

Parameter	Specification
Pressure range	min. 1.0 bar (14.5 psi) max. 2.0 bar (29 psi)
Flow rate	< 100 l/h

> Compressed air is required for a proper functioning of the scanner air bearing.

A.4 Purge gas supply

Parameter	Specification
Purge gas properties	air or nitrogen gas dry and clean (oil-free and dust-free) dew point below -40°C (corresponds to to a degree of dryness of 128ppm humidity)
Pressure range	min. 1.0 bar (14.5 psi) max. 2.0 bar (29 psi)
Flow rate	Short-term: Flow rate should not exceed 500 l/h. Long-term: Recommended flow rate is 200 l/h.

> Note: As an alternative to the vacuum operation, the spectrometer can be purged.

A.5 Environmental conditions

Parameter	Specification
Ambient temperature range	18 - 35°C (64 - 95°F)
Ambient temperature variations	max. 1°C per hour and max. 2°C per day
Humidity (non-condensing)	\leq 80% (relative humidity)
Installation site	in a closed room, max. 2000m above sea level

B Replacement parts

B.1 Source

Order number	Replacement part
Q 328/7	MIR source, mounted, 12 V
Q 428/7	NIR source, mounted, 12 V

B.2 Beamsplitter

Order number	Replacement part	
T303/8	KBr beamsplitter, standard, (MIR), 8,000 to 350 cm ⁻¹	
T304/8	KBr beamsplitter, broad band, (MIR), 10,000 to 400 cm ⁻¹	
T401/8	CaF ₂ beamsplitter (NIR), 15,000 to 1.200 cm ⁻¹	
T602/8	CaF ₂ beamsplitter (NIR/VIS/UV), 50,000 to 4.000 cm ⁻¹	
T222/8	Multilayer beamsplitter (FIR), 680 to 30 cm ⁻¹	
T204/8	Mylar beamsplitter, 25 μ m (FIR), 120 to 20 cm ⁻¹	
T205/8	Mylar beamsplitter, 50 µm (FIR), 60 to 10 cm ⁻¹	
T208/8	Mylar beamsplitter, 125 μ m (FIR), 22 to 5 cm ⁻¹	

B.3 Windows

Windows flanged to the sample compartment walls and windows mounted on the flaps.

> Note: For both optional variants, the windows are identical (diameter: 49.5mm).

Order number	Replacement part	
F131-1	Quartz window	
F131-3	CaF ₂ window	
F131-4	NaCl window	
F131-5	KBr window	
F131-6	KRS-5 window	
F131-7	Csl window	
F131-8	Si window	
F131-9	Polyethylene window	
F131-11	ZnSe window	
F131-17	BaF ₂ window	

Windows for telescopic-type insert

> For this optional variant, the windows have a diameter of 35mm.

Order number	Replacement part	
F173-3	CaF ₂ window	
F173-5	KBr window	
F173-9	Polyethylene window	

C Measurement parameters

C.1 General information

Before starting a measurement, you have to define the measurement parameters using the OPUS software. To do this, select in the OPUS *Measure* menu the *Advanced Measurement* function and enter adequate measurement parameter values. The selected parameter settings and values are stored in a XPM-file.

For detailed information about this topic, refer to the OPUS Reference Manual.

C.2 Default parameter values and settings

For VERTEX 80v, the following xpm-files are delivered with OPUS:

- MIR_TR.XPM (for MIR measurements in transmittance)
- MIR_ATR.XPM (for MIR measurements with an ATR accessory)
- MIR_ATR_preview.XPM (for MIR measurements with an ATR accessory and with the preview mode being activated))
- MIR_DRIFT.XPM (for MIR measurements in diffuse reflectance)
- MIR_Refl_30.XPM (for MIR measurements in reflectance; the accessory is designed for a reflection angle of 30°.)

These XPM-files include the standard parameter settings and values for dedicated types of measurement (e.g. transmittance, reflectance, ATR).

Take into consideration that depending on the actual spectrometer configuration, different measurement parameter settings and values may apply. Especially the optics parameter settings depend on the spectrometer configuration. In this case, you have to adapt the parameter settings and values correspondingly.

The following table lists the standard parameter values and settings which apply to the standard spectrometer configuration for a MIR measurement in transmittance.

Settings and values
4
6 scans
from 7500 to 400cm ⁻¹
Transmittance
Transmittance and Single Channel
Settings
MIR source (#1)
KBr

Optical Filter Setting ^a	open
Aperture Setting ^b	6mm
Sample/Background Measurement Channel	Sample Compartment
Detector Setting	RT-DLaTGS (#1)
Scanner Velocity	10 kHz
Sample Signal Gain	automatic
Background Signal Gain	automatic
Delay after Device Change	3
Delay before Measurement	0
Acquisition Parameters	Setting
Wanted High Frequency Limit	15.500cm ⁻¹
Wanted High Frequency Limit Wanted Low Frequency Limit	15.500cm ⁻¹ 0cm ⁻¹
Wanted High Frequency Limit Wanted Low Frequency Limit High Pass Filter	15.500cm ⁻¹ 0cm ⁻¹ open
Wanted High Frequency Limit Wanted Low Frequency Limit High Pass Filter Low Pass Filter	15.500cm ⁻¹ 0cm ⁻¹ open 10kHz
Wanted High Frequency Limit Wanted Low Frequency Limit High Pass Filter Low Pass Filter Acquisition Mode	15.500cm ⁻¹ 0cm ⁻¹ open 10kHz Double Sided - Forward/Backward
Wanted High Frequency LimitWanted Low Frequency LimitHigh Pass FilterLow Pass FilterAcquisition ModeCorrelation Mode	15.500cm ⁻¹ Ocm ⁻¹ open 10kHz Double Sided - Forward/Backward OFF
Wanted High Frequency LimitWanted Low Frequency LimitHigh Pass FilterLow Pass FilterAcquisition ModeCorrelation ModeFT-Parameters	15.500cm ⁻¹ Ocm ⁻¹ open 10kHz Double Sided - Forward/Backward OFF Settings
Wanted High Frequency LimitWanted Low Frequency LimitHigh Pass FilterLow Pass FilterAcquisition ModeCorrelation ModeFT-ParametersPhase Correction	15.500cm ⁻¹ Ocm ⁻¹ open 10kHz Double Sided - Forward/Backward OFF Settings 32cm ⁻¹
Wanted High Frequency LimitWanted Low Frequency LimitHigh Pass FilterLow Pass FilterAcquisition ModeCorrelation ModeFT-ParametersPhase CorrectionPhase Correction Mode	15.500cm ⁻¹ Ocm ⁻¹ open 10kHz Double Sided - Forward/Backward OFF Settings 32cm ⁻¹ Power Spectrum
Wanted High Frequency LimitWanted Low Frequency LimitHigh Pass FilterLow Pass FilterAcquisition ModeCorrelation ModeFT-ParametersPhase CorrectionPhase Correction ModeApodization Function	15.500cm ⁻¹ Ocm ⁻¹ open 10kHz Double Sided - Forward/Backward OFF Settings 32cm ⁻¹ Power Spectrum Blackman-Harris3-Term

- a. Note: The available optical filter options (NG4, NG9, NG11 and polystyrene) are used for OQ and PQ tests only. When such a test is running, the correct filter is moved automatically in the beampath, i.e. it does not need to be selected explicitly by the user. Normally, these optical filters are not intended for spectroscopic measurements. For this reason, select by default the optical filter setting Open when defining the measurement parameters. Note: There are vacant filter wheel positions which can be equipped with optional filters (filter diameter: 25mm), if desired. They can be used for customer-specific applications.
- b. By default, the aperture wheel has 12 occupied positions which allow for the following aperture settings: 0.25, 0.5, 1, 1.5, 2, 2.5, 3, 3.5, 4, 5, 6, and 8mm. The optimal aperture setting depends mainly on the detector and the source which are currently used and on whether the measurement is to be performed using a special accessory or not. As a rough guideline: The more sensitive a detector is the smaller the aperture should be (e.g. MCT: ca. 2mm). In case of an accessory having a small measurement spot, select a small aperture (e.g. A518, reflection unit, grazing incidence 80°: < 1mm). Note: In addition to the 12 default aperture wheel positions, there are four vacant aperture wheel positions which can be equipped with customer-specific apertures, if desired. These optional aperture settings are selectable by direct commands.

C.3 Interactive setting of optics parameters

The OPUS software provides the option to set the optics parameters *Source Setting*, *Detector Setting* and *Measurement Channel* also interactively using the schematic presentation of the beam path. To do this, click in the *Measurement* dialog on the *Beam Path* tab. The following window opens:



To select the detector position 2, for example, place the cursor on this detector so that the label *Detector 2* occurs and double-click on this position. The setting will switch to detector 2. See fig. C.2. As soon as you click on the *Check Signal* tab, the spectrometer implements the settings.



- In this way, you can also change the Source Setting and Measurement Channel.
- The parameters you have set in the schematic presentation of the beam path are realized automatically by the software also in the corresponding fields on the Optics page and vice versa.

D Dimensional drawings





















E Electronics & power supply unit

E.1 Electronics unit - Diagnostic LEDS and connecting ports



Fig. E.1	Component	Explanation
A	TRG port	The 15-pin TRG port is intended for the connection of a trig- gering device. This port is only used in conjunction with the Step Scan option for step scan and time-resolved measure- ments. (The abbreviation TRG stands for "Trigger".) (For detailed information refer to the Step Scan Manual.)
В	DDC4	The ports DDC 1 to 4 (B, G, J and O in fig. E.1) are versatile ports to connect external optical modules and detectors. These ports include a complete CAN bus, transmits all required remote trigger signals and establishes a complete connection to DDC (Digital Detector Connection) compatible detectors. (Note that the DDC 4 port can not be used if a detector is connected to the DDC 4 port inside the spectrom- eter. In this case, a cap is fixed to the DDC 4 port.)
С	EDIS port	The EDIS port has no function at the moment. (The abbrevia- tion EDIS stands for "External Display".)
D, E and F	CR, CY and CG LEDs	These LEDs are status and diagnose LEDs for the step scan option. They indicate the status of the controlling device. (The abbreviation CR stands for "Controller Red", CY for "Control- ler Yellow" and CG for "Controller Green".) (For detailed infor- mation refer to the Step Scan Manual.)
G	DDC 3	See explanation for component B.
Н	LAS TEST port	The port LAS TEST is intended for service and diagnostic purposes only. Do not connect a device to this port!
I	Spectrometer IP address	For detailed information about the spectrometer IP address, see section 3.10.3.
J	DDC 2	See explanation for component B.
К	COM1 port	This port is technically similar to a conventional, PC-compati- ble serial port, however, it does not have the complete func- tionality like serial port of a PC. It is only used for special applications.
L	ERR LED (red)	A red ERR LED indicates an interferometer error (e.g. a miss- ing laser signal). As long as this LED lights, data acquisition is not possible. (For troubleshooting, see section 7.5.6.)
М	FWD LED (yellow)	This LED indicates the current interferometer mirror move- ment. As long as the interferometer mirror moves forward this LED lights. During the backward movement the LED does not light. Thus, the LED flashes in the rhythm of the interferome- ter mirror forward and backward movement. This rhythm depends on the chosen measurement parameters (e.g. reso- lution and velocity). (The abbreviation FWD stands for "for- ward".)

Fig. E.1	Component	Explanation
N	TKD LED (green)	This LED indicates that the interferometer mirror is within the data acquisition range. Typically, it flashes with twice the frequency and synchronous to the FWD LED. During data acquisition the light intensity changes to bright green. (The abbreviation TKD stands for "take data".)
0	DDC1	See explanation for component B.
P and Q	SR LED (red) and SG LED (green)	These two LEDs indicate the internal operating state of the spectrometer communication processor. (The abbreviation SR stands for "Status Red" and SG for "Status Green".) (For troubleshooting, see section 7.5.7.)
R	RES (reset button)	Pressing this button longer than 1 second resets the spec- trometer without the need to turn it off. The effect is identical to switching the spectrometer off and on again. In addition, this button can be used to assign an IP address to the spec- trometer. See section 3.10.4.
S and T	RX LED (green) and TX LED (yellow)	These LEDs indicate the data transfer direction between spectrometer and PC. In case of the stand-alone configura- tion, the green RX LED signals that the spectrometer receives data. In case the spectrometer is connected to an Ethernet network, the green RX LED indicates that a data packet is transmitted on the Ethernet (This does not neces- sarily mean that the data packet is destined for the spectrom- eter!) The yellow TX LED lights when the spectrometer transmits a data packet, i.e. the spectrometer is accessed by a computer. Note: The abbreviation RX stands for "transmit data" and TX stands for "receive data". You can use these LEDs to test the operational reliability of the Ethernet connection. In case of communication problems see section 7.5.8.
U	ETH (Ethernet port)	This port is used to connect the spectrometer to a PC or to a network (Ethernet standard 10/100Base-T). For detailed information, see section 3.10. The ETH port is designed for RJ-45 plugs and complies with the 10/100Base-T standard.



E.2 Power supply unit - Diagnostic LEDs and connecting ports

Fig. E.2	Component	Explanation
A	Voltage status LEDs (+5V, +12V, -12V)	The voltage status are labeled +5V, +12V and -12V. They indi- cate the state of the secondary voltages of the electronics unit. Note: A dark voltage status LED indicates a major electronics problem. For troubleshooting, see section 7.5.5.
В	CAN bus port	The CAN bus connector is primarily used to connect external automated units (e.g. sample changer, moving mirror unit, etc.) to the spectrometer. The CAN bus also provides power to these units. Thus, most external units can be operated without connecting them to the power supply. Furthermore, the CAN bus can be used as a communication link to control these external units via the spectrometer. (The abbreviation CAN stands for Controller Area Network.)
С	ON/OFF switch	The on/off switch is used to switch the spectrometer on and off. (See section 5.2 and section 5.3.)
D	Low-voltage socket (male connector)	The low-voltage socket is used to connect the low-voltage cable of the external power supply unit to spectrometer. For connecting the spectrometer to the power supply, see section 3.6.

F Spectrometer firmware

F.1 General information

All spectrometer-firmware-related tasks are executed by the FCONF program (<u>Firmware Configuration Tool</u>), namely:

- updating the firmware,
- restoring a previous firmware version,
- backing up the current firmware version,
- initializing the firmware (For service purposes only!),
- running a custom script (For service purposes only!).
- assigning a new IP address to the spectrometer (See section 3.10.4.)

F.2 Starting the FCONF program

1. Browse in the file manager to the OPUS program directory and start the FCONF program by double-clicking on *fconf.exe*.



- Note: In case of updating the spectrometer firmware, the firmware update is typically delivered on CD or by e-mail. If the firmware update has been delivered on a CD, start the FCONF program directly from the CD by double-clicking on the *fconf.exe* file and proceed as described below. If the firmware update has been delivered via e-mail, first store the delivered files into a temporary directory. Then, proceed as described below.
- ➤ Thereupon, the following dialog opens:

Specify the network address of the spectrometer whose firmware you want to configure:
Enter Cuscolin acuress. [10.10.0.1 Search for instruments in network (not supported by all instruments)
IP address: Net name: Instrument type:
C Assign a new address to the spectrometer (BOOTP).
To locate the spectrometer and Beep Beep

- 2. Specify the spectrometer of which the firmware is to be updated. To do this, activate the *Enter custom address* option button and enter the corresponding IP address in dotted notation. (Note: The spectrometer IP address depends on the realized connection variant. For more information, see section 3.10.3.)
- 3. After having entered the IP address, check whether the intended spectrometer is addressed by clicking on the *Beep* button. The addressed spectrometer will beep shortly three times.
- 4. Click the *Next* button.

F.3 Updating the spectrometer firmware

 C Update firmware C Restore previous firmware C Backup current firmware C Initialize firmware		
C Run custom script Description UPDATE SCRIPT Updates the current firmware. Creates a backup of the current firmware before performing the update. Resets the spectrometer when the update is firshed and prints the DSP and EWS firmware versions.	*	
Execute the script stepwise.		

- 1. Activate the Update firmware option button.
- 2. Click on the Next button.
- 3. Select the directory (run folder) in which the backup data are to be stored.
- Note: It is recommended to accept the displayed default directory.
- 4. Follow the next on-screen instructions.

A spectrometer firmware update involves the following steps:

- At first, the FCONF program backs up the current version in case the updateversion does not ensure a trouble-free operation so that the firmware needs to be restored again. (For information about how to restore a previous firmware version, see section F.2.)
- Then, the FCONF program updates the current spectrometer firmware version.
- Afterwards, it resets the spectrometer.
- The update procedure may take several minutes, depending on the available bandwidth and the amount of files to be updated.
- After the firmware updating has been completed successfully, a corresponding message appears.
- In case of error during the update procedure, the FCONF program terminates the procedure and proposes to restore the previous firmware version. (For information about how to restore a previous firmware version, see section F.2.)

F.4 Restoring a previous firmware version

Select the desired firmware configuration procedure.
C Update firmware
Hestore previous timware C Review events forware
C latisfies forward
C Run custom script
- Description
RESTORE SCRIPT
Restores the firmware from a backup which was orested during a previous run. Does not restore the INVRAM or the Range EEPROM. Backs up the current firmware before restoring the Immare. Resets the spectrometer and prints the current EWS and DSP firmware
Execute the script stepwise.

Solution You can restore only a firmware version which has been backed up before.

- 1. Activate the Restore previous firmware option button.
- 2. Click on the Next button.
- Select the directory (run folder) which contains the firmware version you intend to restore.
- 4. Follow the next on-screen instructions.

Restoring a previous spectrometer firmware version involves the following steps:

- At first, the FCONF program backs up the current version.
- Then, the FCONF program restores the spectrometer firmware on the basis of a previous firmware version which the user has been backed up before.
- Afterwards, it resets the spectrometer.

F.5 Backing up the current spectrometer firmware version

Select the desired firmware configuration procedure.
O Update firmware
C Restore previous firmware
Backup current firmware
C Initialize firmware
C Run custom script
Description
BACKUP SCRIPT
Creates a backup of the current firmware (including the NVRAM and the Range EEPROM).
Ŧ
Execute the script stepwise.

- 1. Activate the *Backup current firmware* option button.
- 2. Click on the *Next* button.
- 3. Follow the on-screen instructions.

G Sample preparation

G.1 General information

Proper sample preparation is crucial to obtain good and meaningful spectra. This section describes several sample preparation techniques that cover a wide range of samples. It will give you some help in choosing the most suitable sample preparation technique for a given sample.

The adequate sample preparation technique depends on the state of aggregation and the spectral absorptivity of the sample. Regardless of the state of aggregation, the sample material has to be homogeneous because variations in concentration or composition within the sample area to be analyzed can result in misleading or erroneous data. Sometimes the trial-and-error procedure is required to obtain an acceptable spectrum.

G.1.1 State of aggregation

Depending on the state of aggregation of the sample, there are different sample preparation and measurement techniques. If you have to analyze a solid sample you can either prepare a solution, a Nujol mull or a KBr pellet. Liquid samples can be analyzed either as a thin film between plates or in a liquid cell. Gaseous samples require dedicated cells with different path lengths.

G.1.2 Absorptivity

The absorptivity of the sample is a critical factor in choosing a suitable sample preparation method. To get a meaningful spectrum of a strongly absorbing sample, the sample has to be either:

- very thin or
- diluted by a solvent or powder that is not strongly absorbing.

According to Lambert Beer's Law, the absorbance (i.e. peak intensity) in an absorbance spectrum is directly proportional to the component concentration in the sample, pathlength of the sample and the absorptivity.

$$A = \varepsilon b C$$

Symbol	Description	Typical measuring units
А	Absorbance at a given wavelength	None
3	Molar absorptivity (a proportionality constant)	I · mol ^{-1.} cm ⁻¹
b	Pathlength of the sample (cell length for sam- ples in a cell or sample thickness for films, pressed pellets)	cm
С	Component concentration in the sample	mol/l

If the absorbance A (i.e. peak intensity) is too strong, decrease the sample concentration C by diluting it or diminish the pathlength b by reducing the sample thickness. If the absorbance A (i.e. peak intensity) is too weak, increase the sample concentration C or the pathlength b correspondingly to obtain a reasonable peak intensity.

To find out whether a sample is strongly absorbing in the wavelength range of interest or not you have to acquire a test transmission spectrum. Figure G.1 shows a transmission spectrum of a strongly absorbing sample.



G.2 Sample preparation techniques

There is a large number of possible sample preparation techniques. For lack of space, however, not all possible techniques can be described in detail in this chapter. Therefore, we restrict our explanations only to the most common techniques. (For more detailed information about this topic refer to the relevant specialist literature¹.) Moreover, we give you a general guideline for choosing the adequate sample preparation technique.

To find the most adequate method we recommend trying several sample preparation techniques and acquiring spectral data. On the basis of these data, you can assess which sample preparation technique is the most suitable one for your application. In case of doubt ask your application specialist.

^{1.} e.g. Günzler, Helmut / Gremlich, Hans-Ulrich (2002): IR Spectroscopy - An Introduction. Weinheim: WILEY-VCH Verlag.

Some of the most common sample preparation techniques are:

- No sample preparation (e.g. self supporting film or measurement using a micro-ATR accessory)
- Thin film of liquid sample solution between two IR-transparent plates¹
- Preparing a sample solution
- Preparing a Nujol mull²
- Pressing a KBr pellet
- Liquid cell and gas cell
- Most of the described sample preparation techniques involve the use of hygroscopic materials (such as NaCl or KBr), i.e. if these materials come in contact with water or alcoholic solvents, they begin to dissolve or become opaque and thus, impair the measurement results. Therefore, avoid all sources of water and even alcohols (ethanol and methanol).

G.2.1 No sample preparation

The easiest samples to analyze are film and polymer samples with a thickness of less than approx. 100 micrometers. They can be simply placed in a magnetic holder and immediately scanned. The same procedure can be used for samples which can be sliced to an appropriate thickness.

A large number of solid and liquid samples can also be analyzed without requiring a preparation using a micro-ATR accessory. <u>Attenuated Total Reflectance (ATR)</u> units are a very versatile accessory for FT-IR measurements. In many cases, the micro-ATR unit can be used for liquid and semi-liquid materials instead of the constant path transmission cells and the salt plates. In addition, this measurement accessory can also be used for analyzing polymer films, pastes and powders. Due to the reproducible effective pathlength, they are well suited for both qualitative and quantitative analyses. Depending on the sample material and the objective of the analysis, there are different ATR-crystal materials (e.g. ZnS, ZnSe, Ge and diamond). The sample penetration depth ranges between 0.1 and 2µm and depends on the wavelength, the refractive index of the ATR-crystal material and the incidence angle of the beam. (For more information about attenuated total reflectance refer to the respective specialist literature.)

G.2.2 Thin film between plates

Preparing a thin film of a liquid sample between two IR-transparent plates is an easy sample preparation method. Choose this method if your sample is either a liquid or an oil. An advantage of this method is that only a small amount of the sample is required.

- Apply a drop of the sample on one of the plates using a pipet.
- Place a second plate on the top and make a quarter turn to obtain a nice even film of the liquid sample. Sandwich the plates carefully together to remove all air bubbles. Note that these plates are very fragile and can break easily. (The space between the two plates is very small (typically < 0.01mm).
- If the sample amount proved to be too much, separate the plates, wipe one side clean and fit the plates together again.
- Slot the plates in the sample holder of the spectrometer and start the measurement.

^{1.} i.e. IR-transparent within the frequency range of interest

^{2.} A mull is a mixture (more precisely a suspension) of two substances, one of which (i.e. the sample) is finely divided and dispersed in the other (e.g. the paraffin oil Nujol).

The plates (made of NaCl or KBr) are extremely moisture sensitive. Therefore, do not use samples that contain water, keep the plates always dry, clean them only with chloroform or high purity acetone and polish them carefully after each use. In the course of time they will absorb moisture from the atmosphere and deteriorate. Therefore, proper storage (e.g. in an exicator) is extremely important.

G.2.3 Solid sample as sample solution

Use this sample preparation method if your sample is a soluble solid (e.g. a soluble powder). To obtain an IR spectrum, you have to prepare a concentrated solution of your sample using a suitable solvent. The concentration of the solution needed for a good spectrum depends on the sample.

- Dissolve the sample or sample powder in a solvent and apply the sample solution between two support plates, as described above. Depending on the available amount of sample material you can either apply a small amount of your sample powder directly on the plate and add one drop of the solution or dissolve the sample in a test tube and apply the solution with a pipet on the plate.
- A second variant is to apply the sample solution on an IR-transparent plate and allow the solvent to evaporate leaving a thin sample film on the plate. Then, slot the plate in the sample holder of the spectrometer and start the measurement.
- A third variant is to fill the sample solution in a liquid cell and acquire a sample spectrum. To acquire a background spectrum measure the liquid cell containing only the solvent. The volumes of these liquid cells are between 0.1 and 1ml. Microcells with a much lower capacity are also available.
- Do not forget to acquire a background spectrum from the solvent as well.
- ► The plates (made of NaCl or KBr) are extremely moisture sensitive. (See above.)

The major problem in preparing a solution is choosing an appropriate solvent. Most solvents have a strong absorptivity and so their absorption bands will superimpose those of the solute. Therefore, you have to ensure that the used solvent is not strongly absorbing in the wavelength range of interest. Use only spectrophotometrically pure solvents and solvents that are not infrared active in the spectral region of interest.

No solvent is perfect but if some information about the sample is known, the solvent can be chosen accordingly. Commonly used solvents are carbon tetrachloride, carbon disulphide, chloroform, cyclohexane, acetonitrile, and tetrachloroethylene. Never use water as solvent because, firstly, it will dissolve the salt plates and secondly, it exhibits a broad OH-peak. Consult the relevant reference books for the absorptivity of the various solvents.

G.2.4 Preparing a mull

This sample preparation method is suitable if the solid sample can be ground into fine particles but a suitable solvent is not available. In this case the sample powder is suspended in a mulling agent (i.e. a liquid in that the solid is not soluble). A suitable mulling agent is Nujol, a paraffin oil, which is transparent in the infrared region, except for narrow bands at 2900, 1450 and 1375cm⁻¹. (An alternative mulling agent, which does not absorb in these regions, is a perfluorokerosene, such as Fluorolube.)

The advantage of this technique is that it is a relatively quick and simple procedure. The disadvantage is the interference resulting from the absorption bands of the mulling agent. (Both Nujol and Fluorolube have characteristic spectral features and in most cases have to be used as a pair in order to generate a complete MIR spectrum. Nujol is used below 1330cm-1, Fluorolube above 1330cm⁻¹.)

- Put a small amount of your solid sample in an agate mortar.
- Grind the sample thoroughly into fine powder (particles smaller than 500 mesh) using a pestle.
- A common mistake when preparing a Nujol mull is to spend too little time grinding the powder. Note that a mull prepared from a coarsely ground solid will yield only a poorly resolved spectrum. Grinding the sample into very fine particles is also important to reduce light scattering and salt plate scratching.
 - Add 1 or 2 drops of Nujol. Be careful not to add too much Nujol.
 - Mix the ground sample with the mulling agent until a uniform paste with a vaseline-like consistency is formed.
 - Apply some mull on the surface of a NaCl plate using a suitable tool (e.g. a small spatula or a rubber policeman). Be careful not to scratch the plate.
 - Place the second plate over the mull. To ensure an even and thin sample thickness between the plates, rotate and press the plates together in order to squeeze out the excess of the paste. Exclude also air bubbles.
 - Slot the plates in the plate holder installed in the spectrometer sample compartment and start the measurement.
 - Do not forget to acquire also a background spectrum of the pur Nujol.

G.2.5 Pressing a KBr pellet

This sample preparation technique is very suitable for solid samples in terms of the information yield from an IR spectrum because KBr is significantly more IR transparent than most solvents or Nujol oil. KBr has no absorption in the region 4000cm⁻¹ to 250cm⁻¹ so that a good sample spectrum (i.e. a spectrum that does not contain spectral information about the dispersing agent) is obtained.

The success of this technique strongly depends on the grain size of the ground sample. Grind the sample as fine as possible (particle size of at least 200 mesh, better 500 mesh) to minimize the infrared light scattering on the particle surface, also called Christiansen effect. This effect is caused by a refraction index mismatch between the salt (KBr) and the sample powder that leads to reflections at the salt-sample interface. Therefore, proper grinding is required to ensure a good contact between KBr and sample powder and to minimize the portion of the reflected light.

Another important factor in this technique is to keep everything moisture free as the KBr material is hygroscopic. To prevent the KBr material from absorbing moisture, keep the KBr material and the die in a drying oven at a temperature of 50 to 60°C. Failure to do so will result in opaque pellets that yield distorted spectra. A correctly prepared KBr pellet will be transparent to IR light.

To sum it up, the KBr-pellet technique yields good quality spectra with a wide spectral range and no interfering peaks. Disadvantages include tedious and time consuming sample preparation and cleanup, interference of water bands (3,960 to 3,480cm⁻¹ and 1,950 to 1,300cm⁻¹ and below 500cm⁻¹) and in same cases structural changes caused by high pressure applied to the KBr/sample mix.

- Put a small amount of the sample in an agate mortar and grind it up as fine as possible.
- Add a spatula full of oven-dry KBr material to the ground sample and mix it until a uniform mixture is obtained. Do not grind the mixture as this may increase the absorption of water by KBr.

- A common mistake is to use to much sample. The concentration of the sample in KBr should be in the range of 0.2% to 1% (i.e. typically a 300:1 dilution by mass).
 - Transfer the mixture into a die of a hydraulic or hand press and subject it to very high pressure (ca. 20,000 psi) for a few minutes (2 to 5 minutes). The result should be a translucent pellet with an ideal thickness of 0.5 to 1mm.
 - Carefully remove the pellet from the die, place it in the pellet holder and put the pellet holder in the spectrometer sample compartment.
- The KBr pellet is very hygroscopic and fragile. Handle it with care and use gloves to avoid contact with moisture from your hands. Measure the KBr pellet immediately after removing it from the press as the pellet will fairly rapidly begin to absorb moisture from the air and becomes opaque.

G.2.6 Liquid cell

Liquid cells produce excellent results for most liquids. Especially for liquid samples that are very volatile, using a liquid cell is highly recommended. A liquid cell consists of two IR transparent windows with a precision spacer in between. One of the windows has two drilled holes for the introduction and evacuation of the liquid. A large number of cell options are available including permanently sealed cells, demountable cells with different window material and a wide selection of spacers.

Take into consideration that KBr is hygroscopic and the pathlength of the KBr cell will change when exposed to a 'wet' sample (this may affect quantitative results). In addition, water will reduce the cell throughput by clouding the windows. Note that many liquid cells contribute a fringe pattern to the spectrum. Matching the refraction index of the window material with that of the sample can minimize this effect.

G.2.7 Gas cell

To obtain an infrared spectrum of a gaseous sample a gas cell with windows at each end is required. It is important to select a suitable window material (e.g. KBr, NaCl, or CaF₂) that does not absorb infrared light. The cell usually has an inlet and outlet port with a tap to facilitate the filling with the gas to be analyzed. Simple demountable cells (50 mm to 100 mm) are recommended for samples in a 5 - 10% concentration range. For diluted samples (ppm to ppb concentrations) a long path cell should be used. The long path cell reflects the IR beam several times through the sample using a set of mirrors positioned on the opposite ends of the cell. Note that the cell thickness, the pressure of the gas (proportional to concentration) inside the cell, and the molar absorptivity determine the peak intensity.
Index

Numerics

10/100Base-T Ethernet standard 32, 167

Α

A/D converter 13, 53, 150
AAR (automatic accessory recognition) 13,
Accessory 47, 51
Placing in the sample compartment66
Taking out of the sample compartment67
ACR (automatic component recognition) 13,
Air bearing 24, 45, 51
Aperture wheel 60, 156
Automatic beamsplitter changer 57, 80, 85
Loading84

В

Beam direction control compartment . 43, 45	5
Beamsplitter 13, 46, 51, 56, 60, 80, 119, 138	8
Automatic beamsplitter changer57	7
Color coding of the handle	3
Exchanging80)
Handling instructions81	
Manual exchange 57, 82	2
Optional beamsplitter56	3
Order number of replacement part153	3
Software-controlled exchange	5
Spectral range56	3
Standard beamsplitter56	3
BMS LED 46, 119)
Bolometer	3

С

CAN bus port	168
CG LED	166
COM1 port	166
Compressed air	20, 57, 64, 150
Flow rate	
Pressure	
Compressed air hose	17, 24, 49, 64
CR LED	166
CY LED	166

D

Data cable	17, 32, 50
Crossover cable	32, 34
Straight through cable	32, 35, 36
DDC ports	166
Detector13, 51, 53	, 60, 140, 149
Cooling mode	54
Cooling the MCT detector	95
Exchanging	86

External detector chamber	53
Hold time	
Operating temperature	54
Optional detectors	54
Sensitivity	54
Spectral range	54
Standard detector	54
Detector compartment	43, 45, 53
Detector dewar evacuation	
Evacuation equipment	102
Procedure	103
Diagnostics page	
Automation units	
Detector	125
Electronics	
Interferometer	124
Laser	123
Source	123
DLaTGS detector	54, 55, 86

Ε

EDIS port	
Electronics	
Electronics compartment	43
Electronics unit	
Environmental conditions	
Ambient temperature range	151
Ambient temperature variations	151
Humidity	151
ERR LED	127, 145, 166
Ethernet port	33, 36, 167
PC	
Spectrometer	
Evacuation	
Optimal procedure	73
Evacuation time	73, 74
External power supply unit	22, 23

F

FCONF program	
Starting	
Flaps	13, 45, 58, 69, 139
Controlling	77
FLAPS LED	45, 119, 135
Full report	129, 130
Generating	130
FWD LED	

G

Gas cell	178
Gateway	
PC	37, 38
Spectrometer	37, 38

Η

HeNe lase	r	10
-----------	---	----

I

Regarding the detector140Regarding the interferometer138Regarding the laser136Regarding the source137Interferometer13, 57, 149Spectral resolution57Interferometer compartment43, 45Internal validation wheel60IP address37, 39, 40, 42, 166, 167PC37, 38Spectrometer37, 38IR beam inlet port14, 48, 60IVU (internal validation unit)13, 14
--

L

LAS TEST port	
Laser 10, 45, 51,	57, 119, 132, 136, 149
Laser class	
Safety note	
LASER LED	
Linear scanner	
Liquid cell	
Liquid nitrogen	
Safety note	
Low-voltage socket .	

Μ

MAC address	40
MCT detector54, 86, 96, 97, 102	2, 140
Dewar vacuum	102
Evacuating the dewar	102
Hold time	102
PERMAVAC-type	102
Measurement parameter	13
MIR source	, 110

Ν

NIR source	 51,	110
	- ,	-

0

ON/OFF switch23, 42, 49, 62	2, 64, 168
Opening	
For venting the optical bench	
For venting the sample compartment	:
Optical beam path	60
Optical bench	45
Optical filter wheel	60, 156
OQ test14, 92,	101, 142
OVP14, 68,	101, 142
OVP test	. 120, 121

Ρ

PC	
Network computer	32
Stand-alone PC	32
PERMAVAC-type MCT detector	102
Regenerating the dewar vacuum	107
Photometric accuracy	149
Power cord	17, 23
Power supply	20, 150
PQ test	14, 68, 142
Pressure	, ,
Final pressure	73
PRESSURE LED	5, 119, 135
Pressure sensor	
Purge gas	20, 151
Flow rate	30, 75, 151
Pressure	30, 75, 151
Purge gas inlet	29, 30, 50
Purge mode	77
Activating	

Q

QuickLock	4	7,	51,	66,	67,	76

R

Reset button 4	Э,	167
RX LED 127, 14	7,	167

S

Sample compartment 43, 47,	150, 160
Dimensions	163
Opening	47
Purge gas inlet	76
Sample compartment window	58, 89
Chemical properties	
Handling instruction	
Refraction index	58
Replacing	89, 115
Safety note	89
Transmission range	58
Sample holder	51
Sample preparation technique	174
KBr pellet	177, 178
Preparing a mull	176
Sample solution	176
Thin film between plates	175
Scan speed	149
SG LED	127, 167
Signal	,
Checking	92
Signal amplitude	92
Signal intensity	. 92, 140
Site requirements	
Environmental requirements	19
Space requirements	19
opass requirements intriminin	

Source FIR High-power MIR Installation location Mode of cooling Optional sources	52 52 52 52 52 52 52
Order number of replacement part	53 10
Replacing	14
Standard source	52
UV	52
UV/VIS/NIR	52
VIS/NIR	52
Spectral range 13, 61, 1	49
Extending	79
Options	79
Standard	19
Spectra resolution	49
Assigning a network address	30
Checking the communication with the PC	42
Cleaning1	15
Connecting to a compressed air-line	24
Connecting to a network	35
Connecting to a network PC	36
Connecting to a stand-alone PC	34
Connecting to a vacuum pump	26
Connecting to the power supply	22
Dimensions 19 1	29 49
Evacuating	70
Purging	75
Putting into operation	62
Shutting down	64
Transport handles	18
Validating	14
Venting	/1
Veight	49 60
Backing up the current version 1	72
Diagnostic pages 118 1	22
Restoring a previous version	71
Updating	70
Spectrometer validation	14
SR LED 127, 146, 1	67
Status indicator board 44, 118, 1	19
STATUS LED42, 45, 62, 119, 128, 1	33
Subnet mask	40
PC	38
Spectrometer	38

Т

TKD LED	
TRG port	
TX LED	127, 147, 167

V

Vacuum	 150
VACUUM LED	 119, 131

Vacuum mode Activating
Attachment flange26
Vacuum shutters 13, 45, 58
Valve
For evacuating the optical bench26
For evacuating the sample compartment26
For venting the optical bench
For venting the sample compartment26
Vent opening50
Venting valve131
Vibration absorber17, 28
Voltage status LEDs 127, 144, 168

W

Wavenumber accuracy	149
Window	13
Order number of replacement part	154

VERTEX 80v User Manual



EC-DECLARATION OF CONFORMITY

The undersigned, representing the following manufacturer

Manufacturer: BRUKER OPTIK GMBH
Address: D-76275 Ettlingen, Rudolf-Plank-Straße 27

herewith declares that the product

Product identification:

Vertex 80v

is in conformity with the provisions of the following EC directive(s) (including all applicable amendments)

Reference no.	Title
73/23/EWG	Directive of the commission from February 19 th , 1973
	(Low Voltage Directive)
2004/108/EG	Directive of the commission from December 15 th , 2004
	(Electromagnetic Interference Directive)
93/68/EWG	Directive of the commission from July 22 nd , 1993
	(Amendment Low Voltage Directive)

and that the standards and / or technical specifications referenced overleaf have been applied.

Last two digits of the year in which the CE marking was affixed: 06

(when compliance with the provisions of the Low Voltage Directive 73/23/EWG is declared)

Ettlingen

(Signature)

June 20, 2006

(Date)

(Place)

Dr. Arno Simon, Development Manager

Jung

(Name and function of the signatory empowered to bind the manufacturer or his authorized representative)

Page 1 of 2 of EC-Declaration of Conformity of Vertex 80v

Bruker Optik GmbH	76275 Ettlingen/Germany	28359 Bremen/Germany	04318 Leipzig/Germany	76287 Rheinstetten/Germany
	Rudolf-Plank-Str. 27	Fahrenheitstr. 4	Permoserstr. 15	Silberstreifen
E-Mail: info@brukeroptics.de	Tel. +49 (0)7243 504-600	Tel. +49 (0)421 22319-10	Tel. +49 (0)341 24109-10	Tel. +49 (0)721 5161-141
	Fax +49 (0)7243 504-698	Fax +49 (0)421 22319-70	Fax +49 (0)341 24109-70	Fax +49 (0)721 5161-237
	Sitz der Gesellschaft ist Ettlingen I	HRB 2608E, Geschäftsführer: Dr. Arno S	Simon, Dr. Dieter Schmalbein, DiplIng. Fi	rank Müller
WEEE-RegNr. DE 84716930	Dresdner Bank Karlsruhe Nr. 562 (081800, BLZ 660 800 52 · Deutsche Bar	hk AG Karlsruhe Nr. 013 159900, BLZ 660	1700 04
	Commerzbank Karlsruhe Nr. 2427	06000, BLZ 66040018	USt-IdNr. DE812440710 · Ste	uer-Nr. 31190 39703 Finanzamt Ettlingen



www.brukeroptics.de

<u>References of standards and/or technical specifications applied for this declaration of conformity, or parts thereof :</u>

Harmonized standards:						
No.	Issue	Title	Parts(1)			
EN 61326:1997	Mai 2004	Electrical equipment for measurement,				
+A1:1998+A2:2001+		control and laboratory use				
A3:2003		- EMC requirements				
EN 61000-3-2:2000	September 2005	Electromagnetic compatibility;	3-2			
+A2:2005		Part 3-2: Limits - Limits for harmonic current emissions				
EN 61000-3-3:1995	June 2006	Electromagnetic compatibility: Part 3-3:	3-3			
+A1:2001+A2:2005		Limits - Limitation of voltage				
		fluctuations and flicker in low-voltage				
EN 61010-1:2001		supply systems for equipment with rated				
(2 nd Edition)	August 2002	current ≤16A	1			
		Safety requirements for electrical equip-	8			
EN 60825-1:1994+		ment for measurement, control and				
A1:2002 + A2:2001	October 2003	labor-atory use; Part 1: General	1			
		requirements				
		Safety of laser products;				
		Part 1: Equipment classification,				
		requirements and user's guide				

Other standards and/or technical specifications:

No.	Issue	Title	Parts (1)

Other technical solutions, the details of which are included in the technical documentation or the technical construction file:

Other references or information required by the applicable EC directive(s):

(1) Where appropriate, the applicable parts or clauses of the standard or the technical specification shall be referenced.

Page 2 of 2 of EC-Declaration of Conformity of Vertex 80v

.....

Bruker Optik GmbH

76275 Ettlingen/Germany Rudolf-Plank-Str. 27 Tel. +49 (0)7243 504-600 Fax +49 (0)7243 504-698 28359 Bremen/Germany Fahrenheitstr. 4 Tel. +49 (0)421 22319-10 Fax +49 (0)421 22319-70 04318 Leipzig/Germany Permoserstr. 15 Tel. +49 (0)341 24109-10 Fax +49 (0)341 24109-70 76287 Rheinstetten/Germany Silberstreifen Tel. +49 (0)721 5161-141 Fax +49 (0)721 5161-237

Sitz der Gesellschaft ist Ettlingen HRB 2608E, Geschäftsführer: Dr. Arno Simon, Dr. Dieter Schmalbein, Dipl-Ing. Frank Müller Dresdner Bank Karlsruhe Nr. 562 081800, BLZ 660 800 52 · Deutsche Bank AG Karlsruhe Nr. 013 159900, BLZ 660 700 04 Commerzbank Karlsruhe Nr. 242705000, BLZ 66040018 · US+IdNkr. DEB12440710 · Steure-Nr. 31190 39703 Finanzamt Ettlingen

E-Mail: info@brukeroptics.de WEEE-Reg.-Nr. DE 84716930